ELPIDA

MOS INTEGRATED CIRCUIT

µPD45128441, 45128841, 45128163

128M-bit Synchronous DRAM
4-bank, LVTTL

Description

The µPD45128441, 45128841, 45128163 are high-speed 134,217,728-bit synchronous dynamic random-access memories, organized as $8,388,608 \times 4 \times 4$, $4,194,304 \times 8 \times 4$, $2,097,152 \times 16 \times 4$ (word $\times$ bit $\times$ bank), respectively.

The synchronous DRAMs achieved high-speed data transfer using the pipeline architecture.

All inputs and outputs are synchronized with the positive edge of the clock.

The synchronous DRAMs are compatible with Low Voltage TTL (LVTTL).

These products are packaged in 54-pin TSOP (II).

Features

- Fully Synchronous Dynamic RAM, with all signals referenced to a positive clock edge
- Pulsed interface
- Possible to assert random column address in every cycle
- Quad internal banks controlled by BA0(A13) and BA1(A12)
- Byte control ($\times$16) by LDQM and UDQM
- Programmable Wrap sequence (Sequential / Interleave)
- Programmable burst length (1, 2, 4, 8 and full page)
- Programmable /CAS latency (2 and 3)
- Automatic precharge and controlled precharge
- CBR (Auto) refresh and self refresh
- $\times$4, $\times$8, $\times$16 organization
- Single 3.3 V $\pm$ 0.3 V power supply
- LVTTL compatible inputs and outputs
- 4,096 refresh cycles / 64 ms
- Burst termination by Burst stop command and Precharge command

Ordering Information

Part number	Organization (word × bit × bank)	Clock frequency MHz (MAX.)	Package
μPD45128441G5-A75A-9JF	8M × 4 × 4	133	54-pin Plastic TSOP (II)
μPD45128441G5-A75-9JF		133	(10.16mm (400))
μPD45128441G5-A80-9JF		125	
μPD45128441G5-A10-9JF		100	
μPD45128841G5-A75A-9JF	4M × 8 × 4	133	
μPD45128841G5-A75-9JF		133	
μPD45128841G5-A80-9JF		125	
μPD45128841G5-A10-9JF		100	
μPD45128163G5-A75A-9JF	2M × 16 × 4	133	
μPD45128163G5-A75-9JF		133	
μPD45128163G5-A80-9JF		125	
μPD45128163G5-A10-9JF		100	
μPD45128441G5-A75L-9JF	8M × 4 × 4	133	
μPD45128441G5-A80L-9JF		125	
μPD45128841G5-A75L-9JF	4M × 8 × 4	133	
μPD45128841G5-A80L-9JF		125	
μPD45128163G5-A75L-9JF	2M × 16 × 4	133	
μPD45128163G5-A80L-9JF		125	

Part Number

[x4, x8]

μPD45128841G5 - A75L

NEC Memory

Synchronous DRAM

Memory density

128 : 128M bits

Organization

4 : x4
8 : x8

Number of banks

4 : 4 banks

Interface

1 : LVTTL

Low Power

Minimum cycle time

75A : 7.5 ns (133 MHz @CL=2)
75   : 7.5 ns (133 MHz @CL=3)
80   : 8 ns (125 MHz)
10   : 10 ns (100 MHz)

Low voltage

A : 3.3 V ± 0.3 V

Package

G5 : TSOP (II)
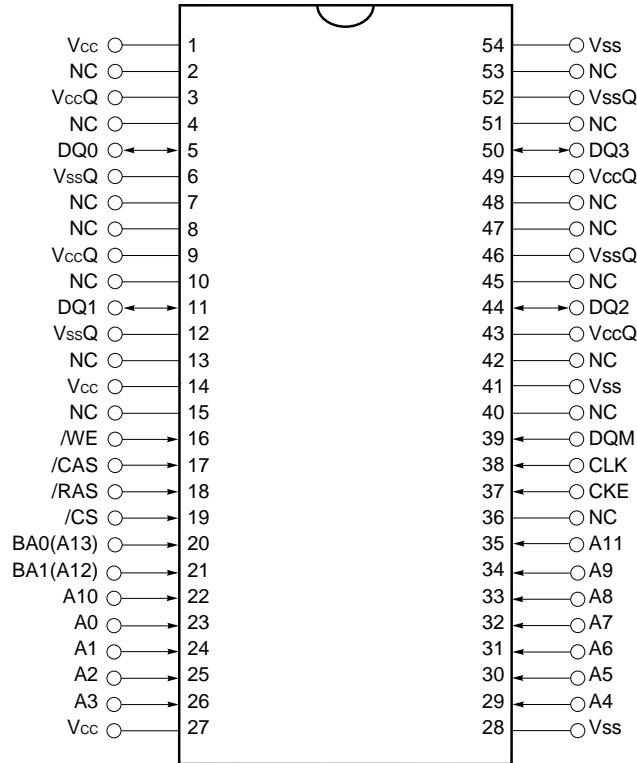
[x16]

163
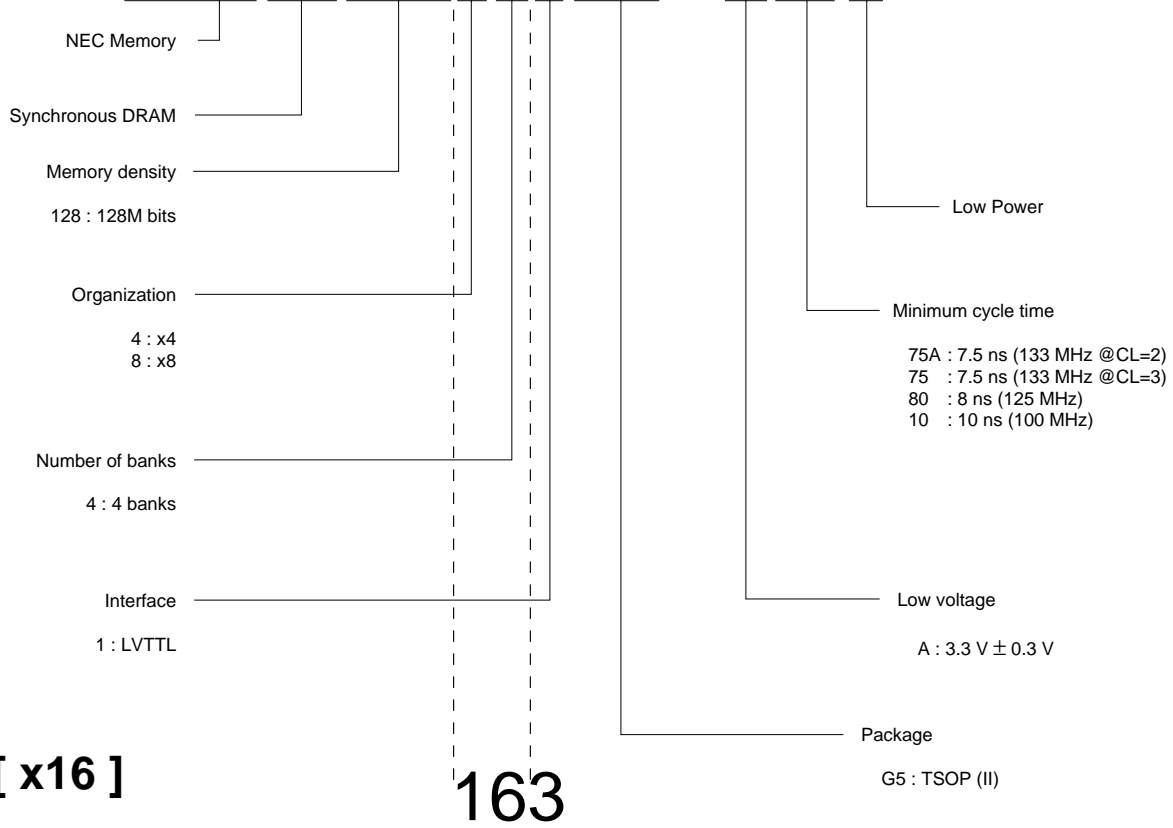
Organization

16 : x16

Number of banks
and Interface

3 : 4 banks, LVTTL

Pin Configurations

/xxx indicates active low signal.

[μPD45128441]
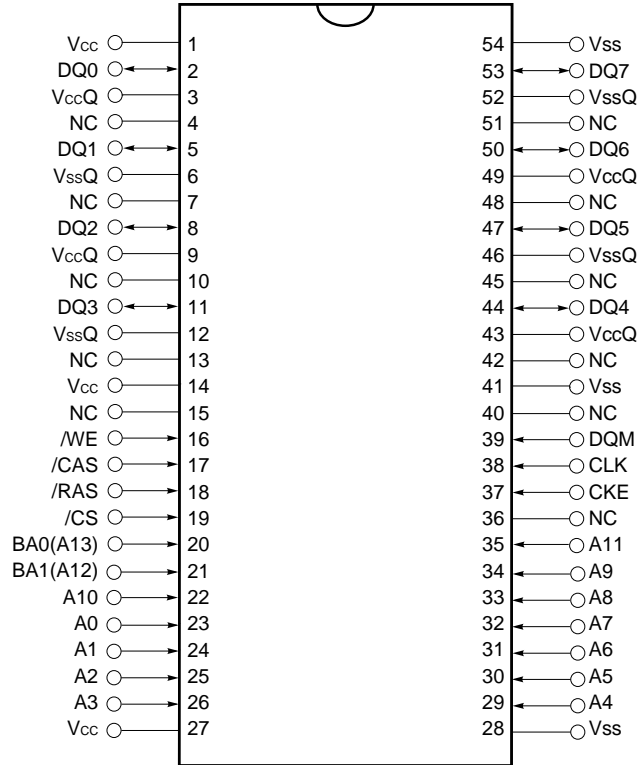**54-pin Plastic TSOP (II) (10.16mm (400))**
8M words × 4 bits × 4 banks

Vcc	1		54	Vss
NC	2		53	NC
VccQ	3		52	VssQ
NC	4		51	NC
DQ0	5		50	DQ3
VssQ	6		49	VccQ
NC	7		48	NC
NC	8		47	NC
VccQ	9		46	VssQ
NC	10		45	NC
DQ1	11		44	DQ2
VssQ	12		43	VccQ
NC	13		42	NC
Vcc	14		41	Vss
NC	15		40	NC
/WE	16		39	DQM
/CAS	17		38	CLK
/RAS	18		37	CKE
/CS	19		36	NC
BA0(A13)	20		35	A11
BA1(A12)	21		34	A9
A10	22		33	A8
A0	23		32	A7
A1	24		31	A6
A2	25		30	A5
A3	26		29	A4
Vcc	27		28	Vss

A0 to A11 **Note**   : Address inputs
BA0(A13), BA1(A12): Bank select
DQ0 to DQ3   : Data inputs / outputs
CLK   : Clock input
CKE   : Clock enable
/CS   : Chip select
/RAS   : Row address strobe
/CAS   : Column address strobe
/WE   : Write enable
DQM   : DQ mask enable
Vcc   : Supply voltage
Vss   : Ground
VccQ   : Supply voltage for DQ   **Note** A0 to A11   : Row address inputs
VssQ   : Ground for DQ   A0 to A9, A11 : Column address inputs
NC   : No connection

[μPD45128841]

54-pin Plastic TSOP (II) (10.16mm (400))

4M words × 8 bits × 4 banks

Pin	Signal		Pin	Signal
1	Vcc		54	Vss
2	DQ0		53	DQ7
3	VccQ		52	VssQ
4	NC		51	NC
5	DQ1		50	DQ6
6	VssQ		49	VccQ
7	NC		48	NC
8	DQ2		47	DQ5
9	VccQ		46	VssQ
10	NC		45	NC
11	DQ3		44	DQ4
12	VssQ		43	VccQ
13	NC		42	NC
14	Vcc		41	Vss
15	NC		40	NC
16	/WE		39	DQM
17	/CAS		38	CLK
18	/RAS		37	CKE
19	/CS		36	NC
20	BA0(A13)		35	A11
21	BA1(A12)		34	A9
22	A10		33	A8
23	A0		32	A7
24	A1		31	A6
25	A2		30	A5
26	A3		29	A4
27	Vcc		28	Vss

A0 to A11 **Note**   : Address inputs

BA0(A13), BA1(A12): Bank select

DQ0 to DQ7   : Data inputs / outputs

CLK   : Clock input

CKE   : Clock enable

/CS   : Chip select

/RAS   : Row address strobe

/CAS   : Column address strobe

/WE   : Write enable

DQM   : DQ mask enable

Vcc   : Supply voltage

Vss   : Ground   **Note** A0 to A11 : Row address inputs

VccQ   : Supply voltage for DQ   A0 to A9   : Column address inputs

VssQ   : Ground for DQ

NC   : No connection

[μPD45128163]
54-pin Plastic TSOP (II) (10.16mm (400))
2M words × 16 bits × 4 banks

Vcc	1		54	Vss
DQ0	2		53	DQ15
VccQ	3		52	VssQ
DQ1	4		51	DQ14
DQ2	5		50	DQ13
VssQ	6		49	VccQ
DQ3	7		48	DQ12
DQ4	8		47	DQ11
VccQ	9		46	VssQ
DQ5	10		45	DQ10
DQ6	11		44	DQ9
VssQ	12		43	VccQ
DQ7	13		42	DQ8
Vcc	14		41	Vss
LDQM	15		40	NC
/WE	16		39	UDQM
/CAS	17		38	CLK
/RAS	18		37	CKE
/CS	19		36	NC
BA0(A13)	20		35	A11
BA1(A12)	21		34	A9
A10	22		33	A8
A0	23		32	A7
A1	24		31	A6
A2	25		30	A5
A3	26		29	A4
Vcc	27		28	Vss
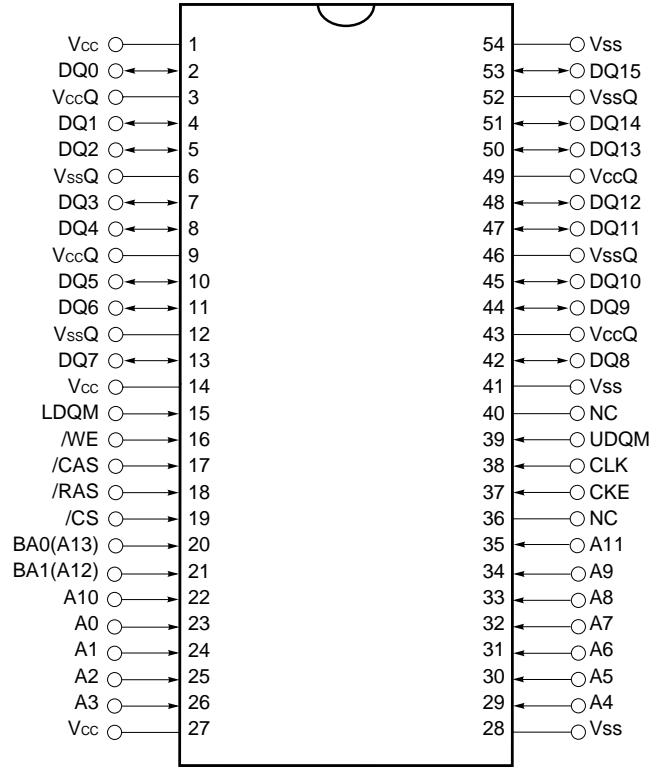
A0 to A11 **Note**   : Address inputs

BA0(A13), BA1(A12): Bank select

DQ0 to DQ15   : Data inputs / outputs

CLK   : Clock input

CKE   : Clock enable

/CS   : Chip select

/RAS   : Row address strobe

/CAS   : Column address strobe

/WE   : Write enable

LDQM   : Lower DQ mask enable

UDQM   : Upper DQ mask enable

Vcc   : Supply voltage

Vss   : Ground   **Note** A0 to A11 : Row address inputs

VccQ   : Supply voltage for DQ   A0 to A8   : Column address inputs

VssQ   : Ground for DQ

NC   : No connection

Block Diagram
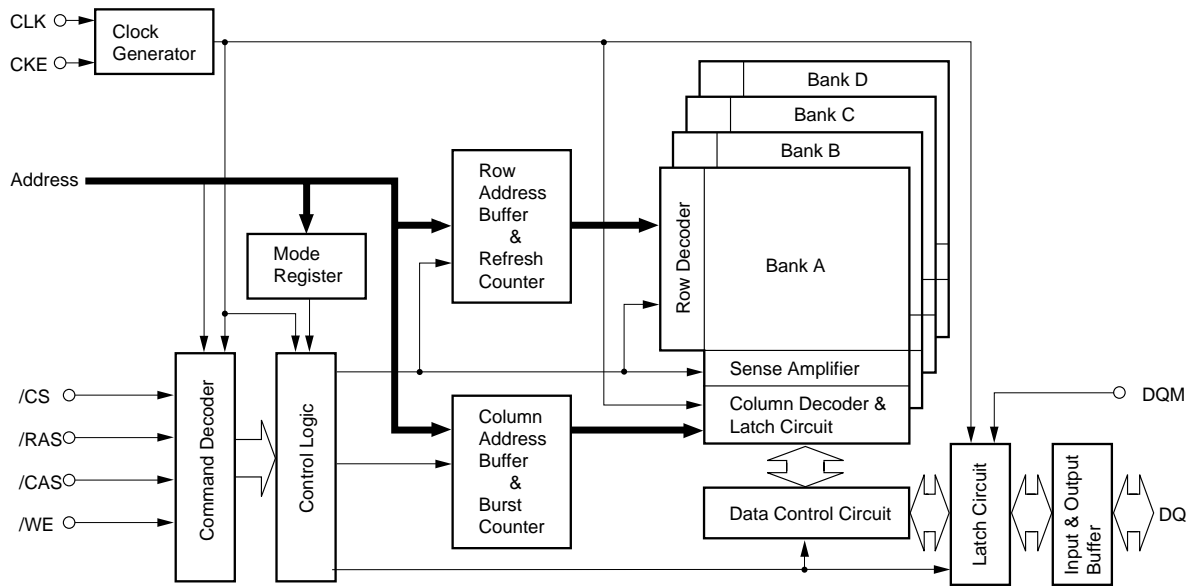
CONTENTS

1. Input / Output Pin Function

Pin name	Input / Output	Function
CLK	Input	CLK is the master clock input. Other inputs signals are referenced to the CLK rising edge.
CKE	Input	CKE determine validity of the next CLK (clock). If CKE is high, the next CLK rising edge is valid; otherwise it is invalid. If the CLK rising edge is invalid, the internal clock is not issued and the μPD45128xxx suspends operation. When the μPD45128xxx is not in burst mode and CKE is negated, the device enters power down mode. During power down mode, CKE must remain low.
/CS	Input	/CS low starts the command input cycle. When /CS is high, commands are ignored but operations continue.
/RAS, /CAS, /WE	Input	/RAS, /CAS and /WE have the same symbols on conventional DRAM but different functions. For details, refer to the command table.
A0 - A11	Input	Row Address is determined by A0 - A11 at the CLK (clock) rising edge in the active command cycle. It does not depend on the bit organization. Column Address is determined by A0 - A9, A11 at the CLK rising edge in the read or write command cycle. It depends on the bit organization: A0 - A9, A11 for ×4 device, A0 - A9 for ×8 device, A0 - A8 for ×16 device. A10 defines the precharge mode. When A10 is high in the precharge command cycle, all banks are precharged; when A10 is low, only the bank selected by BA0(A13) and BA1(A12) is precharged. When A10 is high in read or write command cycle, the precharge starts automatically after the burst access.
BA0, BA1	Input	BA0(A13) and BA1(A12) are the bank select signal. In command cycle, BA0(A13) and BA1(A12) low select bank A, BA0(A13) high and BA1(A12) low select bank B, BA0(A13) low and BA1(A12) high select bank C and then BA0(A13) and BA1(A12) high select bank D.
DQM, UDQM, LDQM	Input	DQM controls I/O buffers. In ×16 products, UDQM and LDQM control upper byte and lower byte I/O buffers, respectively. In read mode, DQM controls the output buffers like a conventional /OE pin. DQM high and DQM low turn the output buffers off and on, respectively. The DQM latency for the read is two clocks. In write mode, DQM controls the word mask. Input data is written to the memory cell if DQM is low but not if DQM is high. The DQM latency for the write is zero.
DQ0 - DQ15	Input / Output	DQ pins have the same function as I/O pins on a conventional DRAM.
V_{CC}, V_{SS}, $V_{CC}Q$, $V_{SS}Q$	(Power supply)	V_{CC} and V_{SS} are power supply pins for internal circuits. $V_{CC}Q$ and $V_{SS}Q$ are power supply pins for the output buffers.

2. Commands

**Mode register set command**

      (/CS, /RAS, /CAS, /WE = Low)

The μPD45128xxx has a mode register that defines how the device operates. In this command, A0 through A11, BA0(A13) and BA1(A12) are the data input pins. After power on, the mode register set command must be executed to initialize the device.

The mode register can be set only when all banks are in idle state.

During 2 CLK (t_RSC) following this command, the μPD45128xxx cannot accept any other commands.

Fig.1 Mode register set command

| CLK |
| CKE |
| /CS |
| /RAS |
| /CAS |
| /WE |
| BA0(A13), BA1(A12) |
| A10 |
| Add |
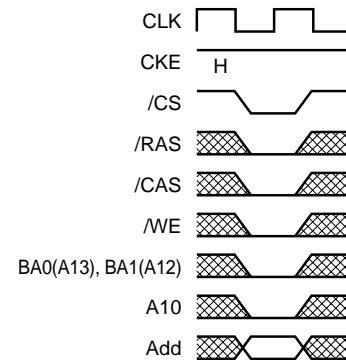
Activate command

      (/CS, /RAS = Low, /CAS, /WE = High)

The μPD45128xxx has four banks, each with 4,096 rows.

This command activates the bank selected by BA0(A13) and BA1(A12) and a row address selected by A0 through A11.

This command corresponds to a conventional DRAM's /RAS falling.

Fig.2 Row address strobe and bank activate command

| CLK |
| CKE |
| /CS |
| /RAS |
| /CAS |
| /WE |
| BA0(A13), BA1(A12) |
| A10 Row |
| Add Row |
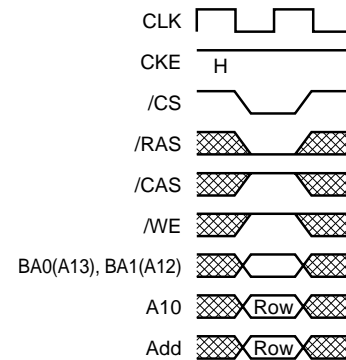
Precharge command

      (/CS, /RAS, /WE = Low, /CAS = High)

This command begins precharge operation of the bank selected by BA0(A13) and BA1(A12). When A10 is High, all banks are precharged, regardless of BA0(A13) and BA1(A12). When A10 is Low, only the bank selected by BA0(A13) and BA1(A12) is precharged.

After this command, the μPD45128xxx can't accept the activate command to the precharging bank during t_RP (precharge to activate command period).

This command corresponds to a conventional DRAM's /RAS rising.

Fig.3 Precharge command

| CLK |
| CKE |
| /CS |
| /RAS |
| /CAS |
| /WE |
| BA0(A13), BA1(A12) |
| A10 (Precharge select) |
| Add |
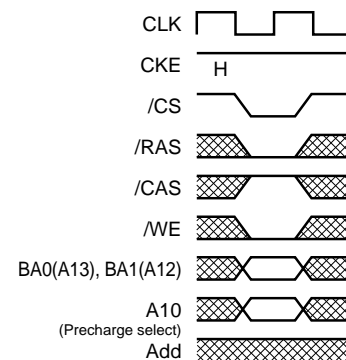
Write command

(/CS, /CAS, /WE = Low, /RAS = High)

If the mode register is in the burst write mode, this command sets the burst start address given by the column address to begin the burst write operation. The first write data in burst mode can input with this command with subsequent data on following clocks.

Fig.4 Column address and write command
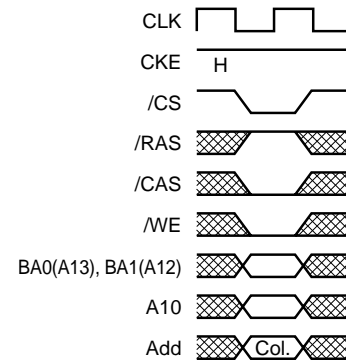
Read command

(/CS, /CAS = Low, /RAS, /WE = High)

Read data is available after /CAS latency requirements have been met. This command sets the burst start address given by the column address.

Fig.5 Column address and read command
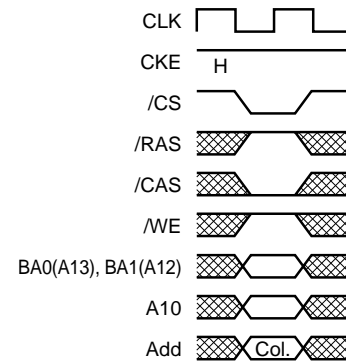
CBR (auto) refresh command

(/CS, /RAS, /CAS = Low, /WE, CKE = High)

This command is a request to begin the CBR (auto) refresh operation. The refresh address is generated internally.
 Before executing CBR (auto) refresh, all banks must be precharged.
 After this cycle, all banks will be in the idle (precharged) state and ready for a row activate command.
 During t_{RC} period (from refresh command to refresh or activate command), the μPD45128xxx cannot accept any other command.

Fig.6 CBR (auto) refresh command
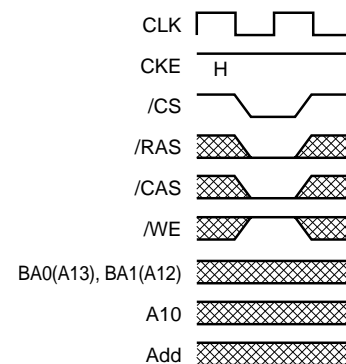
Self refresh entry command

(/CS, /RAS, /CAS, CKE = Low, /WE = High)

After the command execution, self refresh operation continues while CKE remains low. When CKE goes high, the μPD45128xxx exits the self refresh mode.

During self refresh mode, refresh interval and refresh operation are performed internally, so there is no need for external control.

Before executing self refresh, all banks must be precharged.

Fig.7   Self refresh entry command
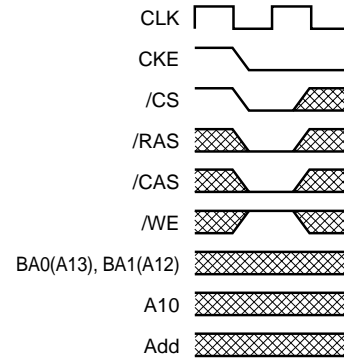
Burst stop command

(/CS, /WE = Low, /RAS, /CAS = High)

This command can stop the current burst operation.

Fig.8   Burst stop command in Full Page Mode
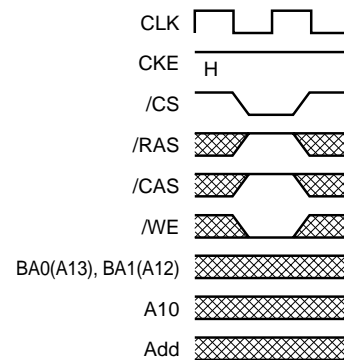
No operation

(/CS = Low, /RAS, /CAS, /WE = High)

This command is not an execution command. No operations begin or terminate by this command.

Fig.9   No operation
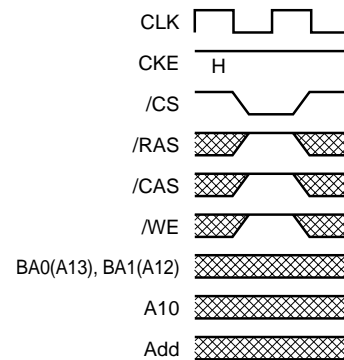
3. Simplified State Diagram

Self
Refresh

SELF

SELF exit

Mode
Register
Set

MRS

IDLE

REF

CBR (Auto)
Refresh

CKE↓

CKE

Power
Down

ACT

ROW
ACTIVE

CKE↓

CKE

Active
Power
Down

BST

Write

BST

Write

Read

Read

WRITE
SUSPEND

CKE↓

CKE

WRITE

Write with
Auto precharge

Read with
Auto precharge

PRE

Read

READ

CKE↓

CKE

READ
SUSPEND

Write

WRITEA
SUSPEND

CKE↓

CKE

WRITEA

PRE (Precharge termination)

PRE (Precharge termination)

READA

CKE↓

CKE

READA
SUSPEND

POWER
ON

Precharge

Precharge

→ Automatic sequence

→ Manual input

4. Truth Table

4.1 Command Truth Table

Function	Symbol	CKE		/CS	/RAS	/CAS	/WE	BA1, BA0	A10	A11, A9 - A0
		n − 1	n							
Device deselect	DESL	H	×	H	×	×	×	×	×	×
No operation	NOP	H	×	L	H	H	H	×	×	×
Burst stop	BST	H	×	L	H	H	L	×	×	×
Read	READ	H	×	L	H	L	H	V	L	V
Read with auto precharge	READA	H	×	L	H	L	H	V	H	V
Write	WRIT	H	×	L	H	L	L	V	L	V
Write with auto precharge	WRITA	H	×	L	H	L	L	V	H	V
Bank activate	ACT	H	×	L	L	H	H	V	V	V
Precharge select bank	PRE	H	×	L	L	H	L	V	L	×
Precharge all banks	PALL	H	×	L	L	H	L	×	H	×
Mode register set	MRS	H	×	L	L	L	L	L	L	V

Remark H = High level, L = Low level, × = High or Low level (Don't care), V = Valid data input

4.2 DQM Truth Table

Function	Symbol	CKE		DQM	
		n − 1	n	U	L
Data write / output enable	ENB	H	×	L	
Data mask / output disable	MASK	H	×	H	
Upper byte write enable / output enable	ENBU	H	×	L	×
Lower byte write enable / output enable	ENBL	H	×	×	L
Upper byte write inhibit / output disable	MASKU	H	×	H	×
Lower byte write inhibit / output disable	MASKL	H	×	×	H

Remark H = High level, L = Low level, × = High or Low level (Don't care)

4.3 CKE Truth Table

Current state	Function	Symbol	CKE		/CS	/RAS	/CAS	/WE	Address
			n − 1	n					
Activating	Clock suspend mode entry		H	L	×	×	×	×	×
Any	Clock suspend mode		L	L	×	×	×	×	×
Clock suspend	Clock suspend mode exit		L	H	×	×	×	×	×
Idle	CBR (auto) refresh command	REF	H	H	L	L	L	H	×
Idle	Self refresh entry	SELF	H	L	L	L	L	H	×
Self refresh	Self refresh exit		L	H	L	H	H	H	×
			L	H	H	×	×	×	×
Idle	Power down entry		H	L	×	×	×	×	×
Power down	Power down exit		L	H	H	×	×	×	×
			L	H	L	H	H	H	×

Remark H = High level, L = Low level, × = High or Low level (Don't care)

4.4 Operative Command Table [Note1] (1/3)

Current state	/CS	/RAS	/CAS	/WE	Address	Command	Action	Notes
Idle	H	×	×	×	×	DESL	Nop or power down	2
	L	H	H	×	×	NOP or BST	Nop or power down	2
	L	H	L	H	BA, CA, A10	READ/READA	ILLEGAL	3
	L	H	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL	3
	L	L	H	H	BA, RA	ACT	Row activating	
	L	L	H	L	BA, A10	PRE/PALL	Nop	
	L	L	L	H	×	REF/SELF	CBR (auto) refresh or self refresh	4
	L	L	L	L	Op-Code	MRS	Mode register accessing	
Row active	H	×	×	×	×	DESL	Nop	
	L	H	H	×	×	NOP or BST	Nop	
	L	H	L	H	BA, CA, A10	READ/READA	Begin read : Determine AP	5
	L	H	L	L	BA, CA, A10	WRIT/WRITA	Begin write : Determine AP	5
	L	L	H	H	BA, RA	ACT	ILLEGAL	3
	L	L	H	L	BA, A10	PRE/PALL	Precharge	6
	L	L	L	H	×	REF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS	ILLEGAL	
Read	H	×	×	×	×	DESL	Continue burst to end → Row active	
	L	H	H	H	×	NOP	Continue burst to end → Row active	
	L	H	H	L	×	BST	Burst stop → Row active	
	L	H	L	H	BA, CA, A10	READ/READA	Terminate burst, new read : Determine AP	7
	L	H	L	L	BA, CA, A10	WRIT/WRITA	Terminate burst, start write : Determine AP	7, 8
	L	L	H	H	BA, RA	ACT	ILLEGAL	3
	L	L	H	L	BA, A10	PRE/PALL	Terminate burst, precharging	
	L	L	L	H	×	REF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS	ILLEGAL	
Write	H	×	×	×	×	DESL	Continue burst to end → Write recovering	
	L	H	H	H	×	NOP	Continue burst to end → Write recovering	
	L	H	H	L	×	BST	Burst stop → Row active	
	L	H	L	H	BA, CA, A10	READ/READA	Terminate burst, start read : Determine AP	7, 8
	L	H	L	L	BA, CA, A10	WRIT/WRITA	Terminate burst, new write : Determine AP	7
	L	L	H	H	BA, RA	ACT	ILLEGAL	3
	L	L	H	L	BA, A10	PRE/PALL	Terminate burst, precharging	9
	L	L	L	H	×	REF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS	ILLEGAL	

(2/3)

Current state	/CS	/RAS	/CAS	/WE	Address	Command	Action	Notes
Read with auto precharge	H	×	×	×	×	DESL	Continue burst to end → Precharging	
	L	H	H	H	×	NOP	Continue burst to end → Precharging	
	L	H	H	L	×	BST	ILLEGAL	
	L	H	L	H	BA, CA, A10	READ/READA	ILLEGAL	3
	L	H	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL	3
	L	L	H	H	BA, RA	ACT	ILLEGAL	3
	L	L	H	L	BA, A10	PRE/PALL	ILLEGAL	3
	L	L	L	H	×	REF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS	ILLEGAL	
Write with auto precharge	H	×	×	×	×	DESL	Continue burst to end → Write recovering with auto precharge	
	L	H	H	H	×	NOP	Continue burst to end → Write recovering with auto precharge	
	L	H	H	L	×	BST	ILLEGAL	
	L	H	L	H	BA, CA, A10	READ/READA	ILLEGAL	3
	L	H	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL	3
	L	L	H	H	BA, RA	ACT	ILLEGAL	3
	L	L	H	L	BA, A10	PRE/PALL	ILLEGAL	3
	L	L	L	H	×	REF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS	ILLEGAL	
Precharging	H	×	×	×	×	DESL	Nop → Enter idle after t_{RP}	
	L	H	H	H	×	NOP	Nop → Enter idle after t_{RP}	
	L	H	H	L	×	BST	ILLEGAL	
	L	H	L	H	BA, CA, A10	READ/READA	ILLEGAL	3
	L	H	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL	3
	L	L	H	H	BA, RA	ACT	ILLEGAL	3
	L	L	H	L	BA, A10	PRE/PALL	Nop → Enter idle after t_{RP}	
	L	L	L	H	×	REF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS	ILLEGAL	
Row activating	H	×	×	×	×	DESL	Nop → Enter bank active after t_{RCD}	
	L	H	H	H	×	NOP	Nop → Enter bank active after t_{RCD}	
	L	H	H	L	×	BST	ILLEGAL	
	L	H	L	H	BA, CA, A10	READ/READA	ILLEGAL	3
	L	H	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL	3
	L	L	H	H	BA, RA	ACT	ILLEGAL	3, 10
	L	L	H	L	BA, A10	PRE/PALL	ILLEGAL	3
	L	L	L	H	×	REF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS	ILLEGAL	

Current state	/CS	/RAS	/CAS	/WE	Address	Command	Action	Notes
Write recovering	H	×	×	×	×	DESL	Nop → Enter row active after t$_{DPL}$	
	L	H	H	H	×	NOP	Nop → Enter row active after t$_{DPL}$	
	L	H	H	L	×	BST	Nop → Enter row active after t$_{DPL}$	
	L	H	L	H	BA, CA, A10	READ/READA	Start read, Determine AP	8
	L	H	L	L	BA, CA, A10	WRIT/WRITA	New write, Determine AP	
	L	L	H	H	BA, RA	ACT	ILLEGAL	3
	L	L	H	L	BA, A10	PRE/PALL	ILLEGAL	3
	L	L	L	H	×	REF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS	ILLEGAL	
Write recovering with auto precharge	H	×	×	×	×	DESL	Nop → Enter precharge after t$_{DPL}$	
	L	H	H	H	×	NOP	Nop → Enter precharge after t$_{DPL}$	
	L	H	H	L	×	BST	Nop → Enter precharge after t$_{DPL}$	
	L	H	L	H	BA, CA, A10	READ/READA	ILLEGAL	3, 8
	L	H	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL	3
	L	L	H	H	BA, RA	ACT	ILLEGAL	3
	L	L	H	L	BA, A10	PRE/PALL	ILLEGAL	
	L	L	L	H	×	REF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS	ILLEGAL	
Refreshing	H	×	×	×	×	DESL	Nop → Enter idle after t$_{RC}$	
	L	H	H	×	×	NOP/BST	Nop → Enter idle after t$_{RC}$	
	L	H	L	×	×	READ/WRIT	ILLEGAL	
	L	L	H	×	×	ACT/PRE/PALL	ILLEGAL	
	L	L	L	×	×	REF/SELF/MRS	ILLEGAL	
Mode register accessing	H	×	×	×	×	DESL	Nop → Enter idle after t$_{RSC}$	
	L	H	H	H	×	NOP	Nop → Enter idle after t$_{RSC}$	
	L	H	H	L	×	BST	ILLEGAL	
	L	H	L	×	×	READ/WRIT	ILLEGAL	
	L	L	×	×	×	ACT/PRE/PALL/ REF/SELF/MRS	ILLEGAL	

Notes 1. All entries assume that CKE was active (High level) during the preceding clock cycle.

    2. If all banks are idle, and CKE is inactive (Low level), μPD45128xxx will enter Power down mode. All input buffers except CKE will be disabled.

    3. Illegal to bank in specified states; Function may be legal in the bank indicated by Bank Address (BA), depending on the state of that bank.

    4. If all banks are idle, and CKE is inactive (Low level), μPD45128xxx will enter Self refresh mode. All input buffers except CKE will be disabled.

    5. Illegal if t$_{RCD}$ is not satisfied.

    6. Illegal if t$_{RAS}$ is not satisfied.

    7. Must satisfy burst interrupt condition.

    8. Must satisfy bus contention, bus turn around, and/or write recovery requirements.

    9. Must mask preceding data which don't satisfy t$_{DPL}$.

    10. Illegal if t$_{RRD}$ is not satisfied.

Remark   H = High level, L = Low level, × = High or Low level (Don't care), V = Valid data

4.5 Command Truth Table for CKE

Current State	CKE n − 1	CKE n	/CS	/RAS	/CAS	/WE	Address	Action	Notes
Self refresh	H	×	×	×	×	×	×	INVALID, CLK (n − 1) would exit self refresh	
	L	H	H	×	×	×	×	Self refresh recovery	
	L	H	L	H	H	×	×	Self refresh recovery	
	L	H	L	H	L	×	×	ILLEGAL	
	L	H	L	L	×	×	×	ILLEGAL	
	L	L	×	×	×	×	×	Maintain self refresh	
Self refresh recovery	H	H	H	×	×	×	×	Idle after t_{RC}	
	H	H	L	H	H	×	×	Idle after t_{RC}	
	H	H	L	H	L	×	×	ILLEGAL	
	H	H	L	L	×	×	×	ILLEGAL	
	H	L	H	×	×	×	×	ILLEGAL	
	H	L	L	H	H	×	×	ILLEGAL	
	H	L	L	H	L	×	×	ILLEGAL	
	H	L	L	L	×	×	×	ILLEGAL	
Power down	H	×	×	×	×	×		INVALID, CLK (n − 1) would exit power down	
	L	H	H	×	×	×	×	EXIT power down → Idle	
	L	H	L	H	H	H	×	EXIT power down → Idle	
	L	L	×	×	×	×	×	Maintain power down mode	
All banks idle	H	H	H	×	×	×		Refer to operations in Operative Command Table	
	H	H	L	H	×	×		Refer to operations in Operative Command Table	
	H	H	L	L	H	×		Refer to operations in Operative Command Table	
	H	H	L	L	L	H	×	CBR (auto) Refresh	
	H	H	L	L	L	L	Op-Code	Refer to operations in Operative Command Table	
	H	L	H	×	×	×		Refer to operations in Operative Command Table	
	H	L	L	H	×	×		Refer to operations in Operative Command Table	
	H	L	L	L	H	×		Refer to operations in Operative Command Table	
	H	L	L	L	L	H	×	Self refresh	1
	H	L	L	L	L	L	Op-Code	Refer to operations in Operative Command Table	
	L	×	×	×	×	×	×	Power down	1
Row active	H	×	×	×	×	×	×	Refer to operations in Operative Command Table	
	L	×	×	×	×	×	×	Power down	1
Any state other than listed above	H	H	×	×	×	×		Refer to operations in Operative Command Table	
	H	L	×	×	×	×	×	Begin clock suspend next cycle	2
	L	H	×	×	×	×	×	Exit clock suspend next cycle	
	L	L	×	×	×	×	×	Maintain clock suspend	

Notes 1. Self refresh can be entered only from the all banks idle state. Power down can be entered only from all banks idle or row active state.

2. Must be legal command as defined in Operative Command Table.

Remark H = High level, L = Low level, × = High or Low level (Don't care)

5. Initialization

The synchronous DRAM is initialized in the power-on sequence according to the following.

(1)   To stabilize internal circuits, when power is applied, a 100 μs or longer pause must precede any signal toggling.

(2)   After the pause, all banks must be precharged using the Precharge command (The Precharge all banks command is convenient).

(3)   Once the precharge is completed and the minimum t_{RP} is satisfied, the mode register can be programmed. After the mode register set cycle, t_{RSC} (2 CLK minimum) pause must be satisfied as well.

(4)   Two or more CBR (Auto) refresh must be performed.

Remarks 1. The sequence of Mode register programming and Refresh above may be transposed.
          2. CKE and DQM must be held high until the Precharge command is issued to ensure data-bus Hi-Z.

6. Programming the Mode Register

The mode register is programmed by the Mode register set command using address bits A11 through A0, BA0(A13) and BA1(A12) as data inputs. The register retains data until it is reprogrammed or the device loses power.

The mode register has four fields;

Options   : A11 through A7, BA0(A13), BA1(A12)
/CAS latency : A6 through A4
Wrap type   : A3
Burst length   : A2 through A0

Following mode register programming, no command can be issued before at least 2 CLK have elapsed.

/CAS Latency

/CAS latency is the most critical of the parameters being set. It tells the device how many clocks must elapse before the data will be available.
The value is determined by the frequency of the clock and the speed grade of the device. **13.3 Relationship between Frequency and Latency** shows the relationship of /CAS latency to the clock period and the speed grade of the device.

Burst Length

Burst Length is the number of words that will be output or input in a read or write cycle. After a read burst is completed, the output bus will become Hi-Z.
The burst length is programmable as 1, 2, 4, 8 or full page.

Wrap Type (Burst Sequence)

The wrap type specifies the order in which the burst data will be addressed. This order is programmable as either "Sequential" or "Interleave". The method chosen will depend on the type of CPU in the system.
Some microprocessor cache systems are optimized for sequential addressing and others for interleaved addressing. **7.1 Burst Length and Sequence** shows the addressing sequence for each burst length using them. Both sequences support bursts of 1, 2, 4 and 8. Additionally, sequence supports the full page length.

7. Mode Register

BA0 (A13)	BA1 (A12)	A11	A10	A9	A8	A7	A6	A5	A4	A3	A2	A1	A0	
0	0	0	0	0	0	1								JEDEC Standard Test Set (refresh counter test)

BA0 (A13)	BA1 (A12)	A11	A10	A9	A8	A7	A6	A5	A4	A3	A2	A1	A0	
x	x	x	x	1	0	0	LTMODE			WT	BL			Burst Read and Single Write (for Write Through Cache)

BA0 (A13)	BA1 (A12)	A11	A10	A9	A8	A7	A6	A5	A4	A3	A2	A1	A0	
					1	0								Use in future

BA0 (A13)	BA1 (A12)	A11	A10	A9	A8	A7	A6	A5	A4	A3	A2	A1	A0	
x	x	x	x	x	1	1	V	V	V	V	V	V	V	Vender Specific

V = Valid
x = Don't care

BA0 (A13)	BA1 (A12)	A11	A10	A9	A8	A7	A6	A5	A4	A3	A2	A1	A0	
0	0	0	0	0	0	0	LTMODE			WT	BL			Mode Register Set

	Bits2-0	WT = 0	WT = 1
	000	1	1
	001	2	2
	010	4	4
Burst length	011	8	8
	100	R	R
	101	R	R
	110	R	R
	111	Full page	R

	0	Sequential
Wrap type	1	Interleave

	Bits6-4	/CAS latency
	000	R
	001	R
	010	2
	011	3
Latency mode	100	R
	101	R
	110	R
	111	R

Remark R : Reserved

Mode Register Set Timing

CLK
CKE
/CS
/RAS
/CAS
/WE
A0 - A11, BA0(13), BA1(A12)
Mode Register Set

Data Sheet E0031N30
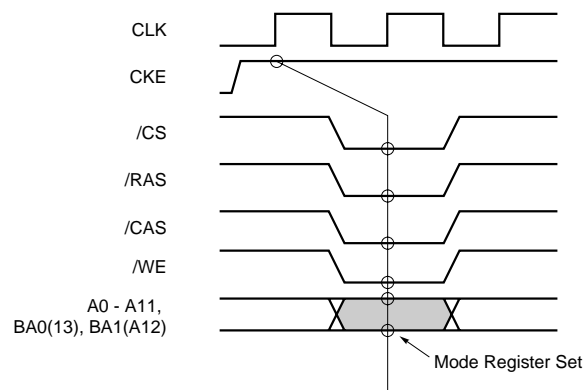
7.1 Burst Length and Sequence

[Burst of Two]

Starting address (column address A0, binary)	Sequential addressing sequence (decimal)	Interleave addressing sequence (decimal)
0	0, 1	0, 1
1	1, 0	1, 0

[Burst of Four]

Starting address (column address A1 - A0, binary)	Sequential addressing sequence (decimal)	Interleave addressing sequence (decimal)
00	0, 1, 2, 3	0, 1, 2, 3
01	1, 2, 3, 0	1, 0, 3, 2
10	2, 3, 0, 1	2, 3, 0, 1
11	3, 0, 1, 2	3, 2, 1, 0

[Burst of Eight]

Starting address (column address A2 - A0, binary)	Sequential addressing sequence (decimal)	Interleave addressing sequence (decimal)
000	0, 1, 2, 3, 4, 5, 6, 7	0, 1, 2, 3, 4, 5, 6, 7
001	1, 2, 3, 4, 5, 6, 7, 0	1, 0, 3, 2, 5, 4, 7, 6
010	2, 3, 4, 5, 6, 7, 0, 1	2, 3, 0, 1, 6, 7, 4, 5
011	3, 4, 5, 6, 7, 0, 1, 2	3, 2, 1, 0, 7, 6, 5, 4
100	4, 5, 6, 7, 0, 1, 2, 3	4, 5, 6, 7, 0, 1, 2, 3
101	5, 6, 7, 0, 1, 2, 3, 4	5, 4, 7, 6, 1, 0, 3, 2
110	6, 7, 0, 1, 2, 3, 4, 5	6, 7, 4, 5, 2, 3, 0, 1
111	7, 0, 1, 2, 3, 4, 5, 6	7, 6, 5, 4, 3, 2, 1, 0

Full page burst is an extension of the above tables of sequential addressing, with the length being 2,048 (for 32M ×4 device), 1,024 (for 16M ×8 device), and 512 (for 8M ×16 device).

8. Address Bits of Bank-Select and Precharge

Row | A0 | A1 | A2 | A3 | A4 | A5 | A6 | A7 | A8 | A9 | A10 | A11 | BA1(A12) | BA0(A13)

(Activate command)

BA1(A12)	BA0(A13)	Result
0	0	**Select Bank A "Activate" command**
0	1	**Select Bank B "Activate" command**
1	0	**Select Bank C "Activate" command**
1	1	**Select Bank D "Activate" command**

A0 | A1 | A2 | A3 | A4 | A5 | A6 | A7 | A8 | A9 | A10 | A11 | BA1(A12) | BA0(A13)

(Precharge command)

A10	BA1(A12)	BA0(A13)	Result
0	0	0	**Precharge Bank A**
0	0	1	**Precharge Bank B**
0	1	0	**Precharge Bank C**
0	1	1	**Precharge Bank D**
1	x	x	**Precharge All Banks**

x : Don't care

0	**disables Auto-Precharge (End of Burst)**
1	**enables Auto-Precharge (End of Burst)**

Col. | A0 | A1 | A2 | A3 | A4 | A5 | A6 | A7 | A8 | A9 | A10 | x | BA1(A12) | BA0(A13)

(/CAS strobes)

BA1(A12)	BA0(A13)	Result
0	0	**enables Read/Write commands for Bank A**
0	1	**enables Read/Write commands for Bank B**
1	0	**enables Read/Write commands for Bank C**
1	1	**enables Read/Write commands for Bank D**

9. Precharge

The precharge command can be issued anytime after $t_{RAS (MIN.)}$ is satisfied.

Soon after the precharge command is issued, precharge operation performed and the synchronous DRAM enters the idle state after t_{RP} is satisfied. The parameter t_{RP} is the time required to perform the precharge.

The earliest timing in a read cycle that a precharge command can be issued without losing any data in the burst is as follows.

It is depending on the /CAS latency and clock cycle time.

Burst length=4

(t_{RAS} must be satisfied)
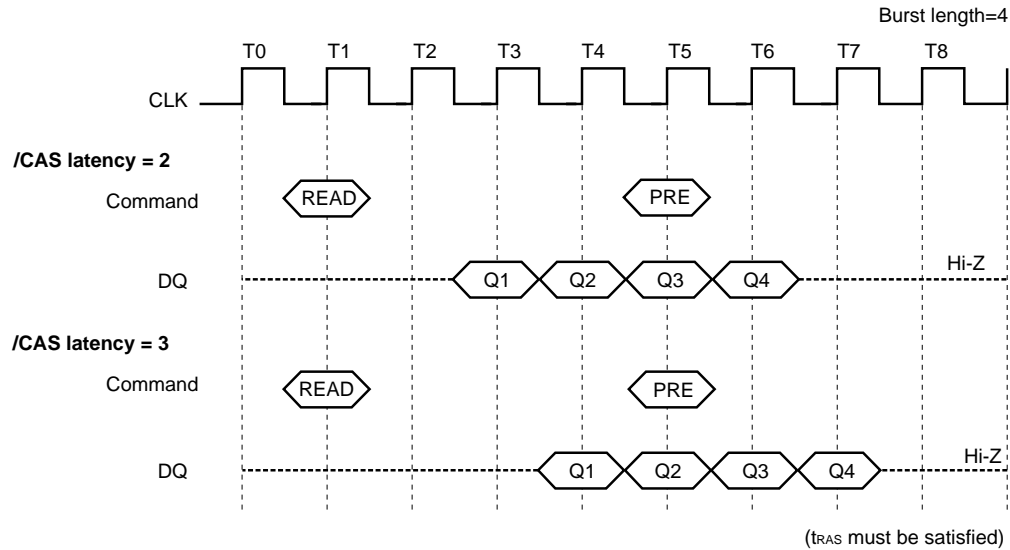
In order to write all data to the memory cell correctly, the asynchronous parameter "t_{DPL}" must be satisfied. The $t_{DPL (MIN.)}$ specification defines the earliest time that a precharge command can be issued. Minimum number of clocks is calculated by dividing $t_{DPL (MIN.)}$ with clock cycle time.

In summary, the precharge command can be issued relative to reference clock that indicates the last data word is valid. In the following table, minus means clocks before the reference; plus means time after the reference.

/CAS latency	Read	Write
2	−1	+$t_{DPL (MIN.)}$
3	−2	+$t_{DPL (MIN.)}$

10. Auto Precharge

During a read or write command cycle, A10 controls whether auto precharge is selected. A10 high in the Read or Write command (Read with Auto precharge command or Write with Auto precharge command), auto precharge is selected and begins automatically.

The t_{RAS} must be satisfied with a read with auto precharge or a write with auto precharge operation. In addition, the next activate command to the bank being precharged cannot be executed until the precharge cycle ends.

In read cycle, once auto precharge has started, an activate command to the bank can be issued after t_{RP} has been satisfied.

In write cycle, the t_{DAL} must be satisfied to issue the next activate command to the bank being precharged.

The timing that begins the auto precharge cycle depends on both the /CAS latency programmed into the mode register and whether read or write cycle.

10.1 Read with Auto Precharge

During a read cycle, the auto precharge begins one clock earlier (/CAS latency of 2) or two clocks earlier (/CAS latency of 3) the last data word output.
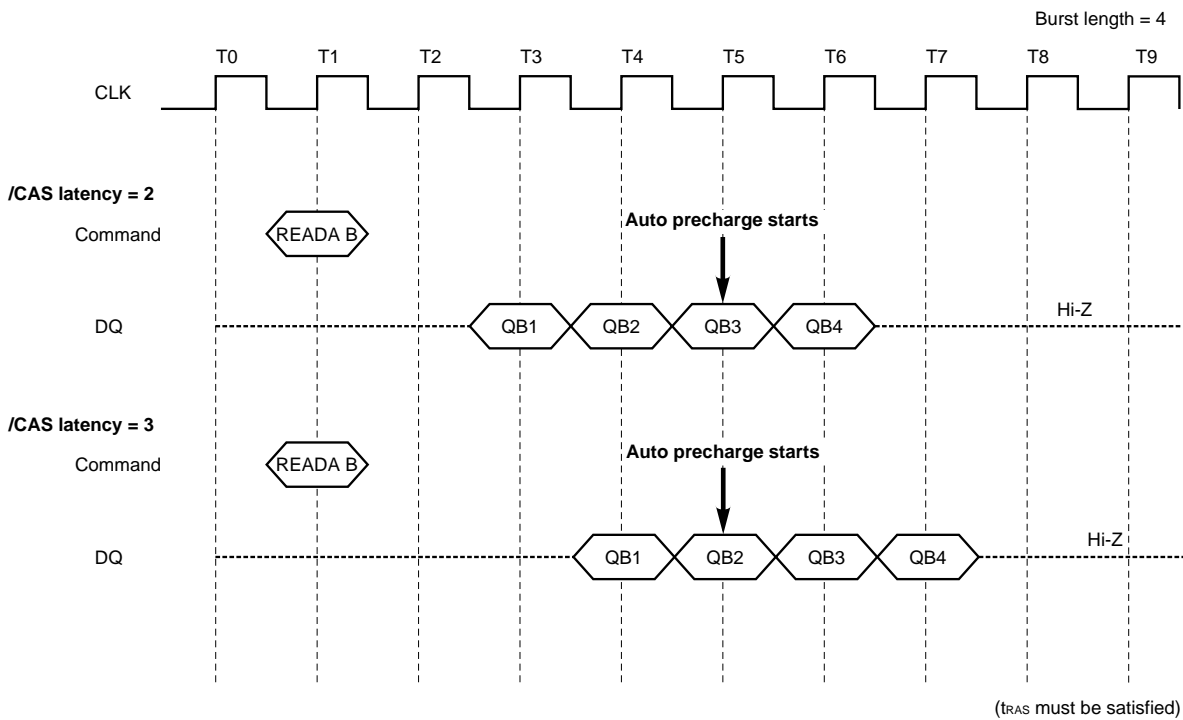
Remark READA means Read with Auto precharge

10.2 Write with Auto Precharge

During a write cycle, the auto precharge starts at the timing that is equal to the value of the $t_{DPL \text{ (MIN.)}}$ after the last data word input to the device.

Burst length = 4
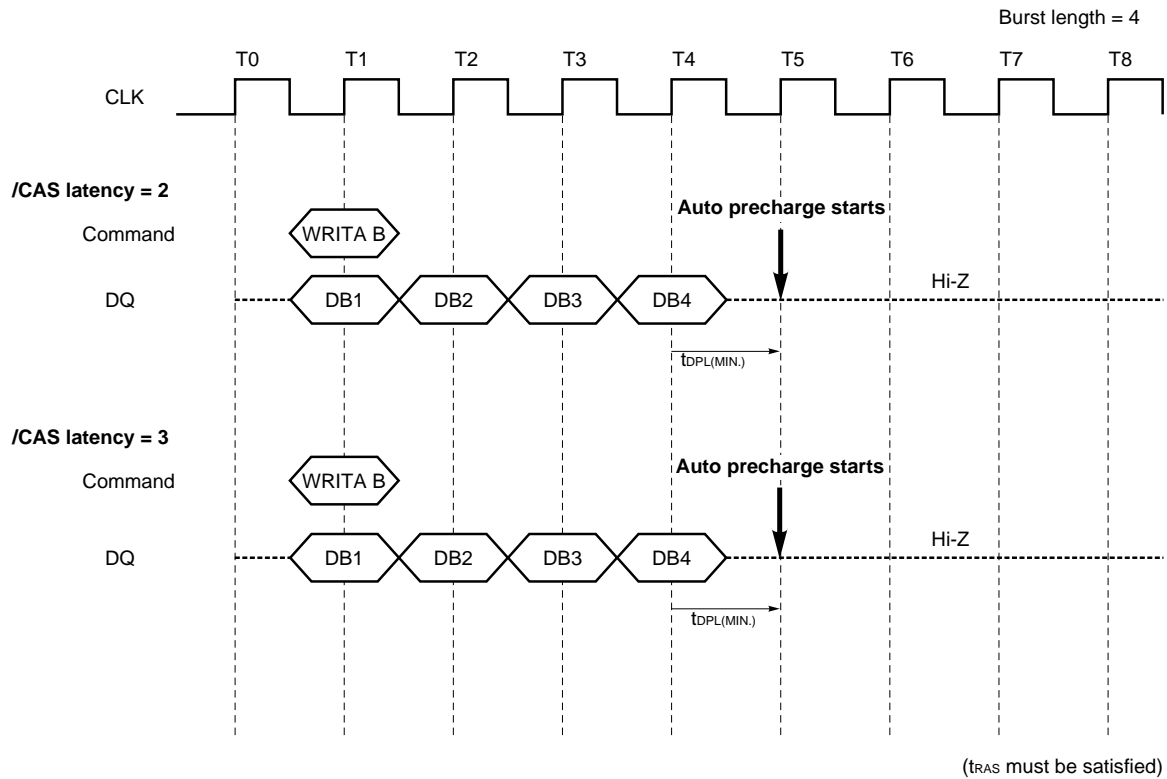
Remark WRITA means Write with Auto Precharge

In summary, the auto precharge begins relative to a reference clock that indicates the last data word is valid.
In the table below, minus means clocks before the reference; plus means after the reference.

/CAS latency	Read	Write
2	−1	$+t_{DPL \text{ (MIN.)}}$
3	−2	$+t_{DPL \text{ (MIN.)}}$

11. Read / Write Command Interval

11.1 Read to Read Command Interval

During a read cycle, when new Read command is issued, it will be effective after /CAS latency, even if the previous read operation does not completed. READ will be interrupted by another READ.

The interval between the commands is 1 cycle minimum. Each Read command can be issued in every clock without any restriction.

Burst length = 4, /CAS latency = 2
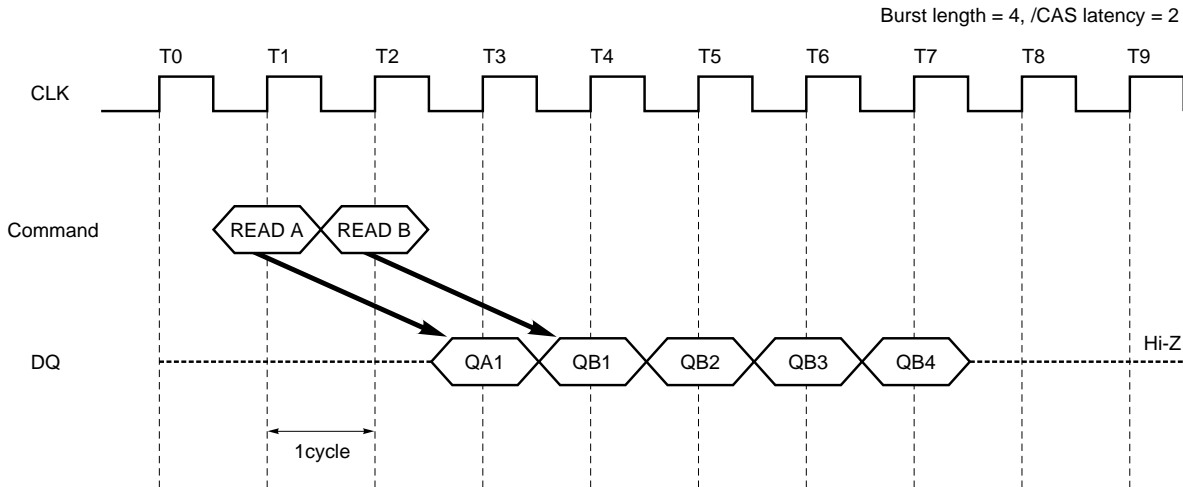
11.2 Write to Write Command Interval

During a write cycle, when a new Write command is issued, the previous burst will terminate and the new burst will begin with a new Write command. WRITE will be interrupted by another WRITE.

The interval between the commands is minimum 1 cycle. Each Write command can be issued in every clock without any restriction.

Burst length = 4, /CAS latency = 2
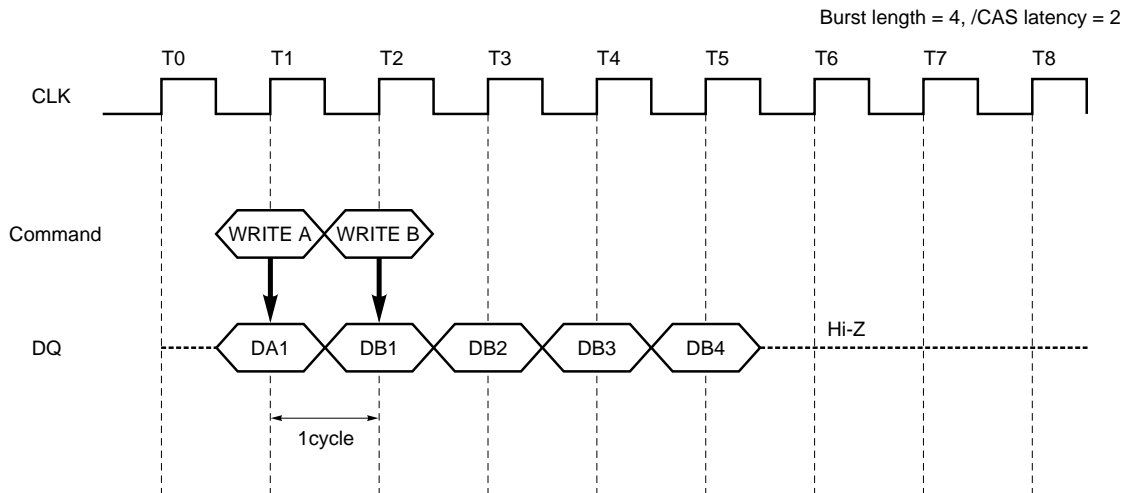
11.3 Write to Read Command Interval

Write command and Read command interval is also 1 cycle.

Only the write data before Read command will be written.

The data bus must be Hi-Z at least one cycle prior to the first D_{OUT}.
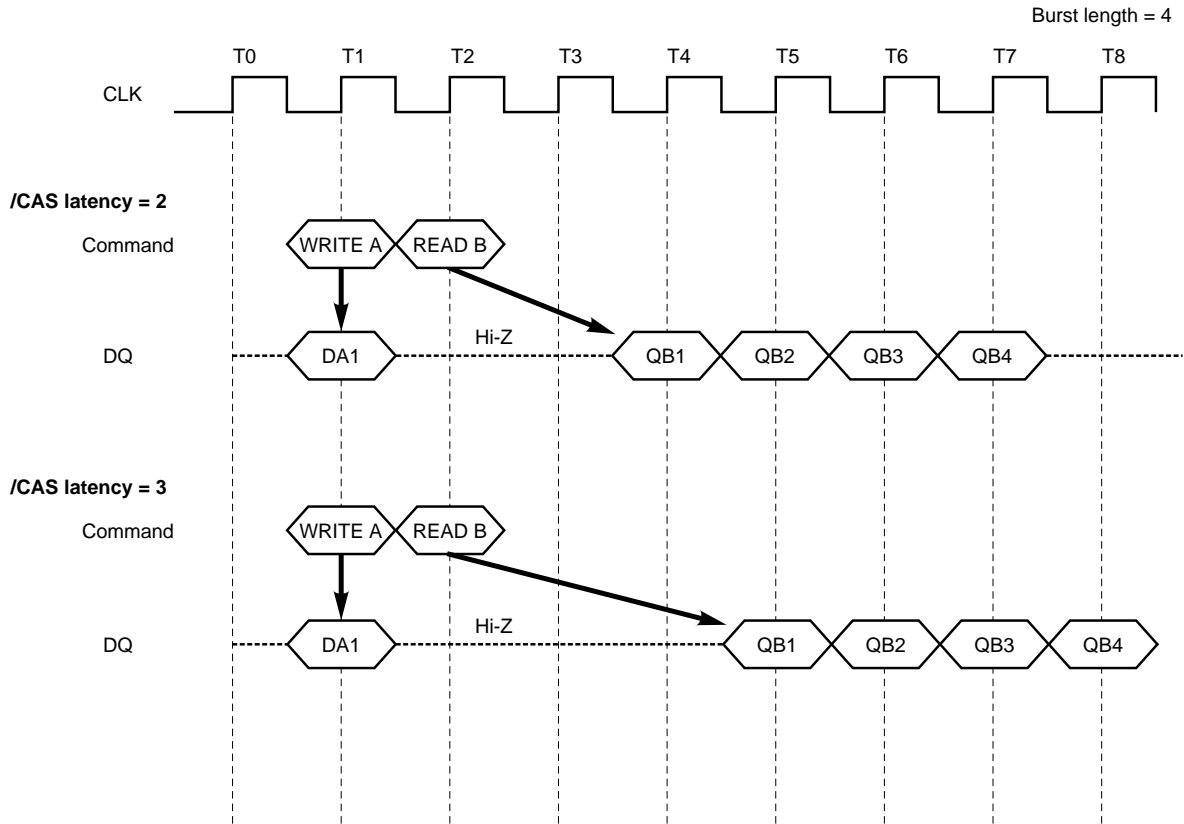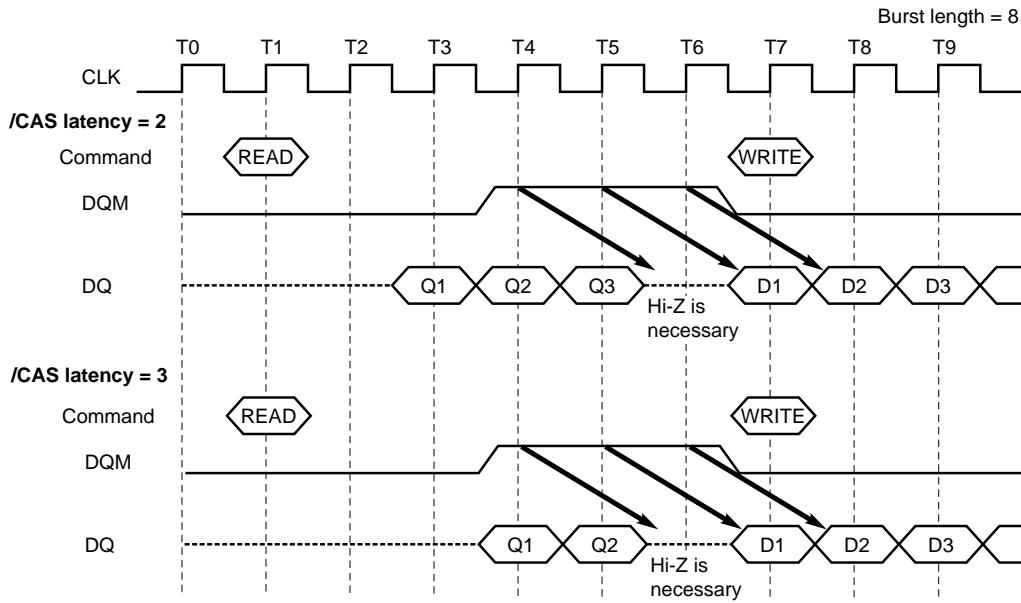
11.4 Read to Write Command Interval

During a read cycle, READ can be interrupted by WRITE.

The Read and Write command interval is 1 cycle minimum. There is a restriction to avoid data conflict. The Data bus must be Hi-Z using DQM before WRITE.

Burst length = 4
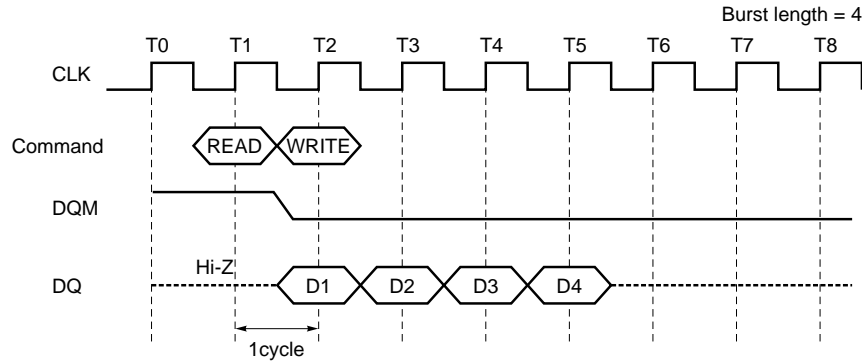
READ can be interrupted by WRITE. DQM must be High at least 3 clocks prior to the Write command.

Burst length = 8

12. Burst Termination

There are two methods to terminate a burst operation other than using a Read or a Write command. One is the burst stop command and the other is the precharge command.
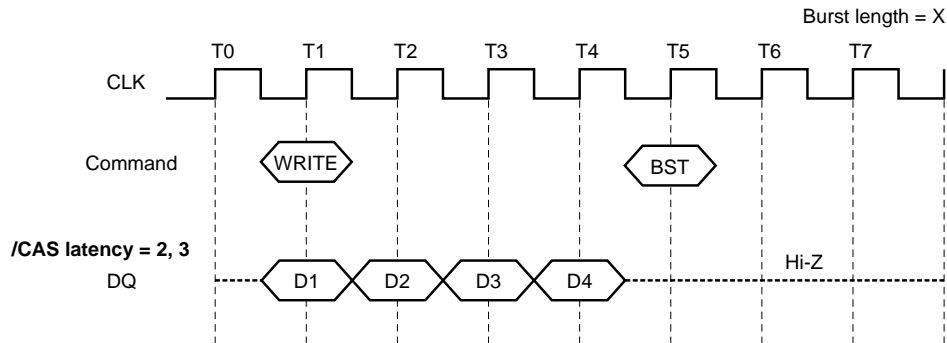
12.1 Burst Stop Command

During a read cycle, when the burst stop command is issued, the burst read data are terminated and the data bus goes to Hi-Z after the /CAS latency from the burst stop command.
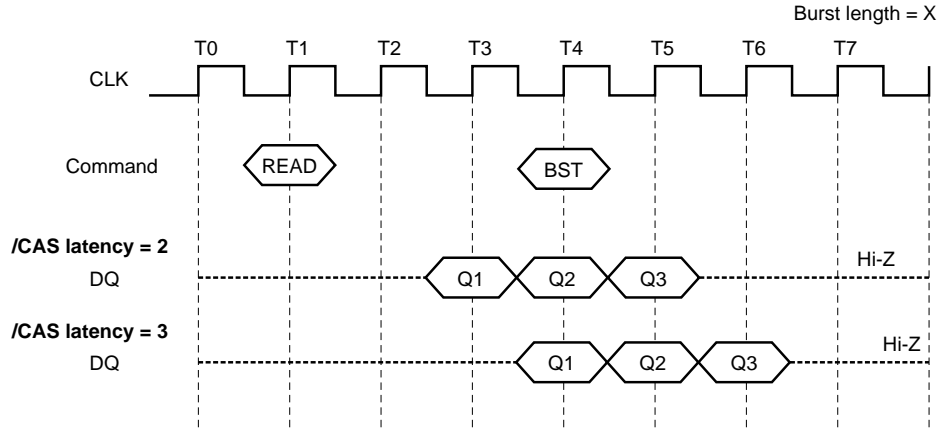
Remark BST: Burst stop command

During a write cycle, when the burst stop command is issued, the burst write data are terminated and data bus goes to Hi-Z at the same clock with the burst stop command.

Remark BST: Burst stop command

12.2 Precharge Termination

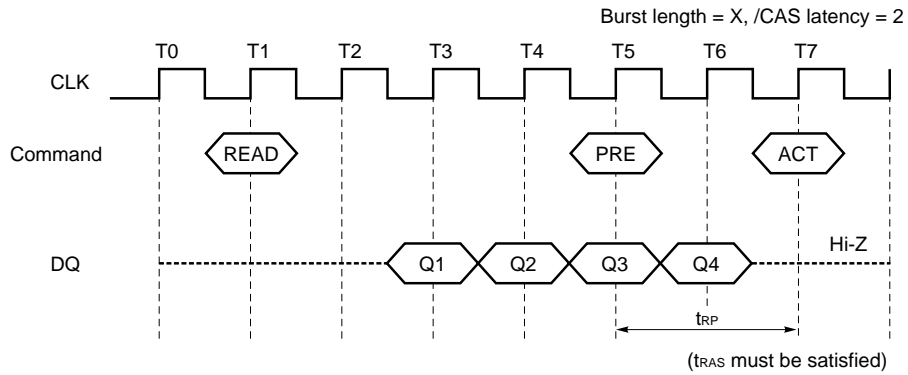### 12.2.1 Precharge Termination in READ Cycle

During a read cycle, the burst read operation is terminated by a precharge command.

When the precharge command is issued, the burst read operation is terminated and precharge starts.

The same bank can be activated again after t_{RP} from the precharge command.

To issue a precharge command, t_{RAS} must be satisfied.

When /CAS latency is 2, the read data will remain valid until one clock after the precharge command.

Burst length = X, /CAS latency = 2

When /CAS latency is 3, the read data will remain valid until two clocks after the precharge command.

Burst length = X, /CAS latency = 3

12.2.2 Precharge Termination in WRITE Cycle

During a write cycle, the burst write operation is terminated by a precharge command.

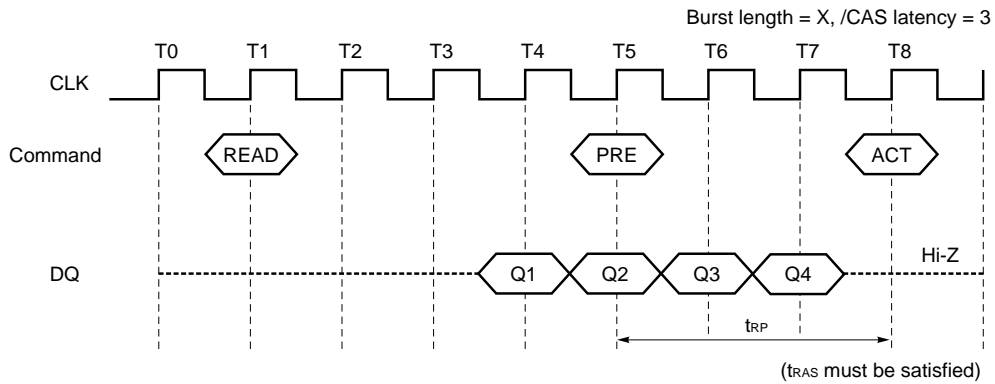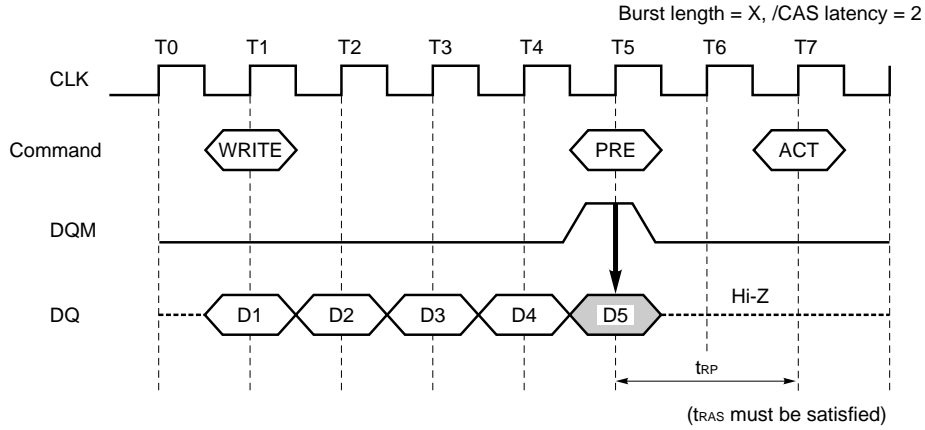When the precharge command is issued, the burst write operation is terminated and precharge starts.
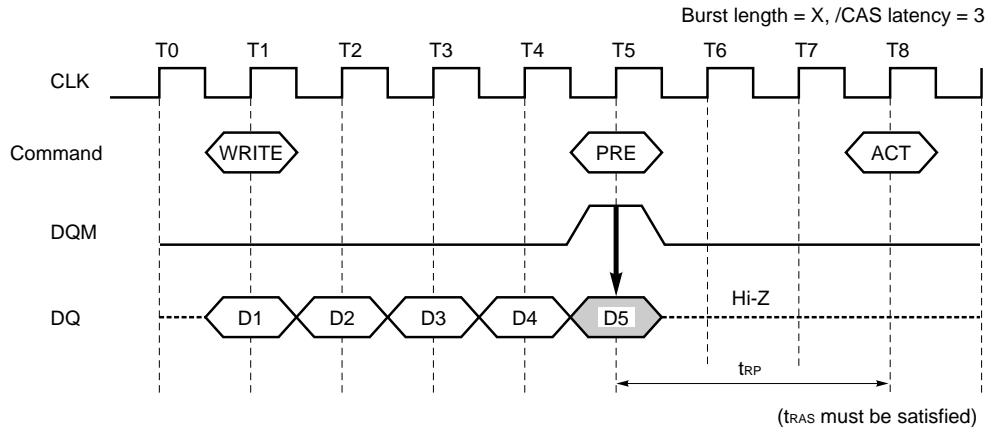
The same bank can be activated again after t_{RP} from the precharge command.

To issue a precharge command, t_{RAS} must be satisfied.

When /CAS latency is 2, the write data written prior to the precharge command will be correctly stored. However, invalid data may be written at the same clock as the precharge command. To prevent this from happening, DQM must be high at the same clock as the precharge command. This will mask the invalid data.

Burst length = X, /CAS latency = 2

T0	T1	T2	T3	T4	T5	T6	T7

CLK

Command: WRITE (T1), PRE (T5), ACT (T7)

DQM

DQ: D1, D2, D3, D4, D5, Hi-Z

t_{RP}

(t_{RAS} must be satisfied)

When /CAS latency is 3, the write data written prior to the precharge command will be correctly stored. However, invalid data may be written at the same clock as the precharge command. To prevent this from happening, DQM must be high at the same clock as the precharge command. This will mask the invalid data.

Burst length = X, /CAS latency = 3

T0	T1	T2	T3	T4	T5	T6	T7	T8

CLK

Command: WRITE (T1), PRE (T5), ACT (T8)

DQM

DQ: D1, D2, D3, D4, D5, Hi-Z

t_{RP}

(t_{RAS} must be satisfied)

13. Electrical Specifications

- All voltages are referenced to Vss (GND).
- After power up, wait more than 100 μs and then, execute **Power on sequence and CBR (auto) Refresh** before proper device operation is achieved.

Absolute Maximum Ratings

Parameter	Symbol	Condition	Rating	Unit
Voltage on power supply pin relative to GND	V_{CC}, $V_{CC}Q$		−0.5 to +4.6	V
Voltage on any pin relative to GND	V_T		−0.5 to +4.6	V
Short circuit output current	I_O		50	mA
Power dissipation	P_D		1	W
Operating ambient temperature	T_A		0 to 70	°C
Storage temperature	T_{stg}		−55 to + 125	°C

Caution Exposing the device to stress above those listed in Absolute Maximum Ratings could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

Recommended Operating Conditions

Parameter	Symbol	Condition	MIN.	TYP.	MAX.	Unit
Supply voltage	V_{CC}, $V_{CC}Q$		3.0	3.3	3.6	V
High level input voltage	V_{IH}		2.0		V_{CC}+0.3[Note1]	V
Low level input voltage	V_{IL}		−0.3[Note2]		+0.8	V
Operating ambient temperature	T_A		0		70	°C

Notes 1. $V_{IH (MAX.)}$ = V_{CC} + 1.5 V (Pulse width ≤ 5 ns)

  2. $V_{IL (MIN.)}$ = −1.5 V (Pulse width ≤ 5 ns)

Pin Capacitance (T_A = 25 °C, f = 1 MHz)

Parameter	Symbol	Condition	MIN.	TYP.	MAX.	Unit
Input capacitance	C_{I1}	CLK	2.5		3.5	pF
	C_{I2}	A0 - A11, BA0(A13), BA1(A12), CKE, /CS, /RAS, /CAS, /WE, DQM, UDQM, LDQM	2.5		3.8	
Data input / output capacitance	$C_{I/O}$	DQ0 - DQ15	4		6.5	pF

DC Characteristics 1 (Recommended Operating Conditions unless otherwise noted)

Parameter	Symbol	Test condition	/CAS latency	Grade	Maximum ×4	Maximum ×8	Maximum ×16	Unit	Notes
Operating current	I_{CC1}	Burst length = 1, $t_{RC} \geq t_{RC\,(MIN.)}$, Io = 0 mA, One bank active	CL = 2	-A75A	110	110	120	mA	1
				-A75	100	100	110		
				-A80	100	100	110		
				-A10	100	100	110		
			CL = 3	-A75A	110	110	120		
				-A75	105	105	115		
				-A80	100	100	110		
				-A10	100	100	110		
Precharge standby current in power down mode	I_{CC2P}	$CKE \leq V_{IL\,(MAX.)}$, t_{CK} = 15 ns			1	1	1	mA	
	I_{CC2PS}	$CKE \leq V_{IL\,(MAX.)}$, t_{CK} = ∞			1	1	1		
Precharge standby current in non power down mode	I_{CC2N}	$CKE \geq V_{IH\,(MIN.)}$, t_{CK} = 15 ns, /CS $\geq V_{IH\,(MIN.)}$, Input signals are changed one time during 30 ns.			20	20	20	mA	
	I_{CC2NS}	$CKE \geq V_{IH\,(MIN.)}$, t_{CK} = ∞, Input signals are stable.			8	8	8		
Active standby current in power down mode	I_{CC3P}	$CKE \leq V_{IL\,(MAX.)}$, t_{CK} = 15 ns			5	5	5	mA	
	I_{CC3PS}	$CKE \leq V_{IL\,(MAX.)}$, t_{CK} = ∞			4	4	4		
Active standby current in non power down mode	I_{CC3N}	$CKE \geq V_{IH\,(MIN.)}$, t_{CK} = 15 ns, /CS $\geq V_{IH\,(MIN.)}$, Input signals are changed one time during 30 ns.			30	30	30	mA	
	I_{CC3NS}	$CKE \geq V_{IH\,(MIN.)}$, t_{CK} = ∞ , Input signals are stable.			20	20	20		
Operating current (Burst mode)	I_{CC4}	$t_{CK} \geq t_{CK\,(MIN.)}$, Io = 0 mA, All banks active	CL = 2	-A75A	140	155	185	mA	2
				-A75	105	120	145		
				-A80	105	120	145		
				-A10	85	95	110		
			CL = 3	-A75A	140	155	185		
				-A75	140	155	185		
				-A80	130	145	175		
				-A10	110	125	140		
CBR (auto) refresh current	I_{CC5}	$t_{RC} \geq t_{RC\,(MIN.)}$	CL = 2	-A75A	270	270	270	mA	3
				-A75	230	230	230		
				-A80	230	230	230		
				-A10	230	230	230		
			CL = 3	-A75A	270	270	270		
				-A75	240	240	240		
				-A80	230	230	230		
				-A10	230	230	230		
Self refresh current	I_{CC6}	$CKE \leq 0.2$ V		-**	2	2	2	mA	
				-**L	0.8	0.8	0.8	mA	

Notes 1. I_{CC1} depends on output loading and cycle rates. Specified values are obtained with the output open. In addition to this, I_{CC1} is measured condition that addresses are changed only one time during $t_{CK\,(MIN.)}$.

2. I_{CC4} depends on output loading and cycle rates. Specified values are obtained with the output open. In addition to this, I_{CC4} is measured condition that addresses are changed only one time during $t_{CK\,(MIN.)}$.

3. I_{CC5} is measured on condition that addresses are changed only one time during $t_{CK\,(MIN.)}$.

DC Characteristics 2 (Recommended Operating Conditions unless otherwise noted)

Parameter	Symbol	Test condition	MIN.	TYP.	MAX.	Unit	Note
Input leakage current	$I_{I(L)}$	$0 \leq V_I \leq V_{CC}Q$, $V_{CC}Q = V_{CC}$ All other pins not under test = 0 V	−1.0		+1.0	μA	
Output leakage current	$I_{O(L)}$	$0 \leq V_O \leq V_{CC}Q$, D_{OUT} is disabled	−1.5		+1.5	μA	
High level output voltage	V_{OH}	$I_O = -4$ mA	2.4			V	
Low level output voltage	V_{OL}	$I_O = +4$ mA			0.4	V	

AC Characteristics (Recommended Operating Conditions unless otherwise noted)

**Test Conditions**

Parameter	Value	Unit
AC high level input voltage / low level input voltage	2.4 / 0.4	V
Input timing measurement reference level	1.4	V
Transition time (Input rise and fall time)	1	ns
Output timing measurement reference level	1.4	V
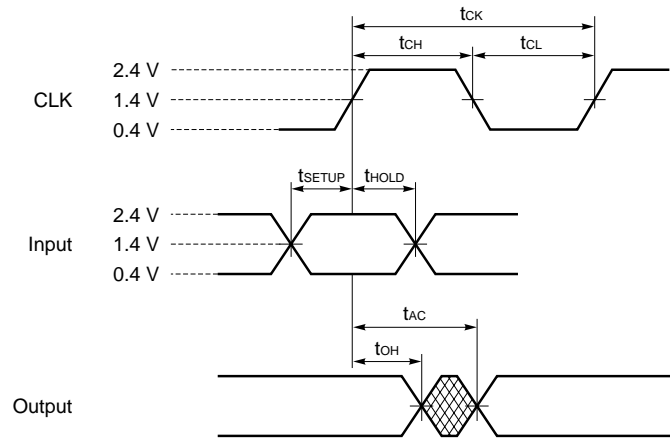
Synchronous Characteristics

Parameter		Symbol	-A75A		-A75		-A80		-A10		Unit	Note
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
Clock cycle time	/CAS latency = 3	t_{CK3}	7.5	(133 MHz)	7.5	(133 MHz)	8	(125 MHz)	10	(100 MHz)	ns	
	/CAS latency = 2	t_{CK2}	7.5	(133 MHz)	10	(100 MHz)	10	(100 MHz)	13	(77 MHz)	ns	
Access time from CLK	/CAS latency = 3	t_{AC3}		5.4		5.4		6		6	ns	1
	/CAS latency = 2	t_{AC2}		5.4		6		6		7	ns	1
CLK high level width		t_{CH}	2.5		2.5		3		3		ns	
CLK low level width		t_{CL}	2.5		2.5		3		3		ns	
Data-out hold time		t_{OH}	3		3		3		3		ns	1
Data-out low-impedance time		t_{LZ}	0		0		0		0		ns	
Data-out high-impedance time	/CAS latency = 3	t_{HZ3}	3	5.4	3	5.4	3	6	3	6	ns	
	/CAS latency = 2	t_{HZ2}	3	5.4	3	6	3	6	3	7	ns	
Data-in setup time		t_{DS}	1.5		1.5		2		2		ns	
Data-in hold time		t_{DH}	0.8		0.8		1		1		ns	
Address setup time		t_{AS}	1.5		1.5		2		2		ns	
Address hold time		t_{AH}	0.8		0.8		1		1		ns	
CKE setup time		t_{CKS}	1.5		1.5		2		2		ns	
CKE hold time		t_{CKH}	0.8		0.8		1		1		ns	
CKE setup time (Power down exit)		t_{CKSP}	1.5		1.5		2		2		ns	
Command (/CS, /RAS, /CAS, /WE, DQM) setup time		t_{CMS}	1.5		1.5		2		2		ns	
Command (/CS, /RAS, /CAS, /WE, DQM) hold time		t_{CMH}	0.8		0.8		1		1		ns	

Note 1. Output load

Z = 50 Ω
Output
50 pF
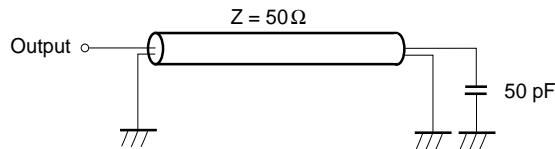
Asynchronous Characteristics

| Parameter		Symbol	-A75A		-A75		-A80		-A10		Unit	Note
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
ACT to REF/ACT command period (operation)		t_{RC}	60		67.5		70		70		ns	
REF to REF/ACT command period (refresh)		t_{RC1}	60		67.5		70		70		ns	
ACT to PRE command period		t_{RAS}	45	120,000	45	120,000	48	120,000	50	120,000	ns	
PRE to ACT command period		t_{RP}	15		20		20		20		ns	
Delay time ACT to READ/WRITE command		t_{RCD}	15		20		20		20		ns	
ACT (one) to ACT (another) command period		t_{RRD}	15		15		16		20		ns	
Data-in to PRE command period		t_{DPL}	8		8		8		10		ns	
Data-in to ACT (REF) command period (Auto precharge)	/CAS latency = 3	t_{DAL3}	1CLK +22.5		1CLK +22.5		1CLK +20		1CLK +20		ns	1
	/CAS latency = 2	t_{DAL2}	1CLK +20		1CLK +20		1CLK +20		1CLK +20		ns	
Mode register set cycle time		t_{RSC}	2		2		2		2		CLK	
Transition time		t_T	0.5	30	0.5	30	0.5	30	1	30	ns	
Refresh time (4,096 refresh cycles)		t_{REF}		64		64		64		64	ms	

Note 1. The –A75A and –A75 grade device can satisfy the t_{DAL3} spec of 1CLK+20 ns for up to and including 125MHz operation.

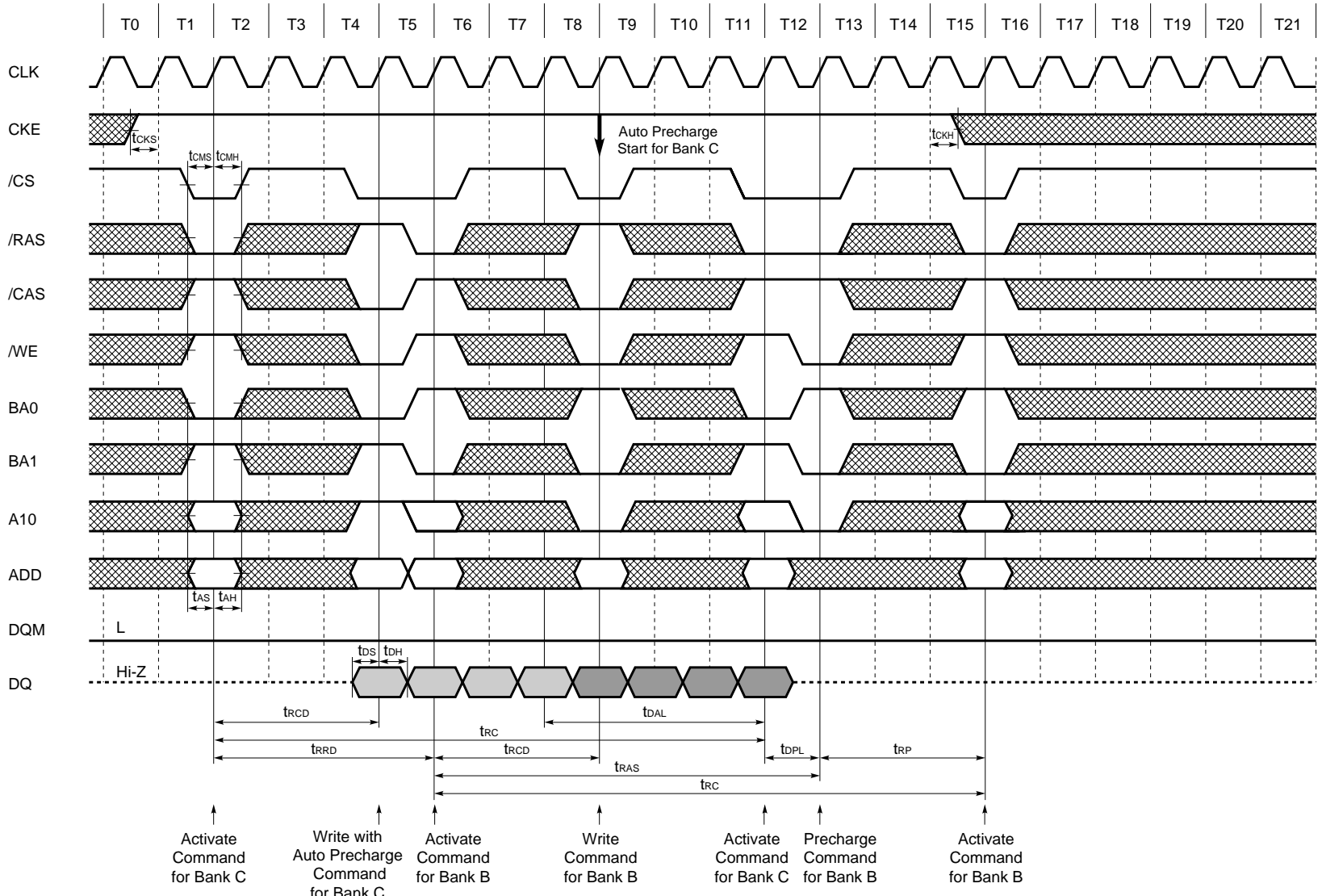**13.1 AC Parameters for Read Timing (Manual Precharge, Burst Length = 4, /CAS Latency = 3)**
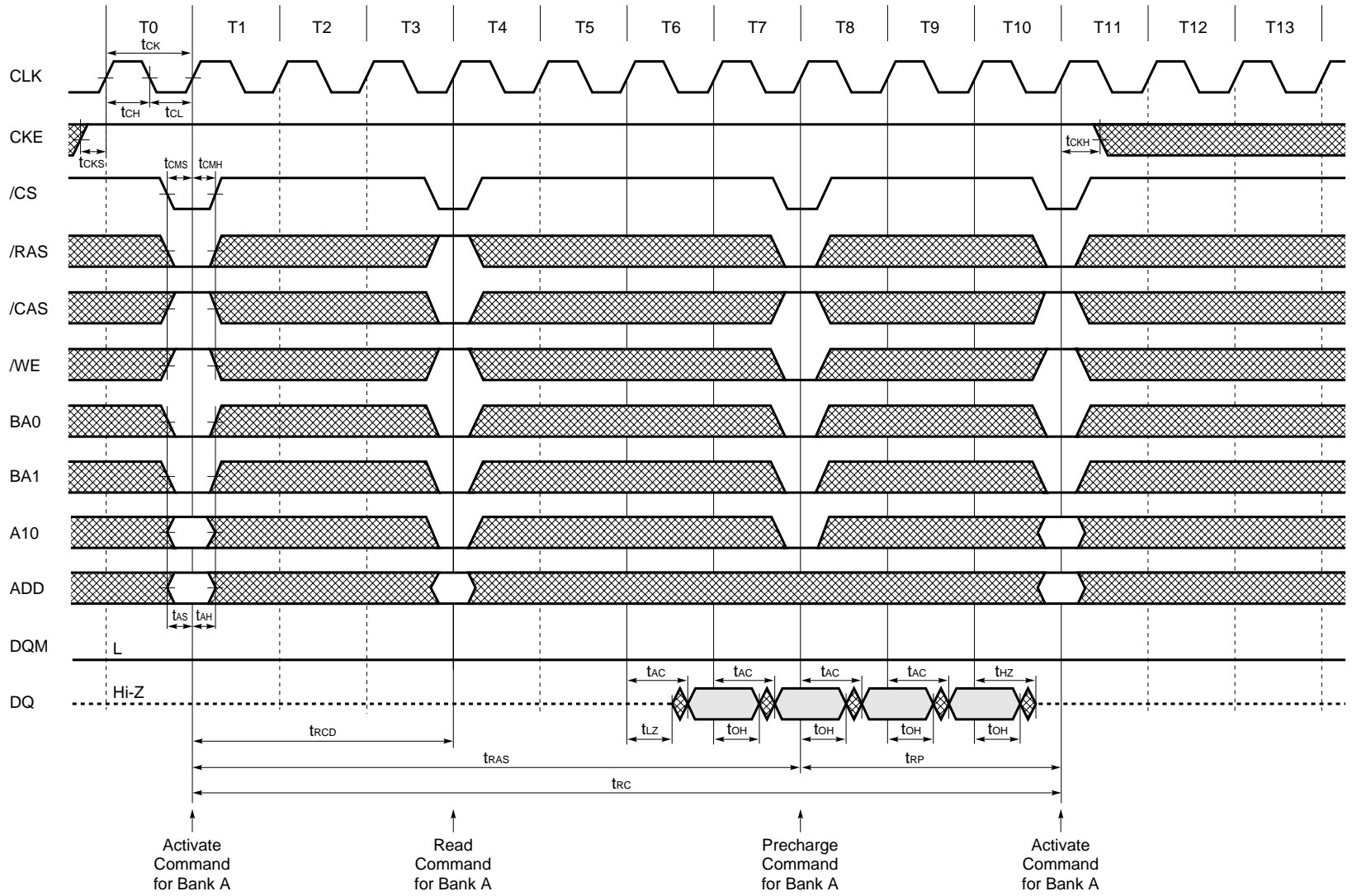
AC Parameters for Read Timing (Auto Precharge, Burst Length = 4, /CAS Latency = 3)
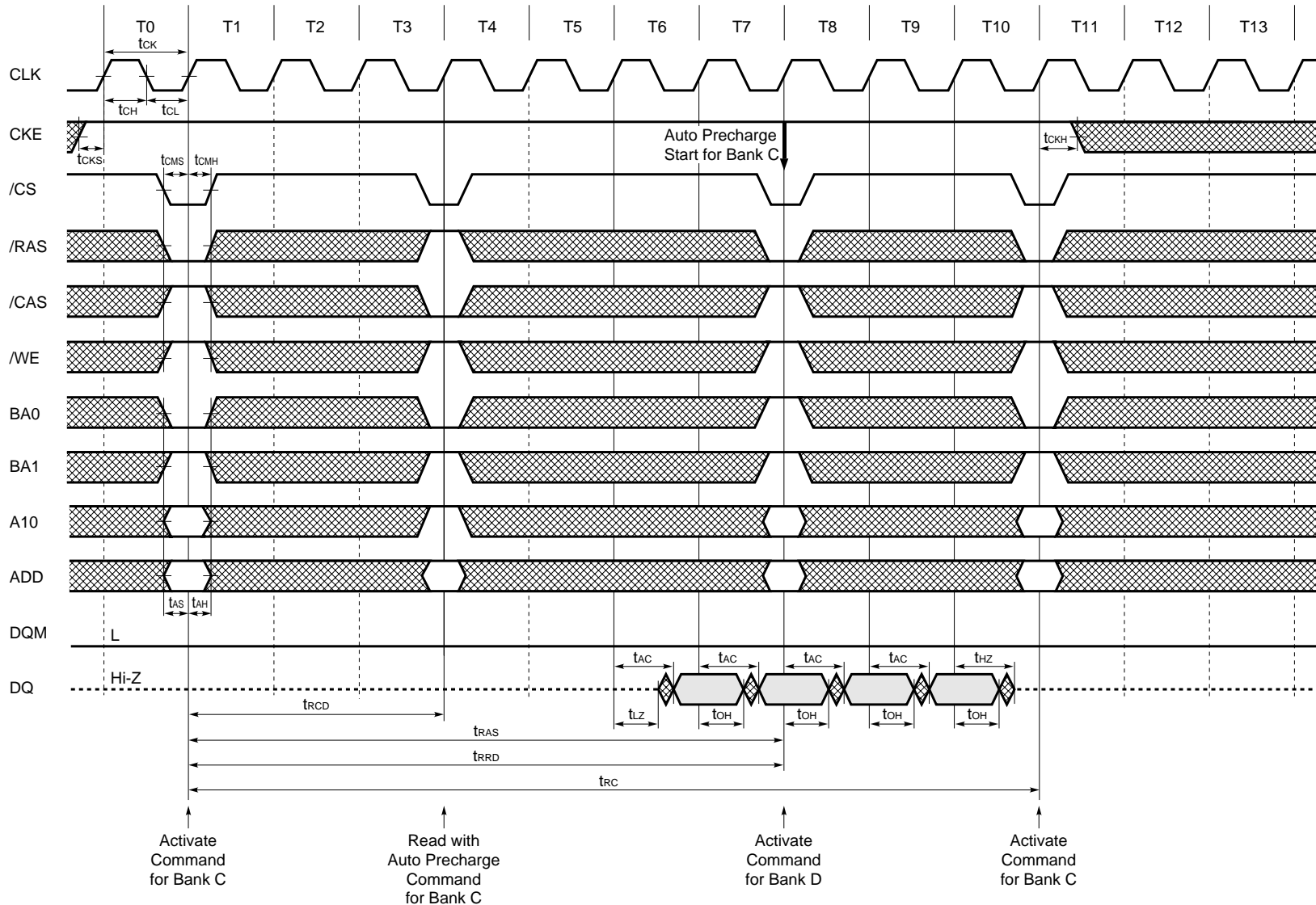
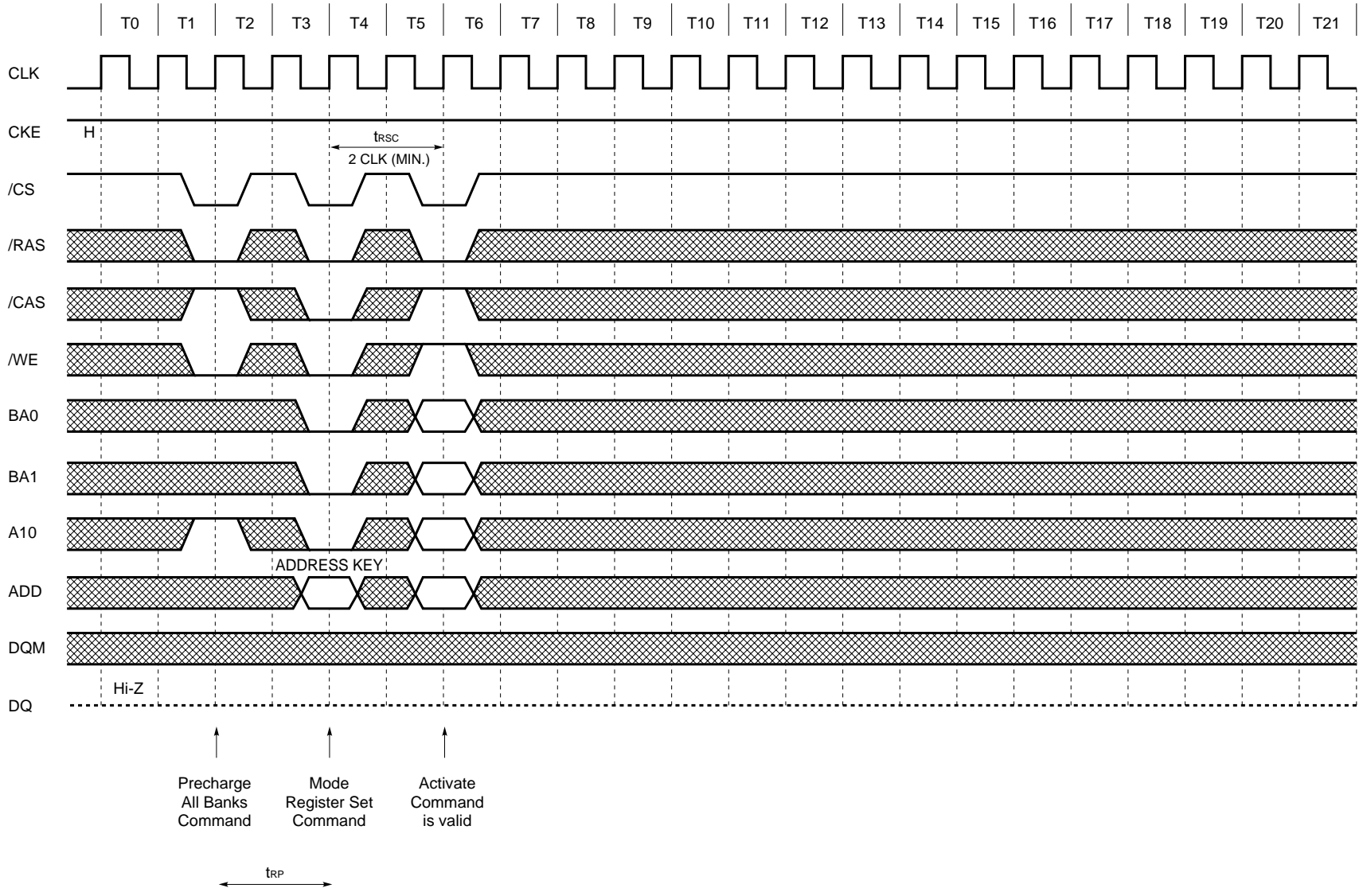## 13.2 AC Parameters for Write Timing (Burst Length = 4, /CAS Latency = 3)

13.3 Relationship between Frequency and Latency

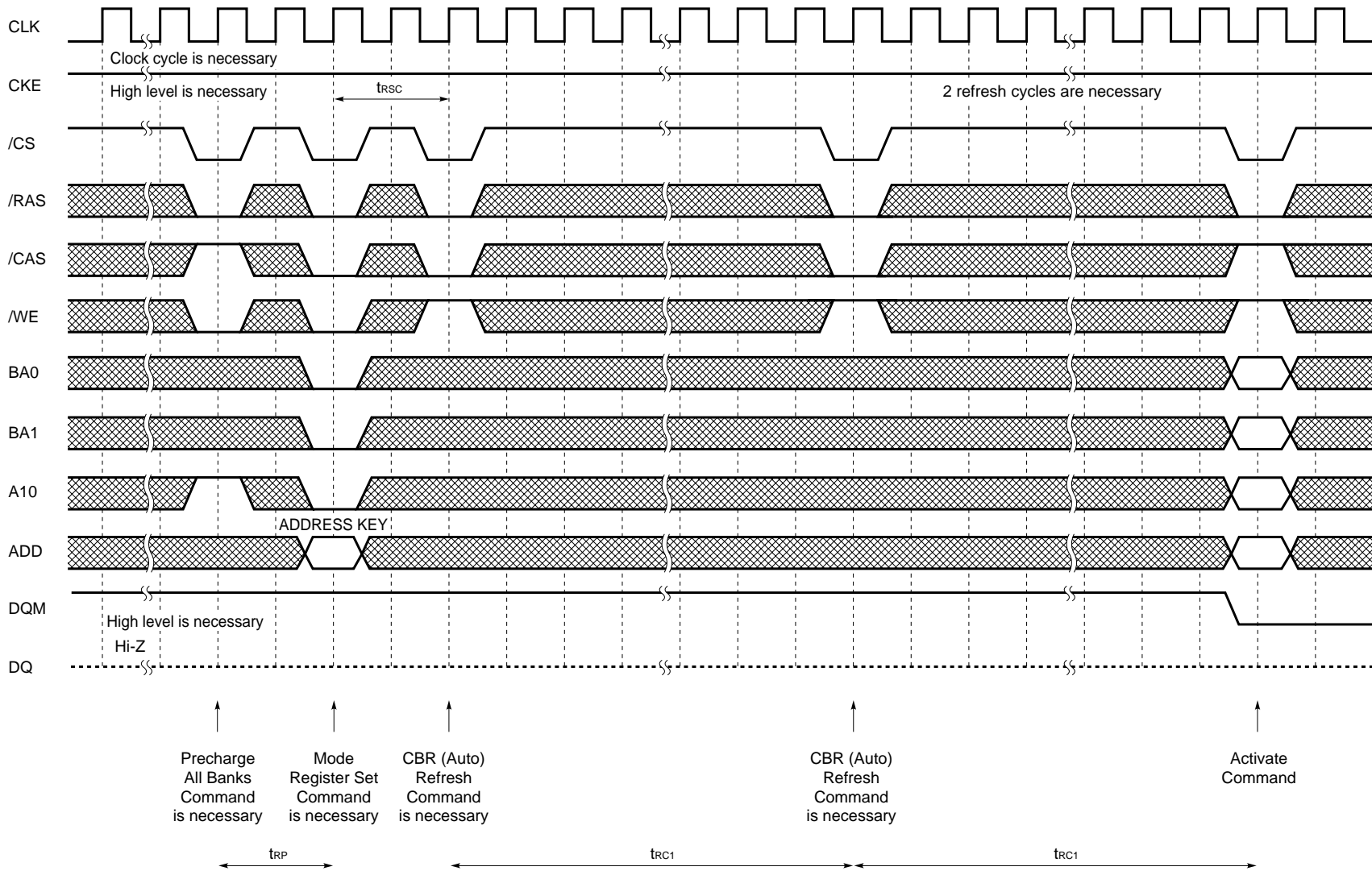| Speed version	-75A		-75		-80		-10	
Clock cycle time [ns]	7.5	7.5	7.5	10	8	10	10	13
Frequency [MHz]	133	133	133	100	125	100	100	77
/CAS latency	3	2	3	2	3	2	3	2
[t_{RCD}]	2	2	3	2	3	2	2	2
/RAS latency (/CAS latency + [t_{RCD}])	5	4	6	4	6	4	5	4
[t_{RC}]	8	8	9	7	9	7	7	6
[t_{RC1}]	8	8	9	7	9	7	8	6
[t_{RAS}]	6	6	6	5	6	5	5	4
[t_{RRD}]	2	2	2	2	2	2	2	2
[t_{RP}]	2	2	3	2	3	2	2	2
[t_{DPL}]	2	2	2	1	1	1	1	1
[t_{DAL}]	4	4	4	3	4	3	3	3
[t_{RSC}]	2	2	2	2	2	2	2	2

13.4 Mode Register Set (Burst Length = 4, /CAS Latency = 2)
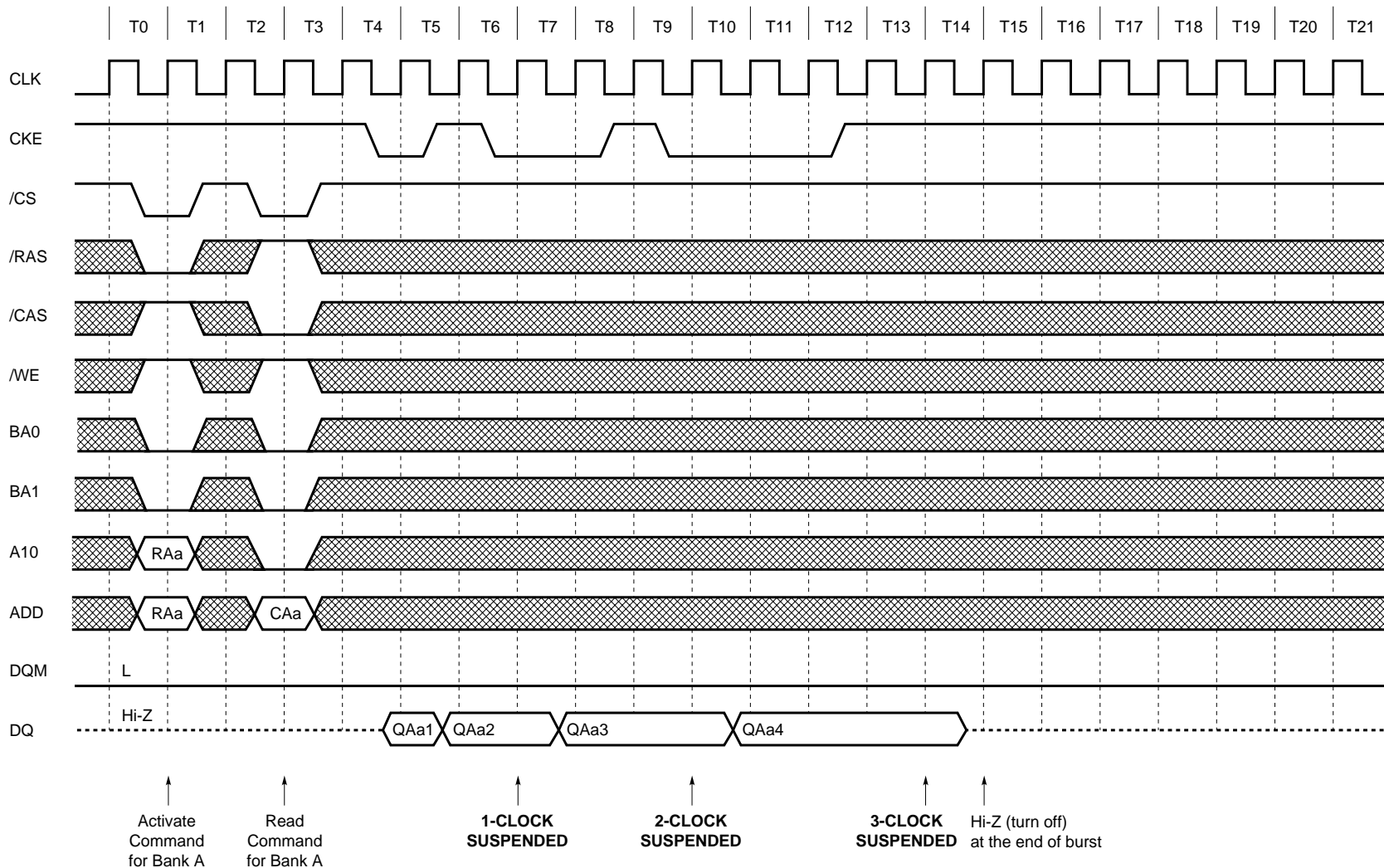
13.5 Power On Sequence and CBR (Auto) Refresh

CLK

CKE

/CS

/RAS

/CAS

/WE

BA0

BA1

A10

ADD

DQM

DQ

Clock cycle is necessary

High level is necessary

t_{RSC}

2 refresh cycles are necessary

ADDRESS KEY

High level is necessary

Hi-Z

Precharge
All Banks
Command
is necessary

Mode
Register Set
Command
is necessary

CBR (Auto)
Refresh
Command
is necessary

CBR (Auto)
Refresh
Command
is necessary

Activate
Command

t_{RP}

t_{RC1}

t_{RC1}

13.6 /CS Function (Burst Length = 4, /CAS Latency = 3)
Only /CS signal needs to be issued at minimum rate
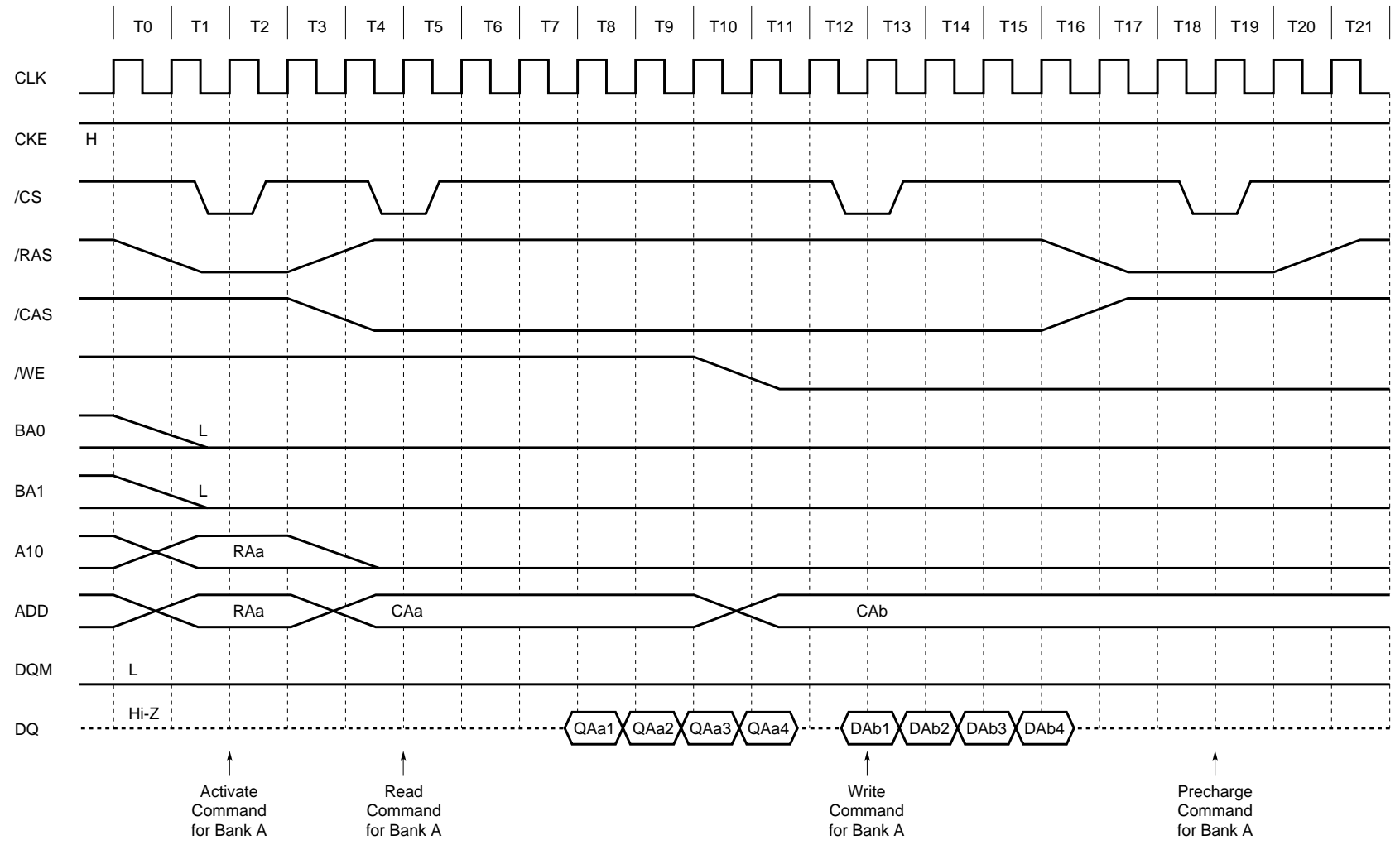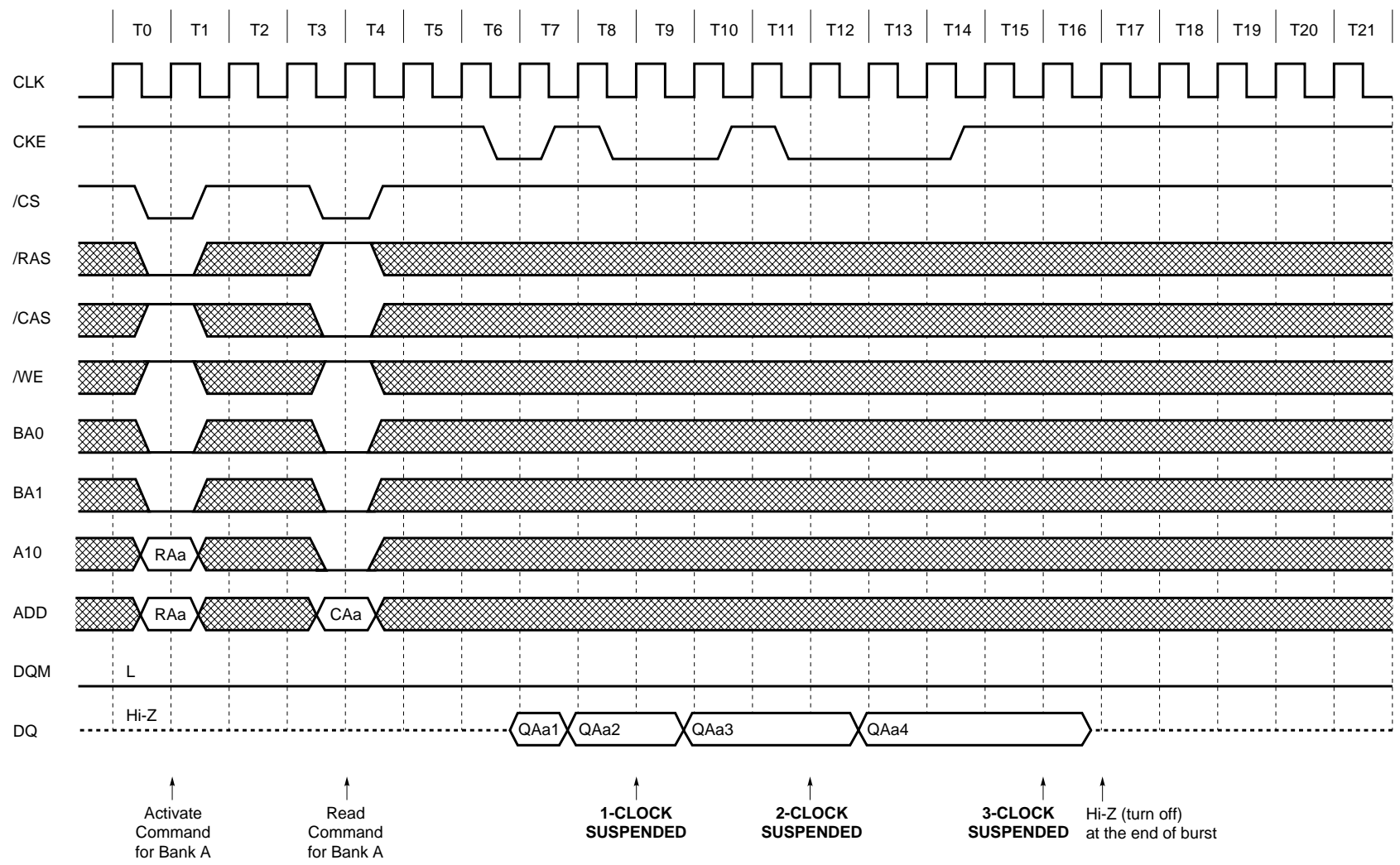
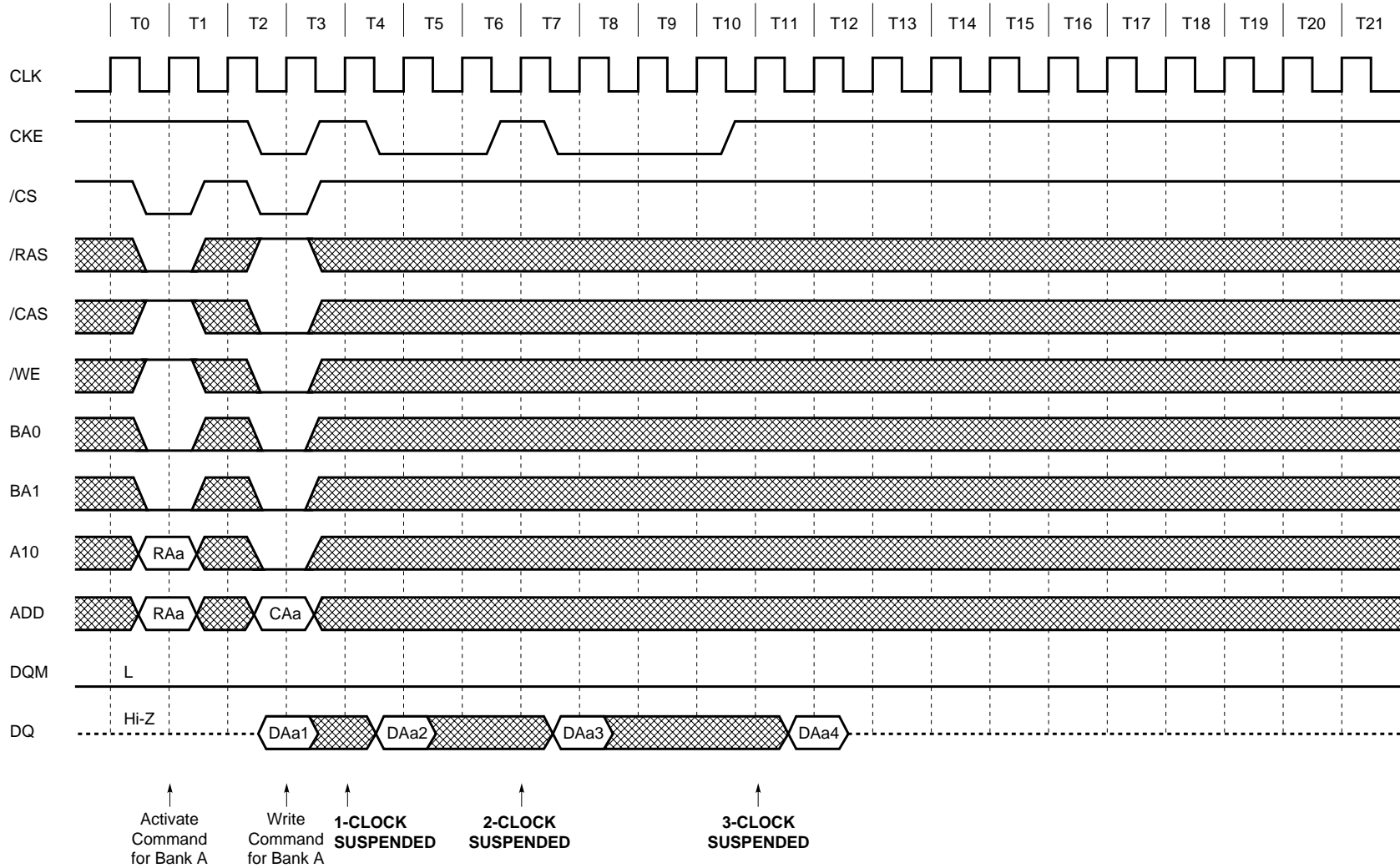**13.7 Clock Suspension during Burst Read (using CKE Function) (1/2) (Burst Length = 4, /CAS Latency = 2)**

| | T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 | T15 | T16 | T17 | T18 | T19 | T20 | T21 |

CLK

CKE

/CS

/RAS

/CAS

/WE

BA0

BA1

A10 — RAa

ADD — RAa — CAa

DQM — L

DQ — Hi-Z — QAa1 — QAa2 — QAa3 — QAa4

Activate Command for Bank A

Read Command for Bank A

1-CLOCK SUSPENDED

2-CLOCK SUSPENDED

3-CLOCK SUSPENDED

Hi-Z (turn off) at the end of burst

Clock Suspension during Burst Read (using CKE Function) (2/2) (Burst Length = 4, /CAS Latency = 3)

13.8   Clock Suspension during Burst Write (using CKE Function) (1/2) (Burst Length = 4, /CAS Latency = 2)

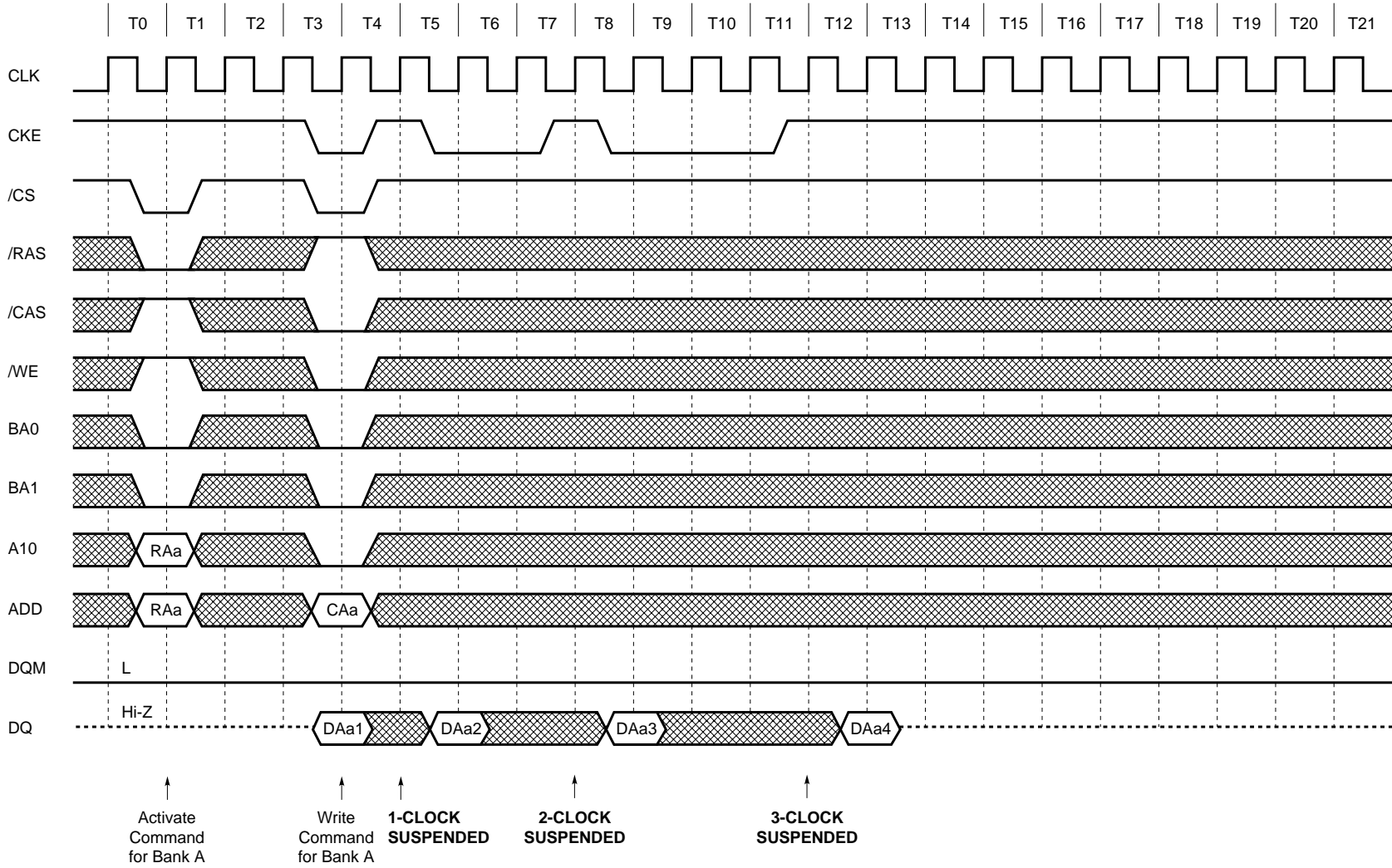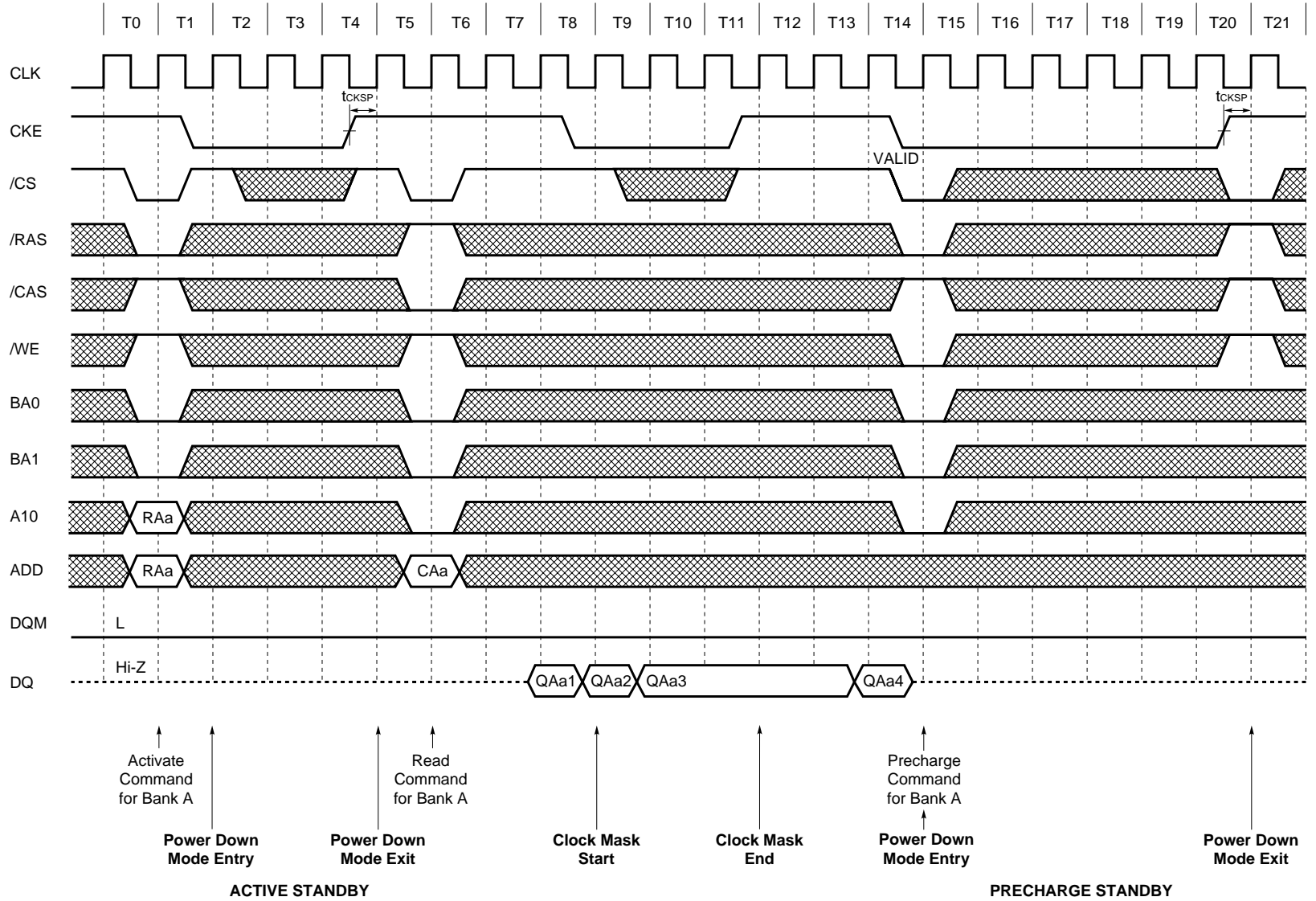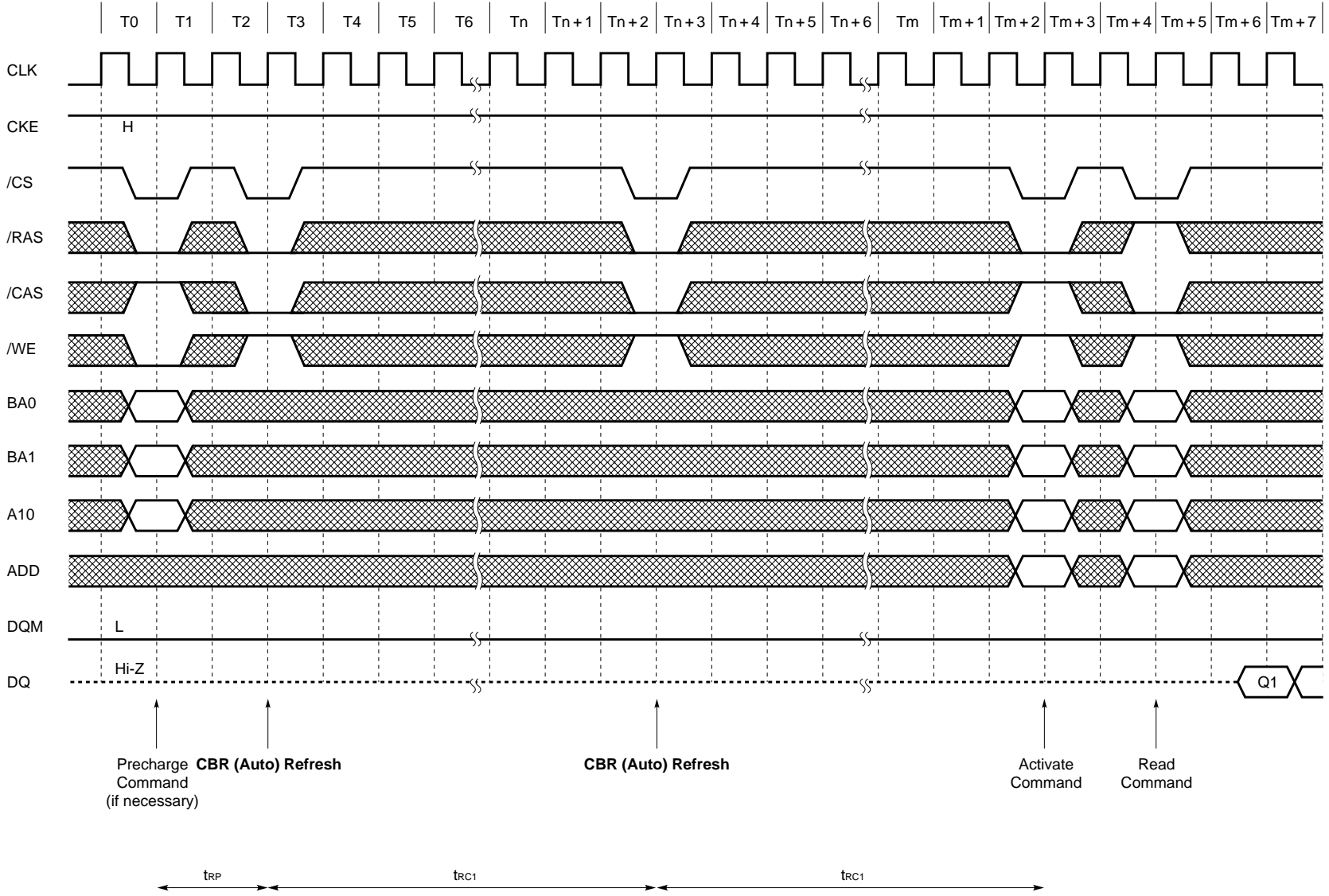|																					
T0	T1	T2	T3	T4	T5	T6	T7	T8	T9	T10	T11	T12	T13	T14	T15	T16	T17	T18	T19	T20	T21

CLK

CKE

/CS

/RAS

/CAS

/WE

BA0

BA1

A10   RAa

ADD   RAa   CAa

DQM   L

DQ   Hi-Z   DAa1   DAa2   DAa3   DAa4

Activate
Command
for Bank A

Write
Command
for Bank A

**1-CLOCK
SUSPENDED**

**2-CLOCK
SUSPENDED**

**3-CLOCK
SUSPENDED**

Clock Suspension during Burst Write (using CKE Function) (2/2) (Burst Length = 4, /CAS Latency = 3)

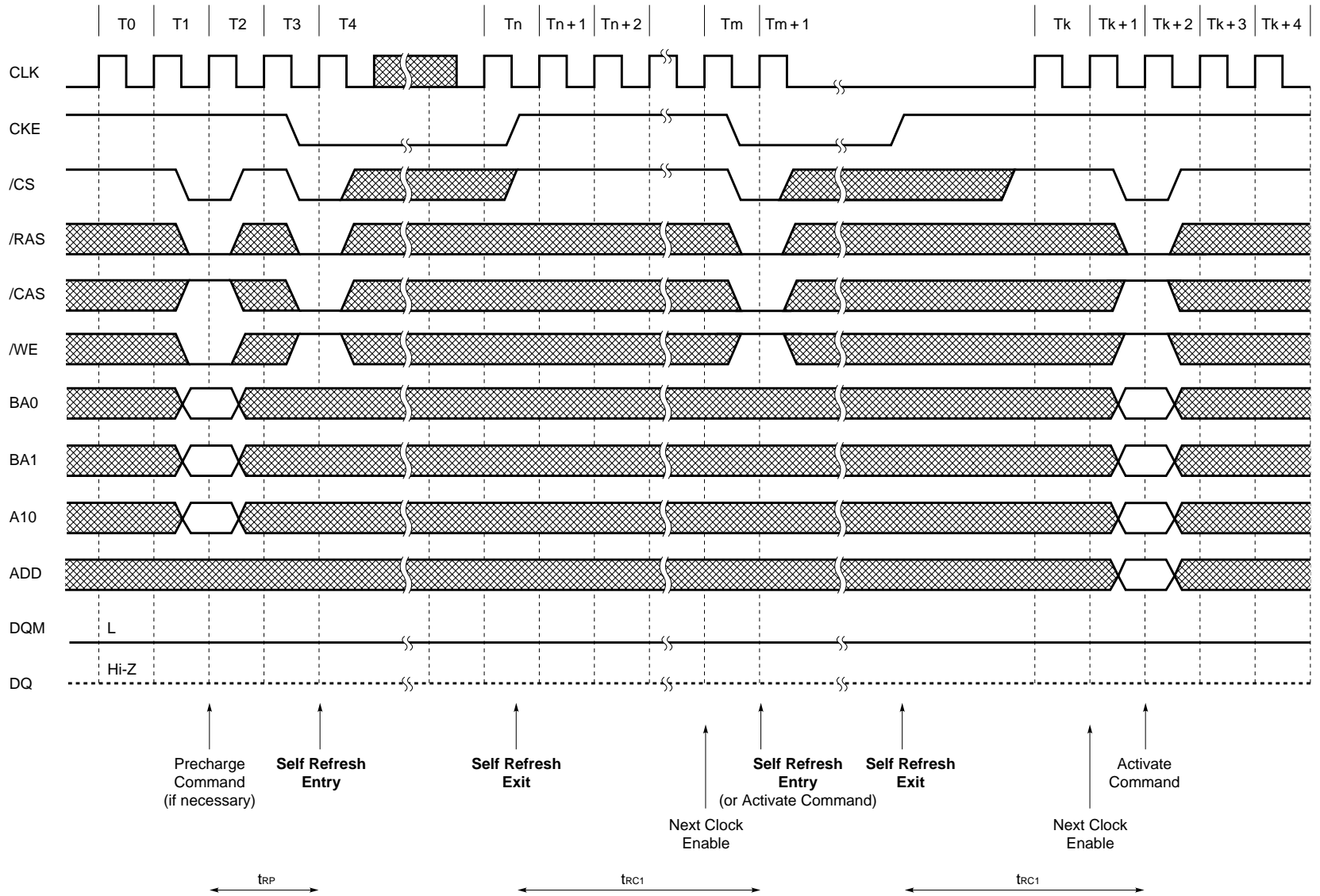## 13.9 Power Down Mode and Clock Mask (Burst Length = 4, /CAS Latency = 2)

13.10 CBR (Auto) Refresh

ELPIDA

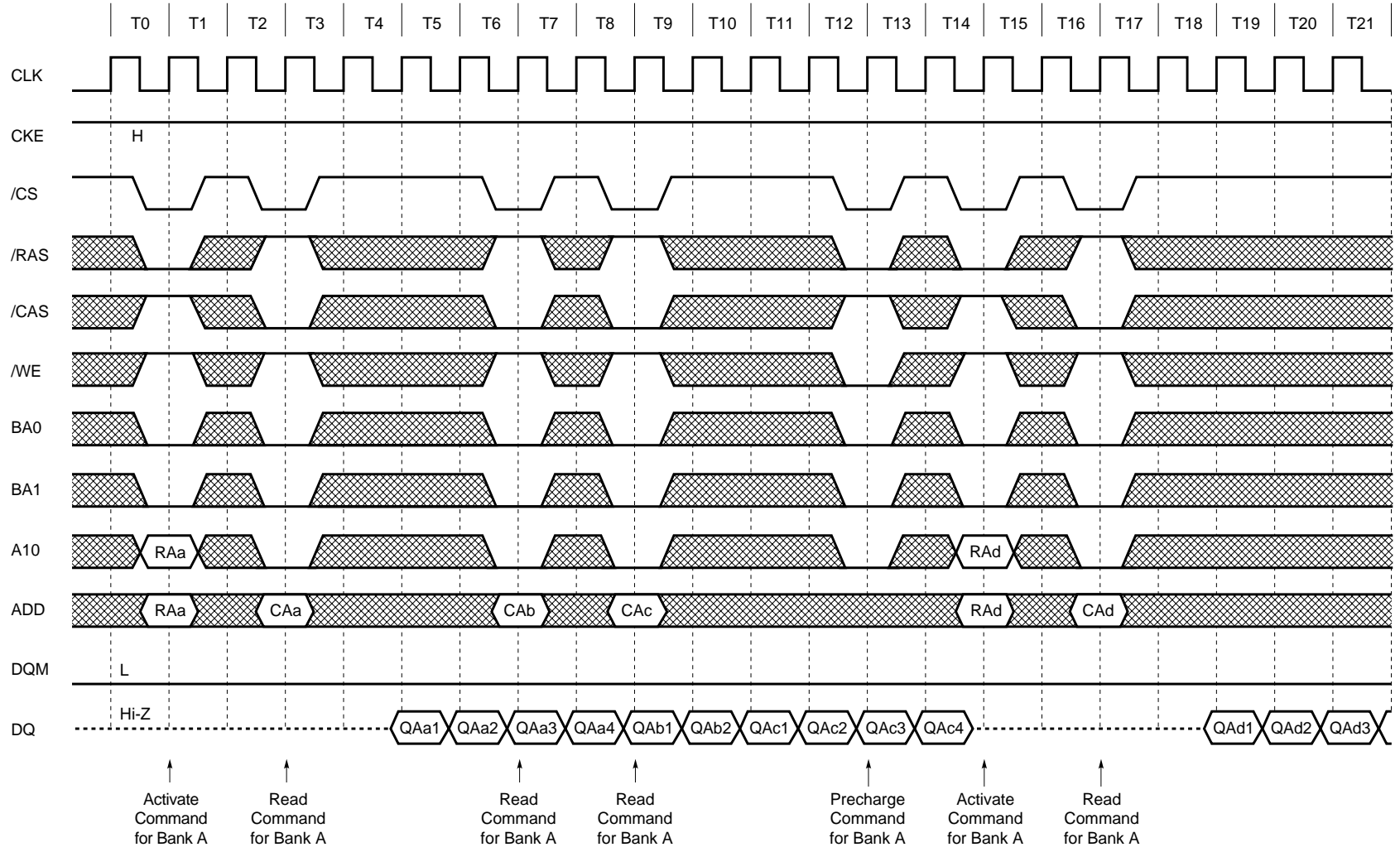μPD45128441, 45128841, 45128163

13.11   Self Refresh (Entry and Exit)

T0 | T1 | T2 | T3 | T4 | Tn | Tn+1 | Tn+2 | Tm | Tm+1 | Tk | Tk+1 | Tk+2 | Tk+3 | Tk+4

CLK

CKE

/CS

/RAS

/CAS

/WE

BA0

BA1

A10

ADD

DQM   L

DQ   Hi-Z

Precharge
Command
(if necessary)

**Self Refresh
Entry**

**Self Refresh
Exit**

**Self Refresh
Entry**
(or Activate Command)

Next Clock
Enable

**Self Refresh
Exit**

Activate
Command

Next Clock
Enable

t_{RP}

t_{RC1}

t_{RC1}

13.12 Random Column Read (Page with Same Bank) (1/2) (Burst Length = 4, /CAS Latency = 2)

| | T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 | T15 | T16 | T17 | T18 | T19 | T20 | T21 |

CLK

CKE   H

/CS

/RAS

/CAS

/WE

BA0

BA1

A10   RAa   RAd

ADD   RAa   CAa   CAb   CAc   RAd   CAd

DQM   L

DQ   Hi-Z   QAa1 QAa2 QAa3 QAa4 QAb1 QAb2 QAc1 QAc2 QAc3 QAc4   QAd1 QAd2 QAd3

Activate Command for Bank A

Read Command for Bank A

Read Command for Bank A

Read Command for Bank A

Precharge Command for Bank A

Activate Command for Bank A

Read Command for Bank A

Random Column Read (Page with Same Bank) (2/2) (Burst Length = 4, /CAS Latency = 3)

| | | | | | | | | | | | | | | | | | | | | | | |
| T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 | T15 | T16 | T17 | T18 | T19 | T20 | T21 |

CLK

CKE H

/CS

/RAS

/CAS

/WE

BA0

BA1

A10 — RAa ... RAa

ADD — RAa ... CAa ... CAb ... CAc ... RAa ... CAa

DQM L

DQ Hi-Z ... QAa1 QAa2 QAa3 QAa4 QAb1 QAb2 QAc1 QAc2 QAc3 QAc4

Activate Command for Bank A

Read Command for Bank A

Read Command for Bank A

Read Command for Bank A

Precharge Command for Bank A

Activate Command for Bank A

Read Command for Bank A

13.13 Random Column Write (Page with Same Bank) (1/2) (Burst Length = 4, /CAS Latency = 2)

Random Column Write (Page with Same Bank) (2/2) (Burst Length = 4, /CAS Latency = 3)

	T0	T1	T2	T3	T4	T5	T6	T7	T8	T9	T10	T11	T12	T13	T14	T15	T16	T17	T18	T19	T20	T21

CLK
CKE H
/CS
/RAS
/CAS
/WE
BA0
BA1
A10 RDa RDd
ADD RDa CDa CDb CDc RDd CDd
DQM L
DQ Hi-Z DDa1 DDa2 DDa3 DDa4 DDb1 DDb2 DDc1 DDc2 DDc3 DDc4 DDd1 DDd2

Activate Command for Bank D
Write Command for Bank D
Write Command for Bank D
Write Command for Bank D
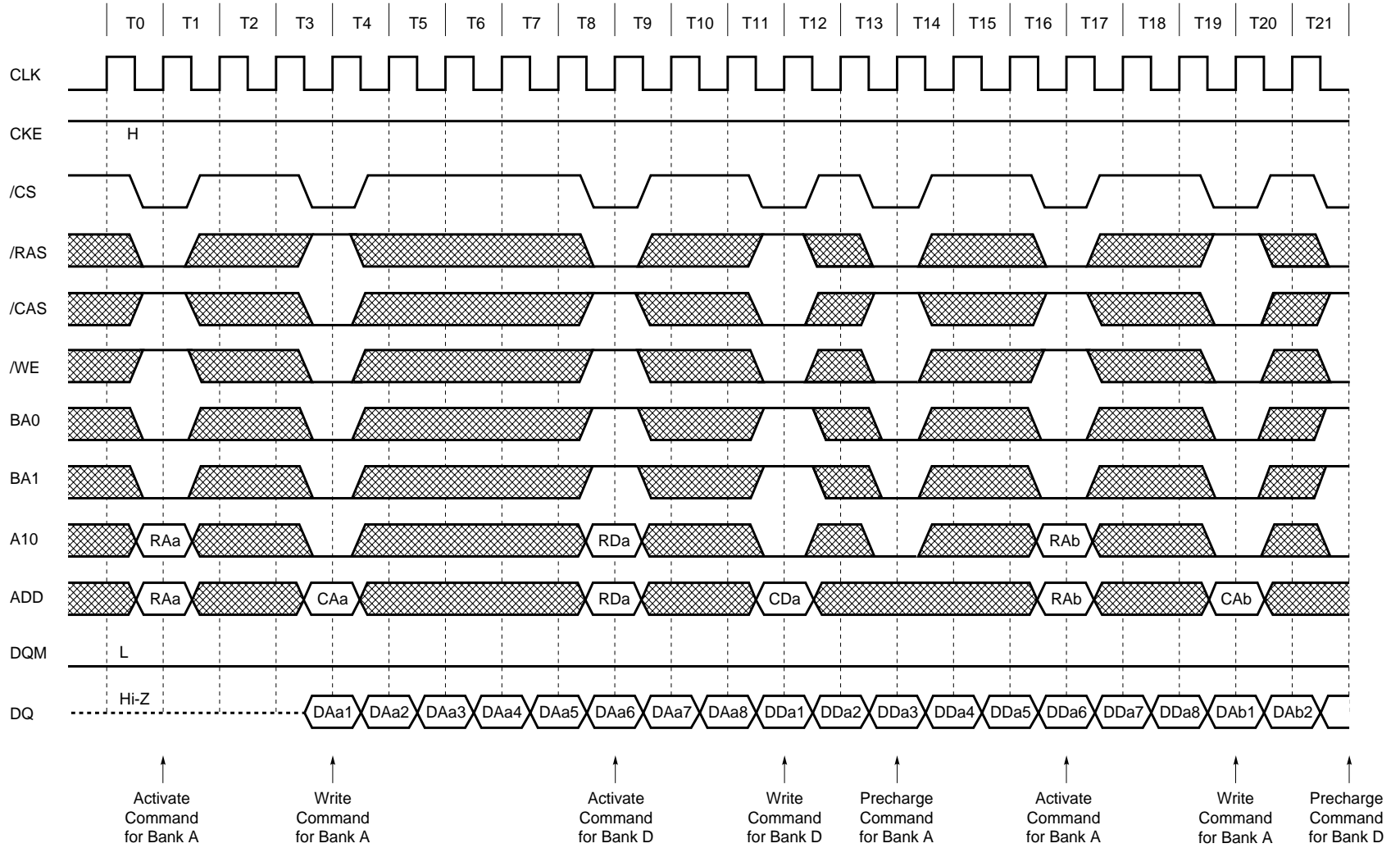Precharge Command for Bank D
Activate Command for Bank D
Write Command for Bank D

13.14 Random Row Read (Ping-Pong Banks) (1/2) (Burst Length = 8, /CAS Latency = 2)
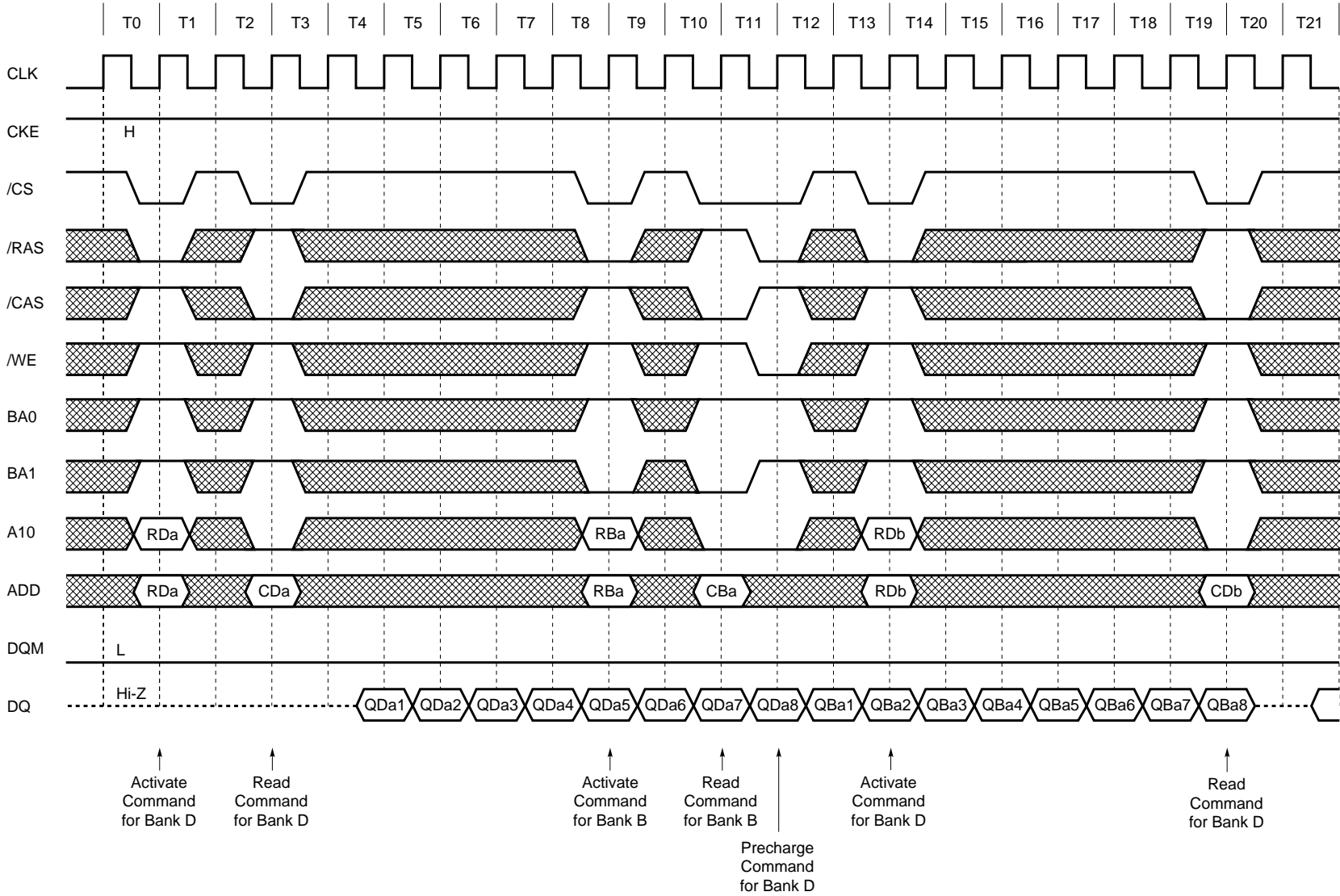
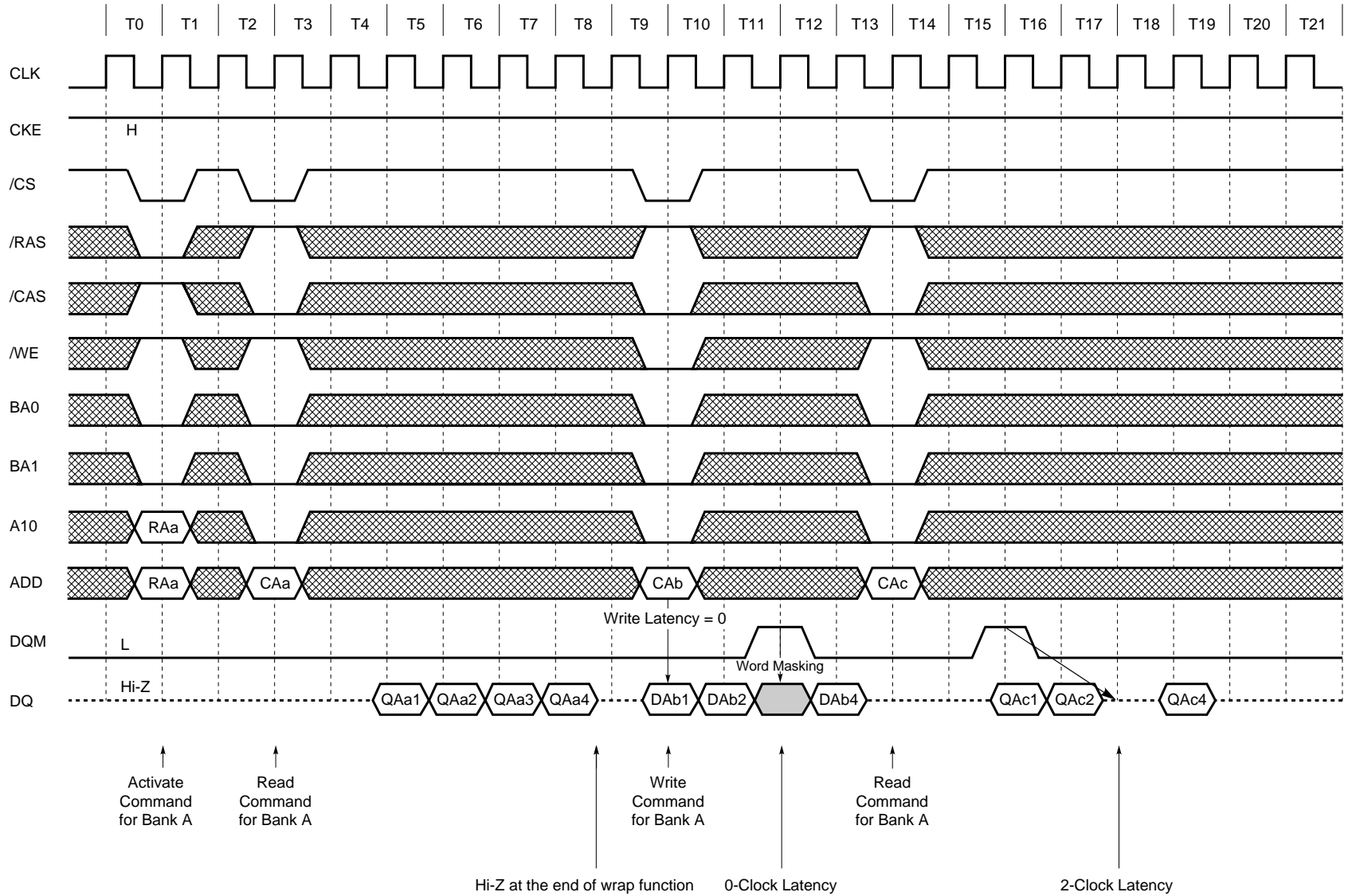**Random Row Read (Ping-Pong Banks) (2/2) (Burst Length = 8, /CAS Latency = 3)**

| | T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 | T15 | T16 | T17 | T18 | T19 | T20 | T21 |

CLK

CKE H

/CS

/RAS

/CAS

/WE

BA0

BA1

A10   RBa   RAa   RBb

ADD   RBa   CBa   RAa   CAa   RBb   CBb

DQM L

DQ Hi-Z QBa1 QBa2 QBa3 QBa4 QBa5 QBa6 QBa7 QBa8 QAa1 QAa2 QAa3 QAa4 QAa5 QAa6 QAa7

Activate Command for Bank B

Read Command for Bank B

Activate Command for Bank A

Read Command for Bank A

Precharge Command for Bank B

Activate Command for Bank B

Read Command for Bank B

Precharge Command for Bank A
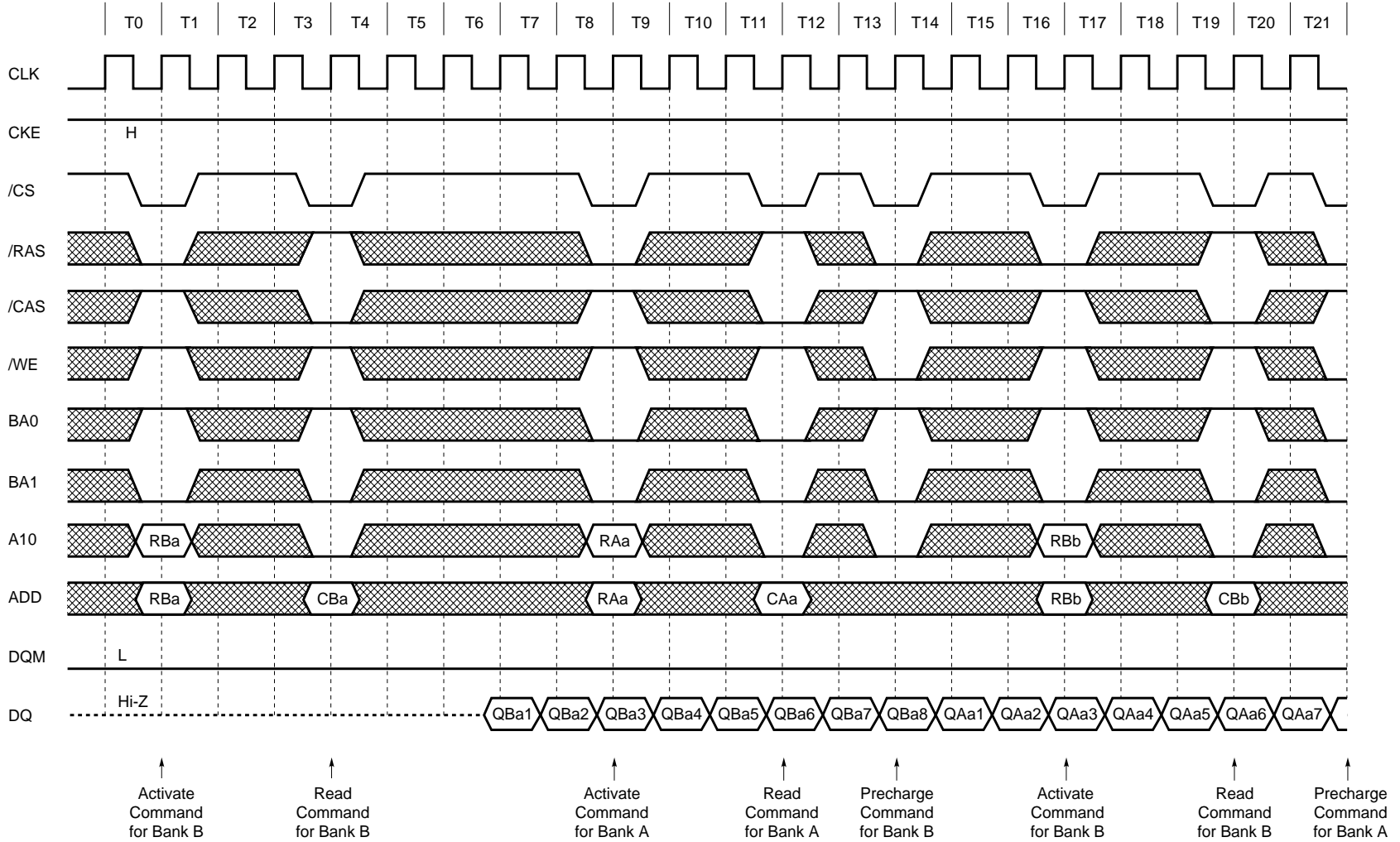
13.15 Random Row Write (Ping-Pong Banks) (1/2) (Burst Length = 8, /CAS Latency = 2)

	T0	T1	T2	T3	T4	T5	T6	T7	T8	T9	T10	T11	T12	T13	T14	T15	T16	T17	T18	T19	T20	T21

CLK

CKE H

/CS

/RAS

/CAS

/WE

BA0

BA1

A10   RAa   RDa   RAb

ADD   RAa   CAa   RDa   CDa   RAb   CAb

DQM L

DQ Hi-Z   DAa1 DAa2 DAa3 DAa4 DAa5 DAa6 DAa7 DAa8 DDa1 DDa2 DDa3 DDa4 DDa5 DDa6 DDa7 DDa8 DAb1 DAb2 DAb3

Activate Command for Bank A

Write Command for Bank A

Activate Command for Bank D

Write Command for Bank D

Precharge Command for Bank A

Activate Command for Bank A

Write Command for Bank A

Precharge Command for Bank D

Random Row Write (Ping-Pong Banks) (2/2) (Burst Length = 8, /CAS Latency = 3)

| | T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 | T15 | T16 | T17 | T18 | T19 | T20 | T21 |

CLK

CKE   H

/CS

/RAS

/CAS

/WE

BA0

BA1

A10   RAa   RDa   RAb

ADD   RAa   CAa   RDa   CDa   RAb   CAb

DQM   L

DQ   Hi-Z   DAa1 DAa2 DAa3 DAa4 DAa5 DAa6 DAa7 DAa8 DDa1 DDa2 DDa3 DDa4 DDa5 DDa6 DDa7 DDa8 DAb1 DAb2

Activate Command for Bank A

Write Command for Bank A

Activate Command for Bank D

Write Command for Bank D

Precharge Command for Bank A

Activate Command for Bank A

Write Command for Bank A

Precharge Command for Bank D

13.16　Read and Write (1/2) (Burst Length = 4, /CAS Latency = 2)

| | T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 | T15 | T16 | T17 | T18 | T19 | T20 | T21 |

CLK

CKE　H

/CS

/RAS

/CAS

/WE

BA0

BA1

A10　RAa

ADD　RAa　CAa　CAb　CAc

DQM　L　Write Latency = 0

Word Masking

DQ　Hi-Z　QAa1　QAa2　QAa3　QAa4　DAb1　DAb2　DAb4　QAc1　QAc2　QAc4

Activate Command for Bank A

Read Command for Bank A

Write Command for Bank A

Read Command for Bank A

Hi-Z at the end of wrap function

0-Clock Latency

2-Clock Latency

Read and Write (2/2) (Burst Length = 4, /CAS Latency = 3)
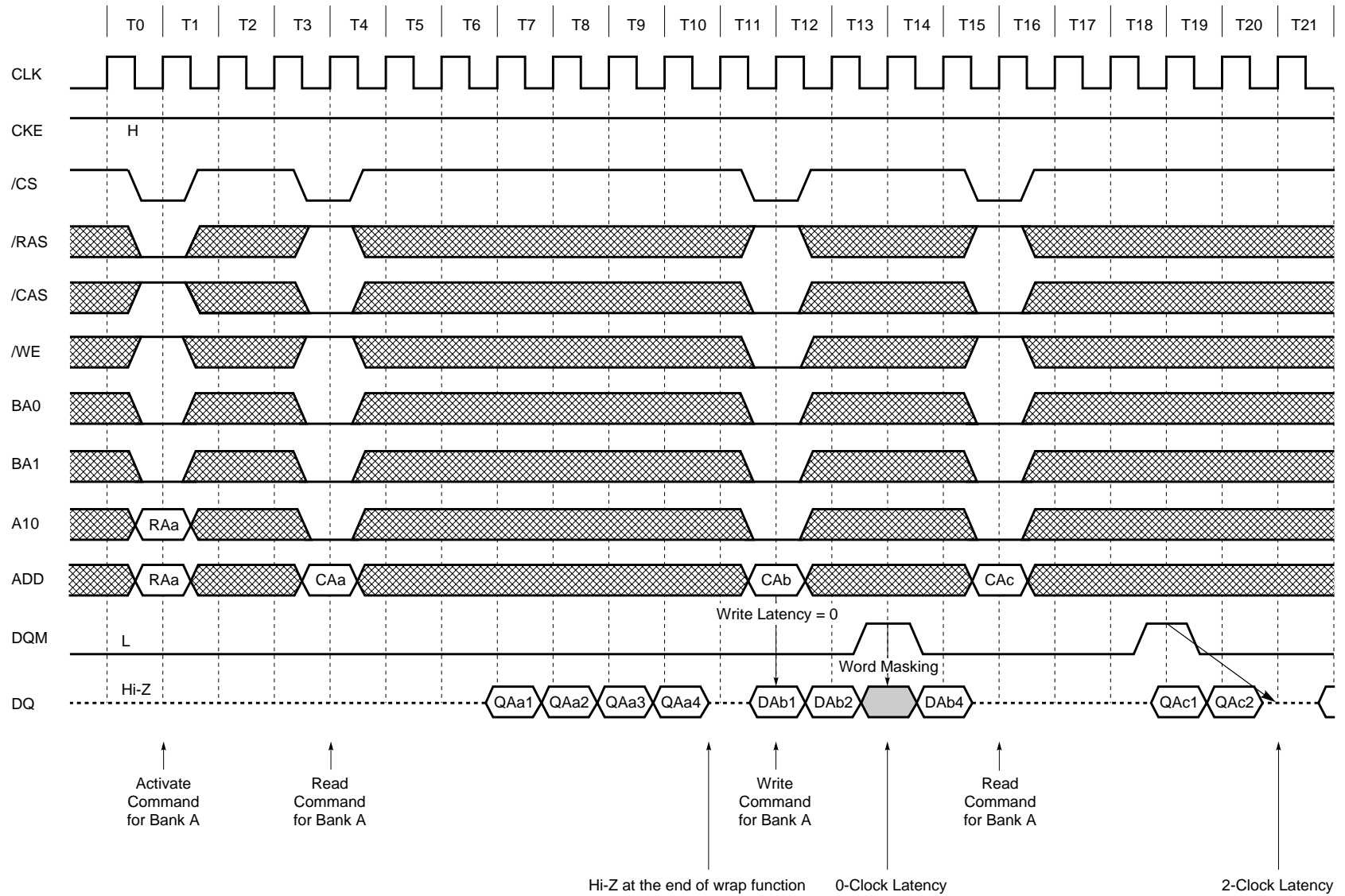
	T0	T1	T2	T3	T4	T5	T6	T7	T8	T9	T10	T11	T12	T13	T14	T15	T16	T17	T18	T19	T20	T21

CLK

CKE — H

/CS

/RAS

/CAS

/WE

BA0

BA1

A10 — RAa

ADD — RAa — CAa — CAb — CAc

DQM — L — Write Latency = 0 — Word Masking

DQ — Hi-Z — QAa1 QAa2 QAa3 QAa4 — DAb1 DAb2 [ ] DAb4 — QAc1 QAc2

Activate Command for Bank A

Read Command for Bank A

Write Command for Bank A

Read Command for Bank A

Hi-Z at the end of wrap function

0-Clock Latency

2-Clock Latency

13.17 Interleaved Column Read Cycle (1/2) (Burst Length = 4, /CAS Latency = 2)
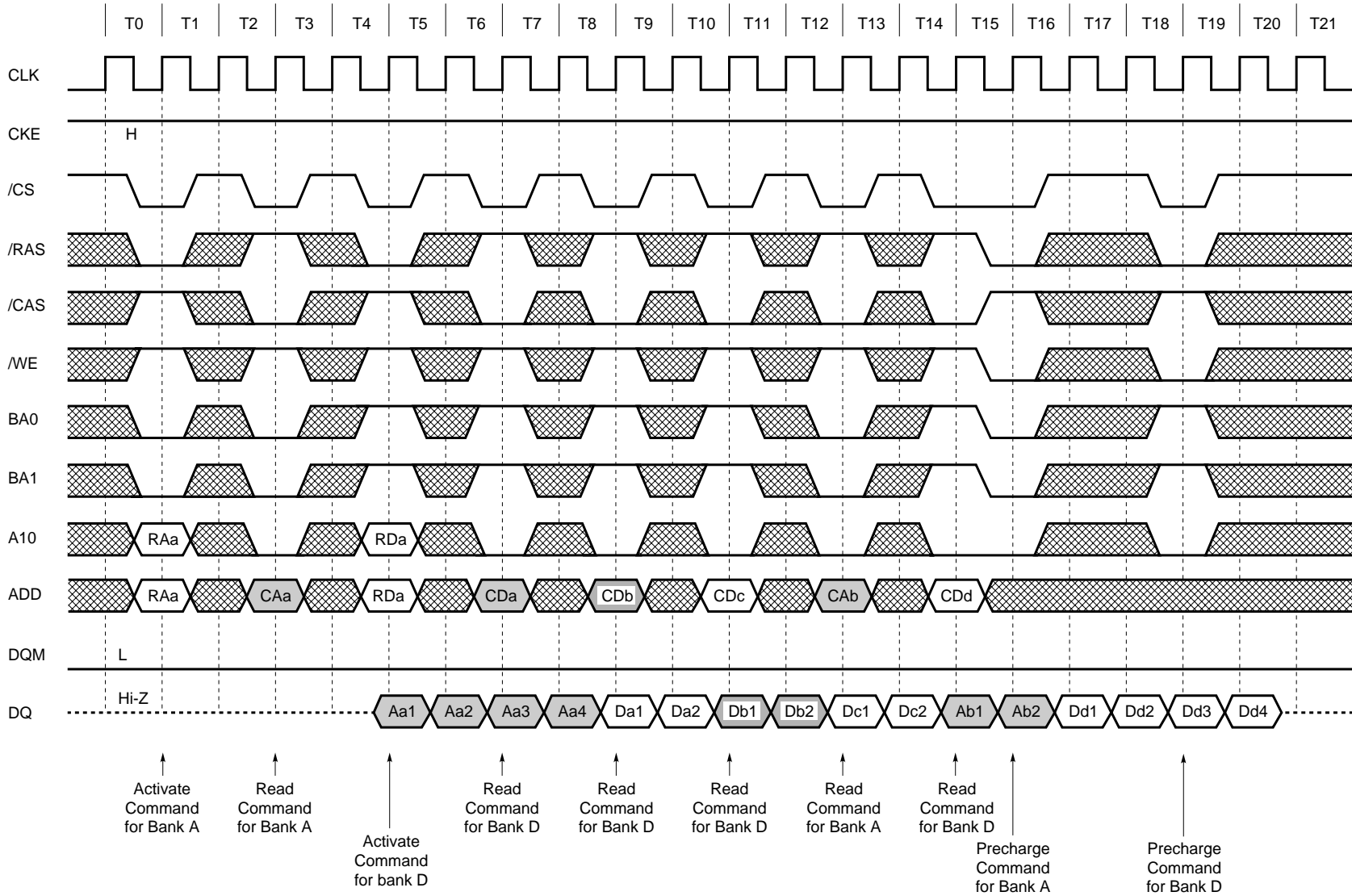
Interleaved Column Read Cycle (2/2) (Burst Length = 4, /CAS Latency = 3)

	T0	T1	T2	T3	T4	T5	T6	T7	T8	T9	T10	T11	T12	T13	T14	T15	T16	T17	T18	T19	T20	T21

CLK

CKE   H

/CS

/RAS

/CAS

/WE

BA0

BA1

A10   RAa   RDa

ADD   RAa   CAa   RDa   CDa   CDb   CDc   CAb

DQM   L

DQ   Hi-Z   Aa1   Aa2   Aa3   Aa4   Da1   Da2   Db1   Db2   Dc1   Dc2   Ab1   Ab2   Ab3   Ab4

Activate Command for Bank A

Read Command for Bank A

Activate Command for Bank D

Read Command for Bank D

Read Command for Bank D

Read Command for Bank D

Read Command for Bank A

Precharge Command for Bank D

Precharge Command for Bank A

13.18 Interleaved Column Write Cycle (1/2) (Burst Length = 4, /CAS Latency = 2)

| | T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 | T15 | T16 | T17 | T18 | T19 | T20 | T21 |

CLK

CKE   H

/CS

/RAS

/CAS

/WE

BA0

BA1

A10   RAa   RBa

ADD   RAa   CAa   RBa   CBa   CBb   CBc   CAb   CBd

DQM   L

DQ   Hi-Z   Aa1   Aa2   Aa3   Aa4   Ba1   Ba2   Bb1   Bb2   Bc1   Bc2   Ab1   Ab2   Bd1   Bd2   Bd3   Bd4

Activate Command for Bank A

Write Command for Bank A

Activate Command for Bank B

Write Command for Bank B

Write Command for Bank B

Write Command for Bank B

Write Command for Bank A

Write Command for Bank B

Precharge Command for Bank A

Precharge Command for Bank B

Interleaved Column Write Cycle (2/2) (Burst Length = 4, /CAS Latency = 3)
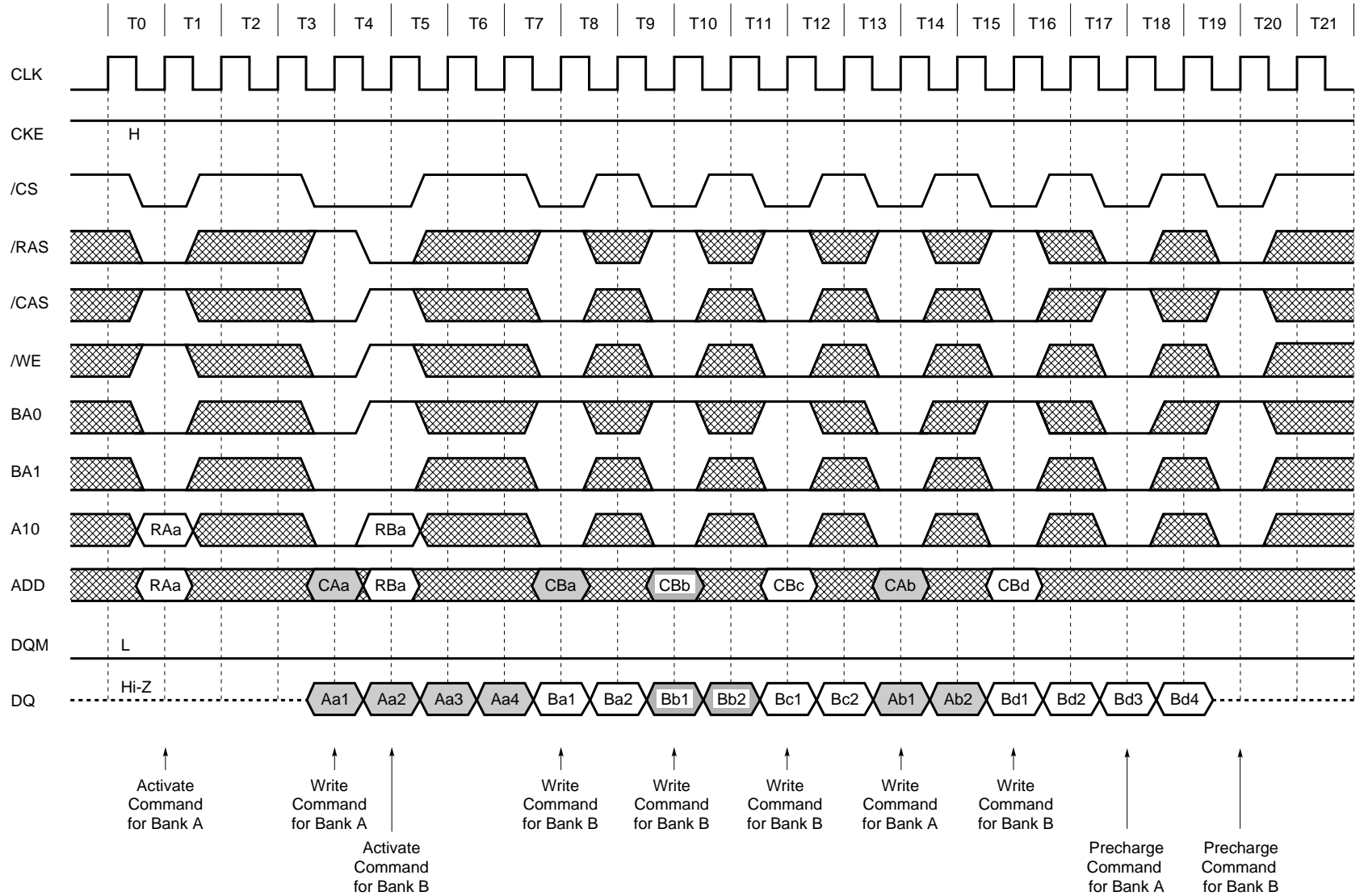
13.19 Auto Precharge after Read Burst (1/2) (Burst Length = 4, /CAS Latency = 2)
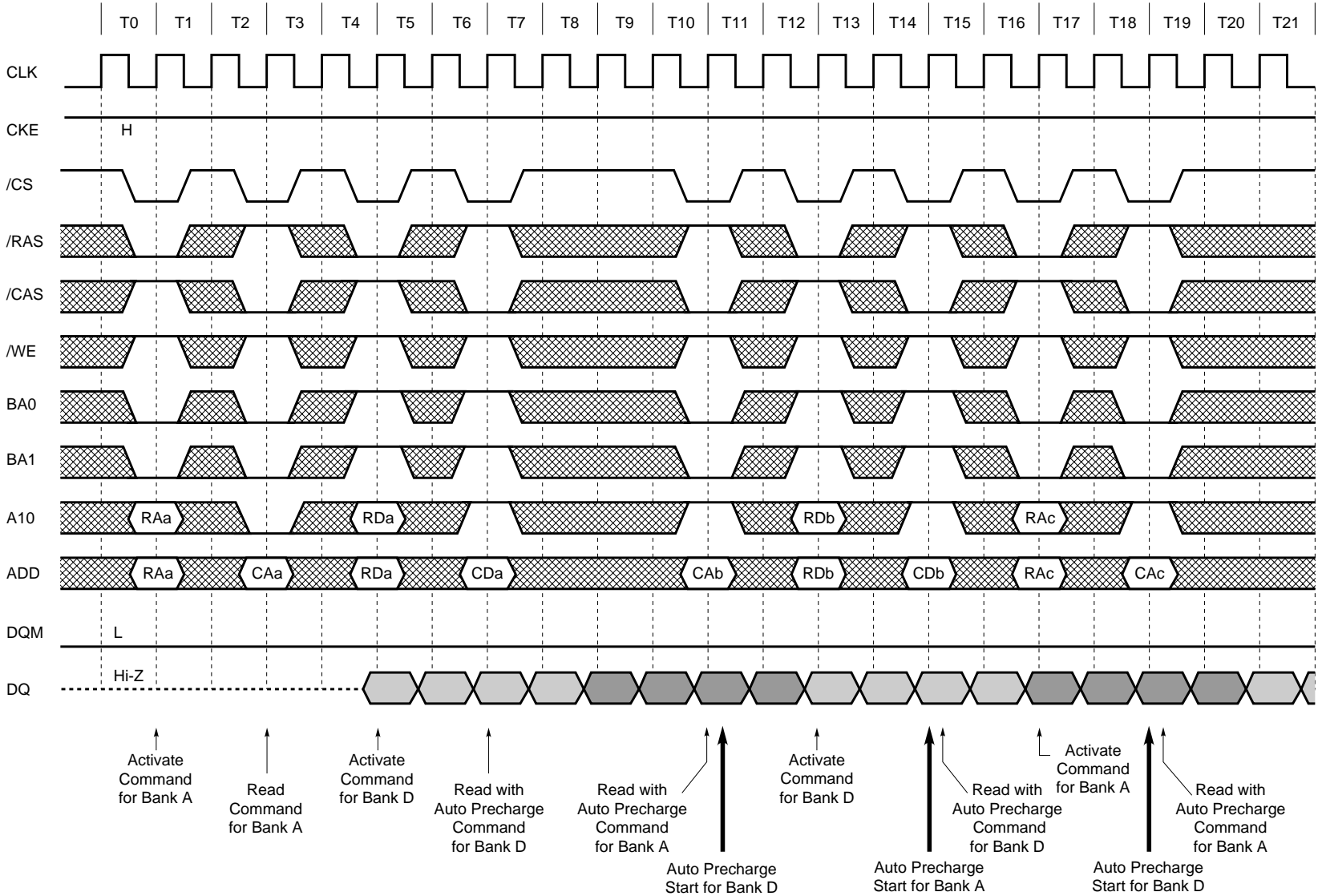
Auto Precharge after Read Burst (2/2) (Burst Length = 4, /CAS Latency = 3)

Signal	Timing

Timing diagram signals: CLK, CKE (H), /CS, /RAS, /CAS, /WE, BA0, BA1, A10 (RAa, RDa, RDb), ADD (RAa, CAa, RDa, CDa, CAb, RDb, CDb), DQM (L), DQ (Hi-Z)

Clock cycles: T0 T1 T2 T3 T4 T5 T6 T7 T8 T9 T10 T11 T12 T13 T14 T15 T16 T17 T18 T19 T20 T21

Annotations:
- Activate Command for Bank A
- Read Command for Bank A
- Activate Command for Bank D
- Read with Auto Precharge Command for Bank D
- Read with Auto Precharge Command for Bank A
- Auto Precharge Start for Bank D
- Activate Command for Bank D
- Auto Precharge Start for Bank A
- Read with Auto Precharge Command for Bank D

13.20   Auto Precharge after Write Burst (1/2) (Burst Length = 4, /CAS Latency = 2)
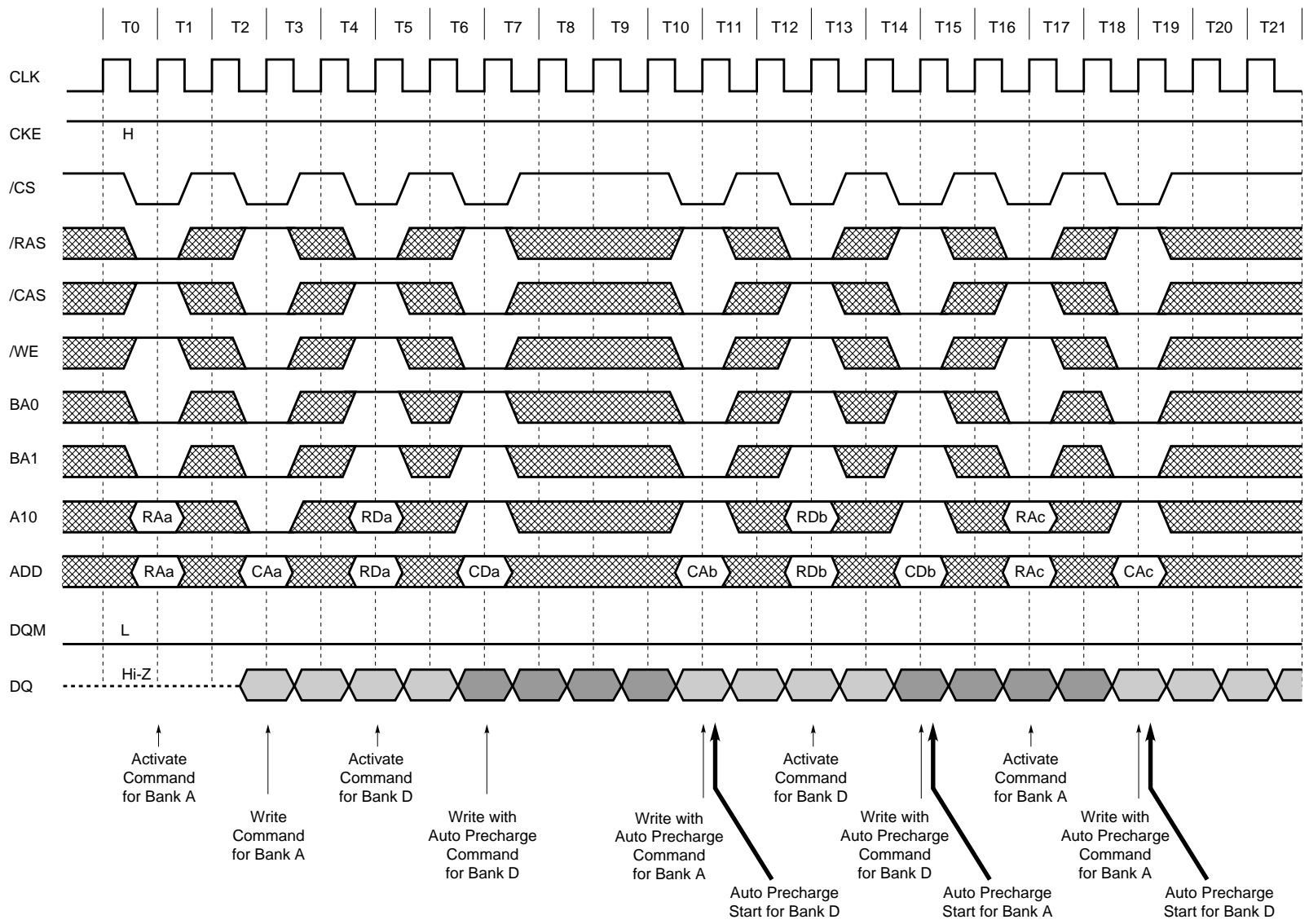
Auto Precharge after Write Burst (2/2) (Burst Length = 4, /CAS Latency = 3)
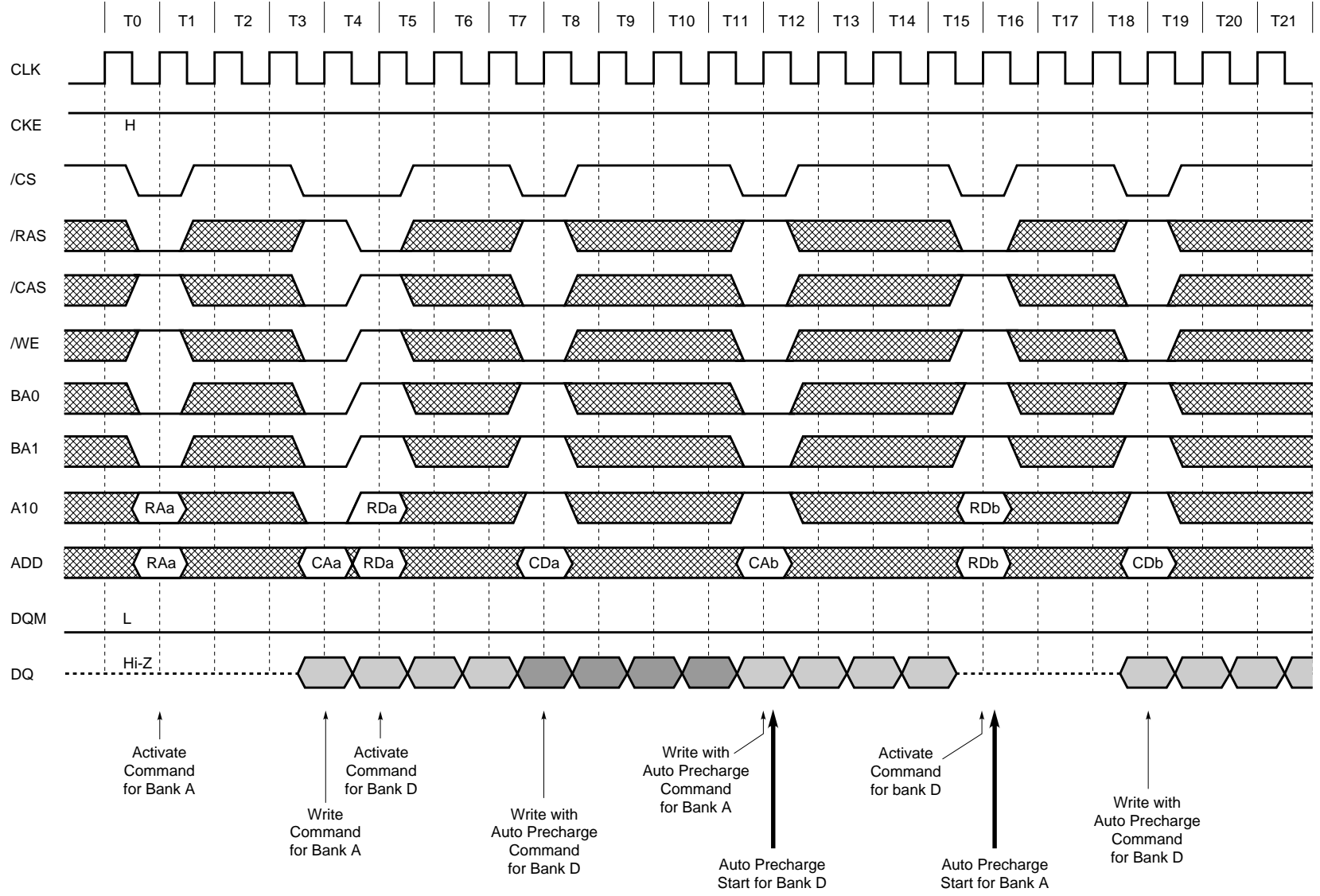
13.21 Full Page Read Cycle (1/2) (/CAS Latency = 2)
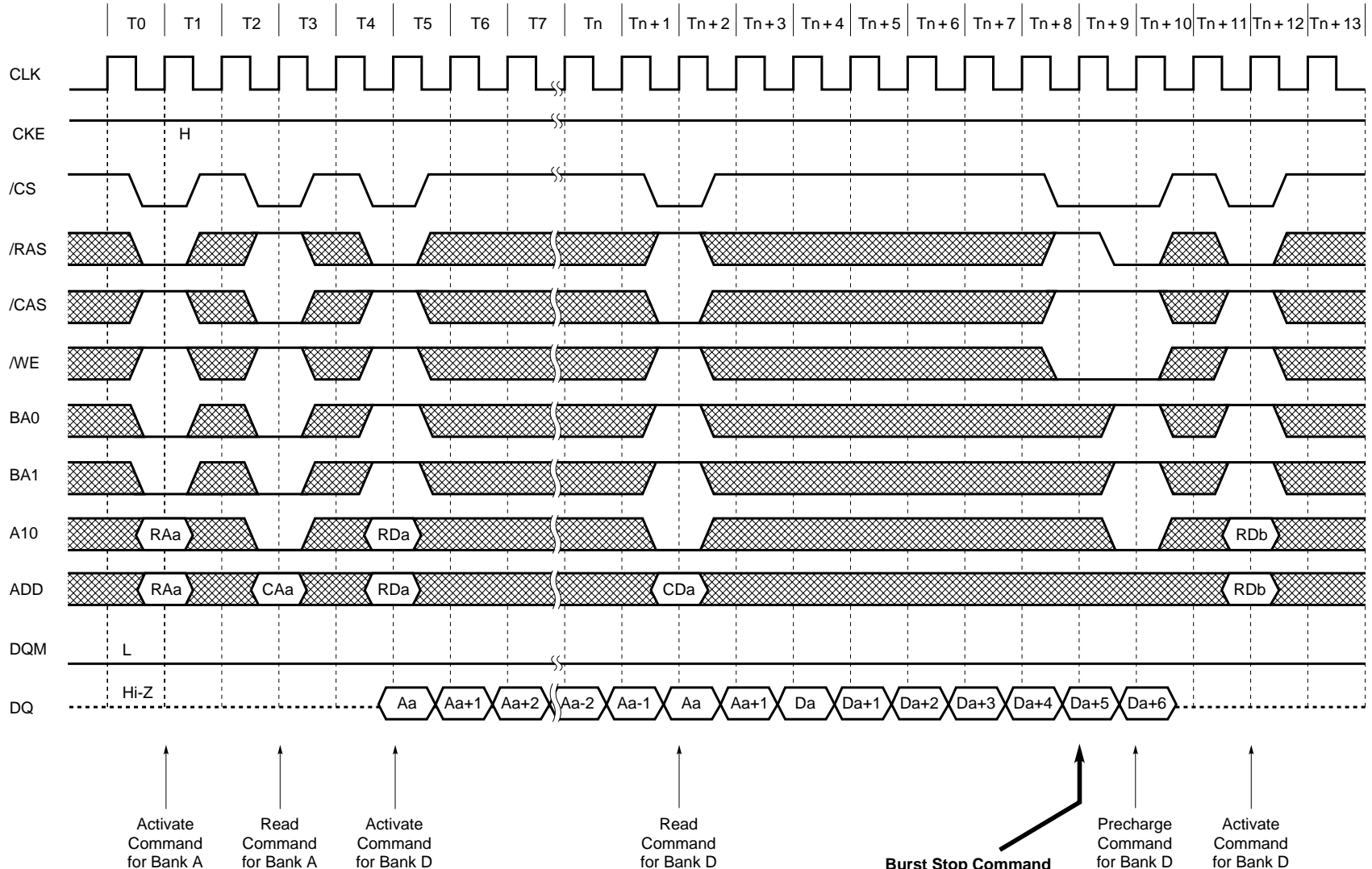
Full Page Read Cycle (2/2) (/CAS latency = 3)

| | T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | Tn | Tn+1 | Tn+2 | Tn+3 | Tn+4 | Tn+5 | Tn+6 | Tn+7 | Tn+8 | Tn+9 | Tn+10 | Tn+11 | Tn+12 |

CLK

CKE   H

/CS

/RAS

/CAS

/WE

BA0

BA1

A10   RAa   RDa   RDb

ADD   RAa   CAa   RDa   CDa   RDb

DQM   L

DQ   Hi-Z   Aa Aa+1 Aa-3 Aa-2 Aa-1 Aa Aa+1 Da Da+1 Da+2 Da+3 Da+4 Da+5

Activate   Read   Activate   Read   Precharge   Activate
Command   Command   Command   Command   Command   Command
for Bank A   for Bank A   for Bank D   for Bank D   for Bank D   for Bank D

Burst Stop Command
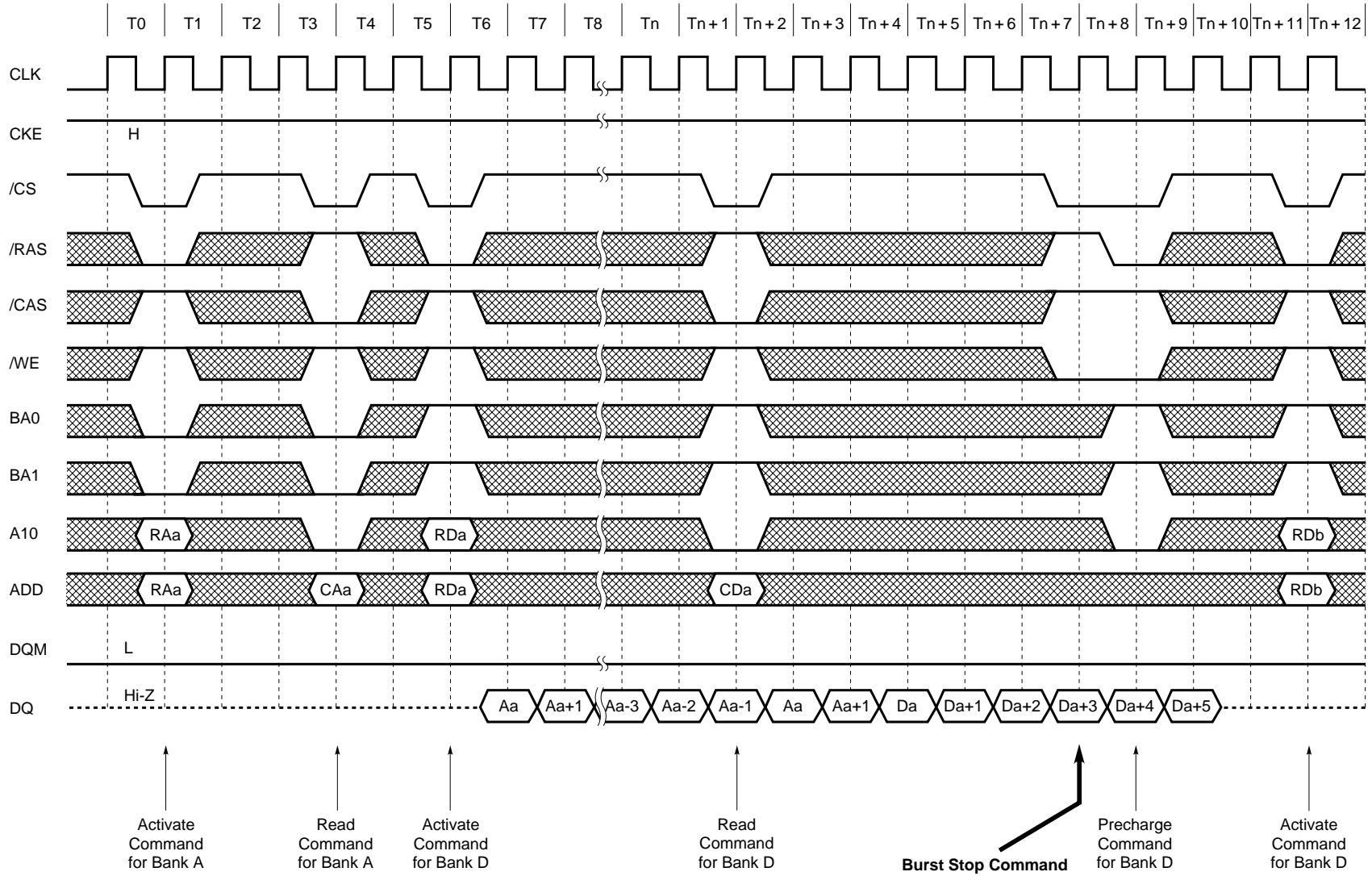
13.22 Full Page Write Cycle (1/2) (/CAS latency = 2)
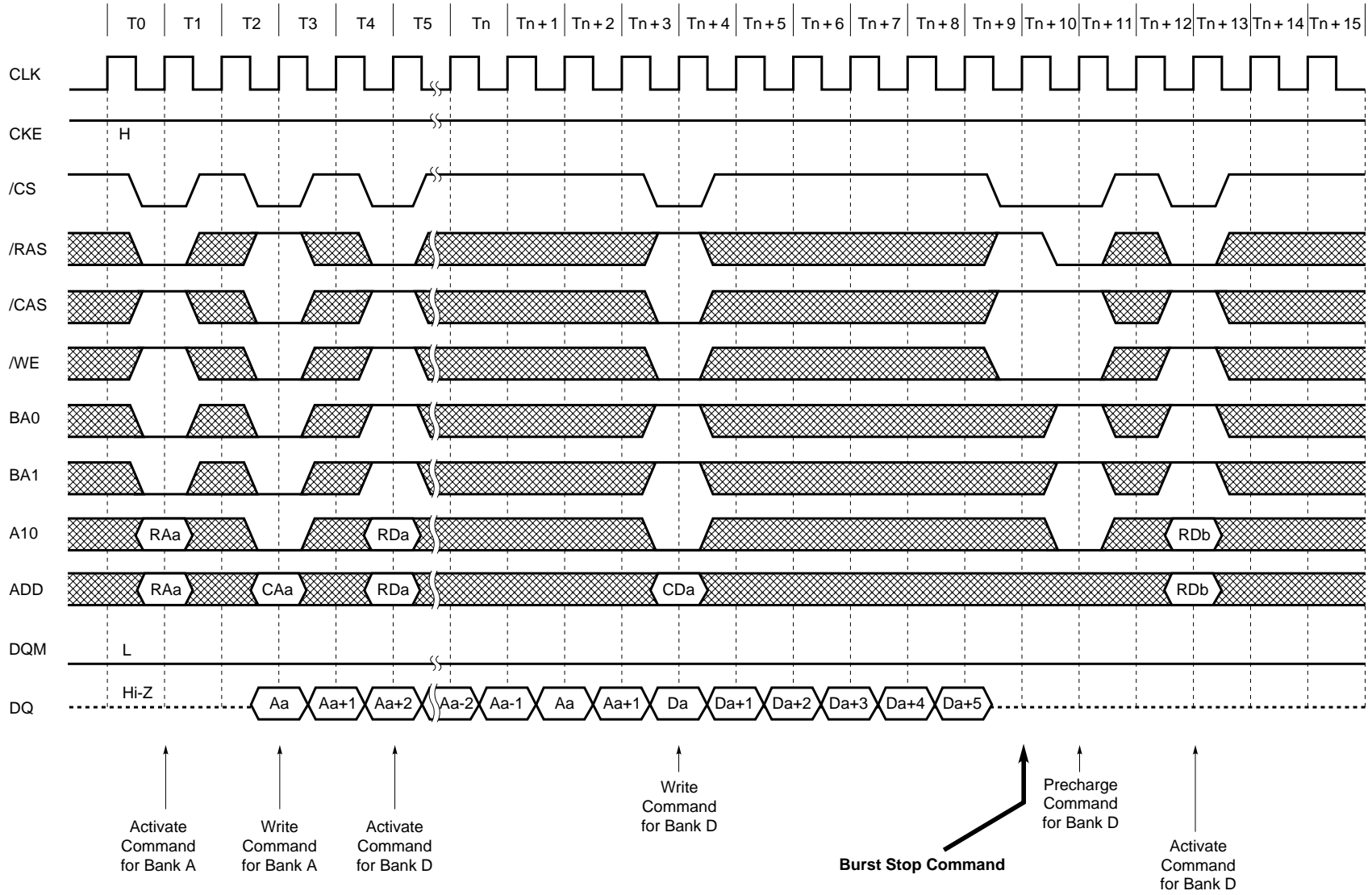
Full Page Write Cycle (2/2) (/CAS Latency = 3)

	T0	T1	T2	T3	T4	T5	T6	T7	Tn	Tn+1	Tn+2	Tn+3	Tn+4	Tn+5	Tn+6	Tn+7	Tn+8	Tn+9	Tn+10	Tn+11	Tn+12 Tn+13

Signals: CLK, CKE (H), /CS, /RAS, /CAS, /WE, BA0, BA1, A10 (RAa, RDa, RDb), ADD (RAa, CAa, RDa, CDa, RDb), DQM (L), DQ (Hi-Z, Aa, Aa+1, Aa+2, Aa+3, Aa-1, Aa, Aa+1, Da, Da+1, Da+2, Da+3, Da+4, Da+5)

Activate Command for Bank A

Write Command for Bank A

Activate Command for Bank D

Burst is not completed in the Full Page Mode

Write Command for Bank D

Burst Stop Command

Precharge Command for Bank D

Activate Command for Bank D

13.23 Byte Write Operation (Burst Length = 4, /CAS Latency = 2)

Timing diagram signals (top to bottom): CLK, CKE, /CS, /RAS, /CAS, /WE, BA0, BA1, A10, ADD, LDQM, UDQM, DQ (lower), DQ (upper)

Clock cycles labeled T0 through T21.

Annotations:
Activate Command for Bank D
Read Command for Bank D
Upper Byte not Read
Lower Byte not Write
Upper Byte not Write
Lower Byte not Write

Byte Write Operation (Burst Length = 4, /CAS Latency = 3)

| | T0 | T1 | T2 | T3 | T4 | T5 | T6 | T7 | T8 | T9 | T10 | T11 | T12 | T13 | T14 | T15 | T16 | T17 | T18 | T19 | T20 | T21 |

CLK

CKE

/CS

/RAS

/CAS

/WE

BA0

BA1

A10

ADD

LDQM

UDQM

DQ (lower)

DQ (upper)

Activate Command for Bank D

Read Command for Bank D

Upper Byte not Read

Lower Byte not Read

Lower Byte not Write

Upper Byte not Write

Lower Byte not Write

Read Command for Bank D

Lower Byte not Read

Lower Byte not Read

13.24 Burst Read and Single Write (Option) (Burst Length = 4, /CAS Latency = 2)

Burst Read and Single Write (Option) (Burst Length = 4, /CAS Latency = 3)

	T0	T1	T2	T3	T4	T5	T6	T7	T8	T9	T10	T11	T12	T13	T14	T15	T16	T17	T18	T19	T20	T21

CLK

CKE   H

/CS

/RAS

/CAS

/WE

BA0

BA1

A10

ADD

DQM

DQ   Hi-Z   Qa1 Qa2 Qa3 Qa4   D1   Qb1 Qb2   Qb4

Activate
Command
for Bank D

Read
Command
for Bank D

Single
Write
Command
for Bank D

Single
Write
Command
for Bank D

Read
Command
for Bank D

13.25 Full Page Random Column Read (Burst Length = Full Page, /CAS Latency = 2)

Activate Command for Bank A
Activate Command for Bank D
Read Command for Bank A
Read Command for Bank D
Read Command for Bank A
Read Command for Bank D
Read Command for Bank A
Read Command for Bank D
Precharge Command for Bank D (PRE Termination of Burst)

Full Page Random Column Read (Burst Length = Full Page, /CAS Latency = 3)

Timing diagram signals: CLK, CKE, /CS, /RAS, /CAS, /WE, BA0, BA1, A10, ADD, DQM, DQ across clock cycles T0 through T21.

Annotations:
- Activate Command for Bank A
- Activate Command for Bank D
- Read Command for Bank A
- Read Command for Bank D
- Read Command for Bank A
- Read Command for Bank D
- Read Command for Bank A
- Read Command for Bank D
- Precharge Command for Bank D (PRE Termination of Burst)

13.26 Full Page Random Column Write (Burst Length = Full Page, /CAS Latency = 2)

Full Page Random Column Write (Burst Length = Full Page, /CAS Latency = 3)
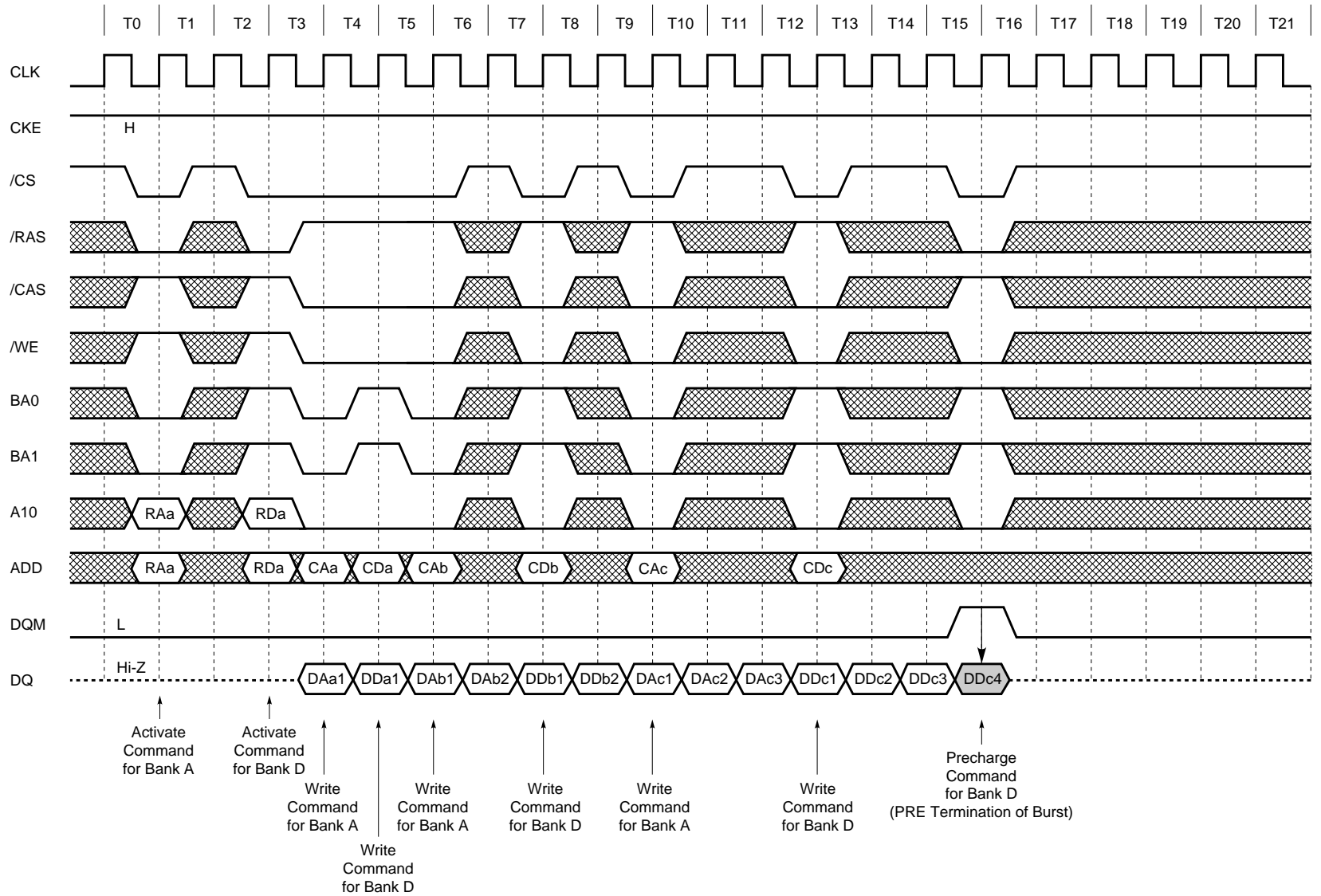
13.27 PRE (Precharge) Termination of Burst (1/2) (Burst Length = 8, /CAS Latency = 2)
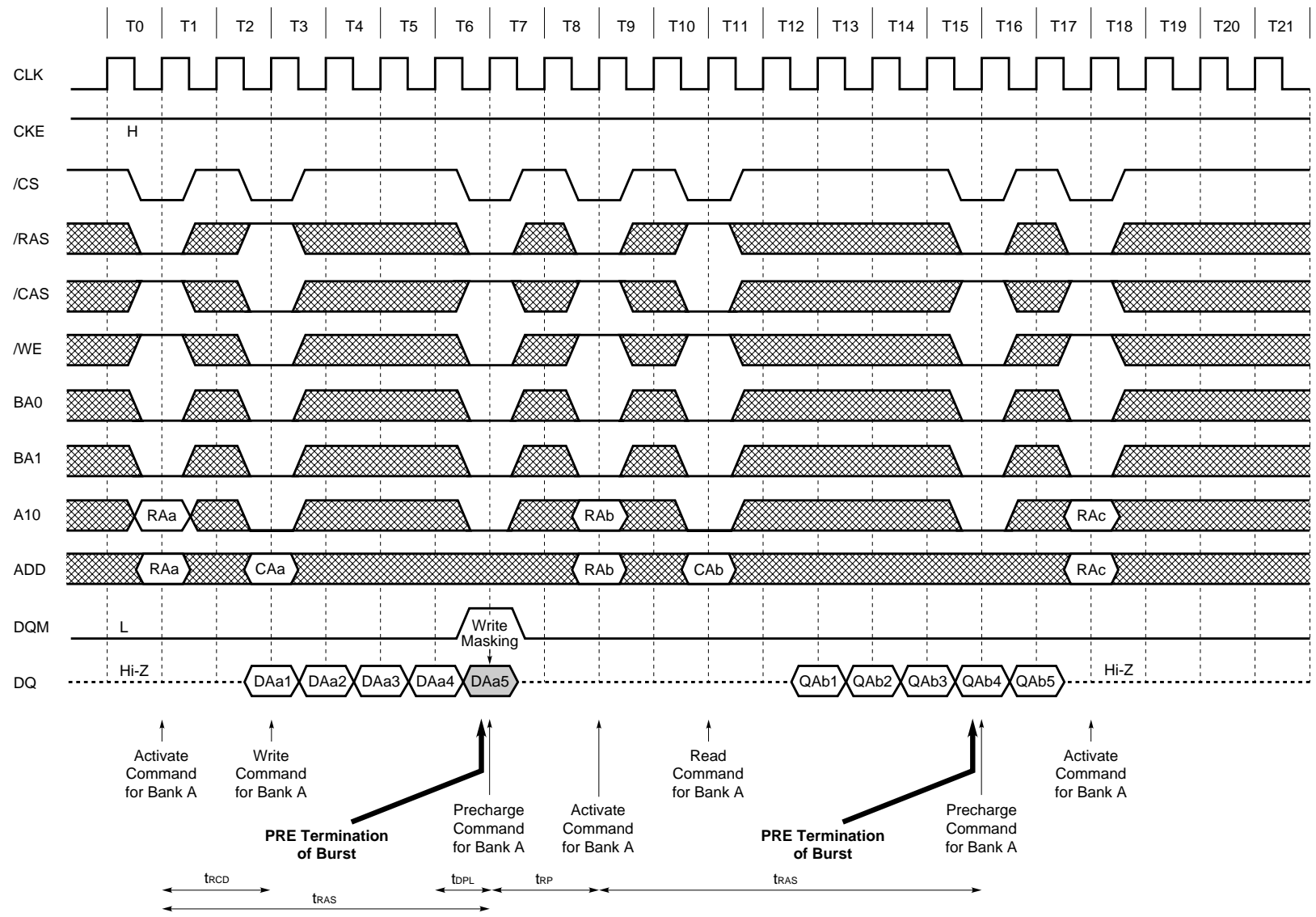
PRE (Precharge) Termination of Burst (2/2) (Burst Length = 8, /CAS Latency = 3)
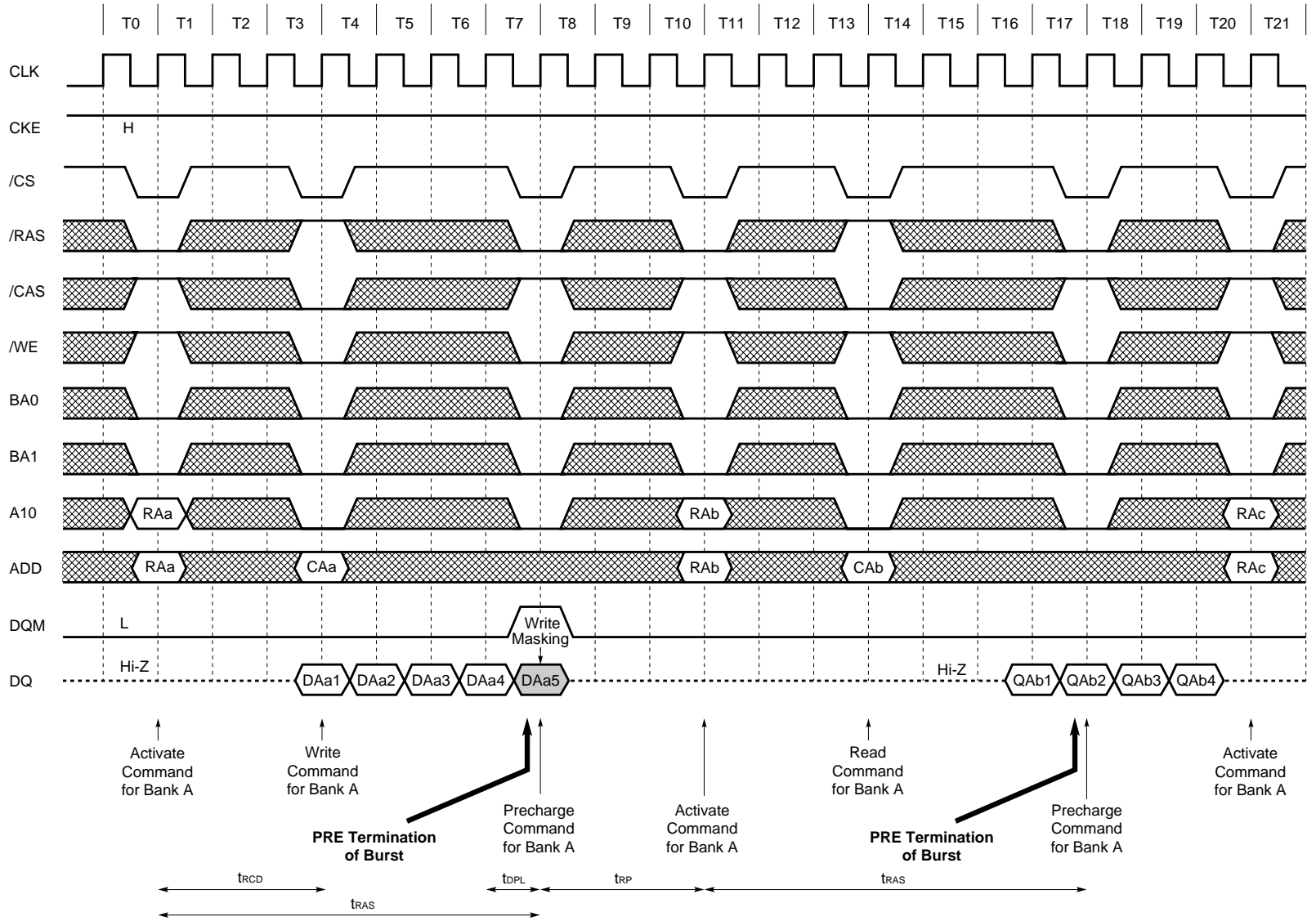
14. Package Drawing

54-PIN PLASTIC TSOP (II) (10.16 mm (400))

detail of lead end
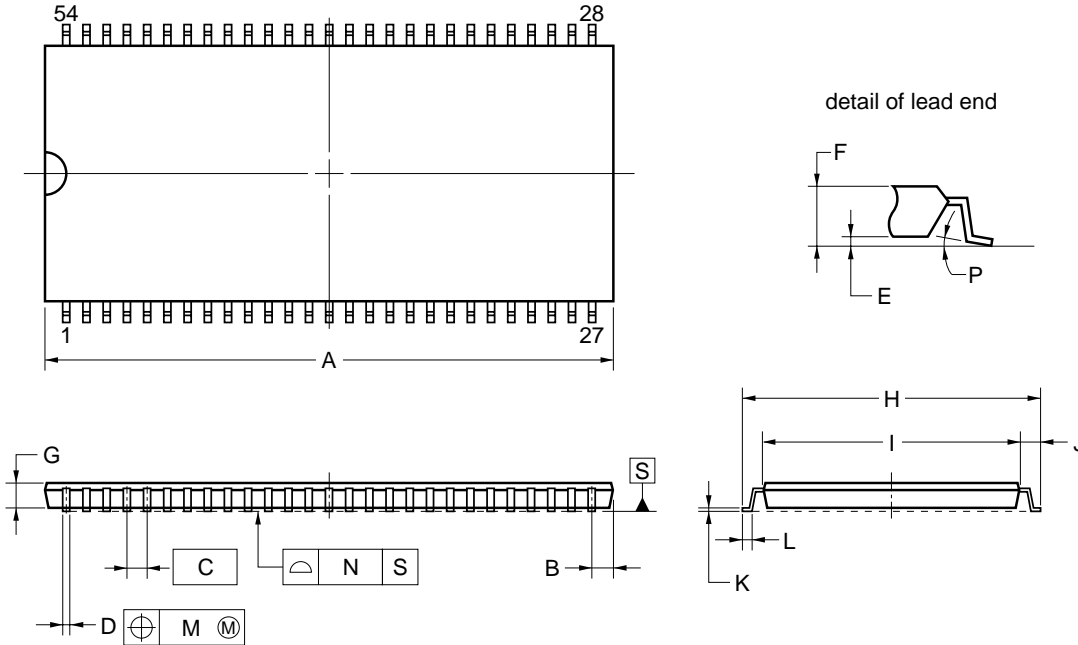
NOTES

1. Each lead centerline is located within 0.13 mm of its true position (T.P.) at maximum material condition.

2. Dimension "A" does not include mold fiash, protrusions or gate burrs. Mold flash, protrusions or gate burrs shall not exceed 0.15 mm per side.

ITEM	MILLIMETERS
A	22.22±0.05
B	0.91 MAX.
C	0.80 (T.P.)
D	$0.32^{+0.08}_{-0.07}$
E	0.10±0.05
F	1.1±0.1
G	1.00
H	11.76±0.20
I	10.16±0.10
J	0.80±0.20
K	$0.145^{+0.025}_{-0.015}$
L	0.50±0.10
M	0.13
N	0.10
P	$3°^{+7°}_{-3°}$

S54G5-80-9JF-2

15. Recommended Soldering Conditions

Please consult with our sales offices for soldering conditions of the μPD45128xxx.

Type of Surface Mount Device

μPD45128xxxG5 : 54-pin Plastic TSOP (II) (10.16mm (400))

16. Revision History

Edition /	Page		Description	
Date	This edition	Previous edition	Type of revision	Location
NEC Corporation (M12650E)				
9th edition / Mar. 1999	p.15	p.15	Modification, Addition	CKE Truth Table - Power down
	p.19	p.19	Modification, Addition	Command Truth Table for CKE - Power down
	p.35	p.35	Modification	I_{CC1} (spec), $I_{CC2}NS$ (spec), $I_{CC3}N$ (spec), I_{CC4} (spec), I_{CC5} (spec)
	p.37	p.37	Modification	Output load
	p.50	p.50	Modification	Timing Chart (Power Down Mode and Clock Mask)
	p.77	p.77	Modification	Timing Chart (Full Page Random Column Read)
10th edition / Jan. 2000	Throughout	Throughout	Modification	A13 → BA0, A12 → BA1
	p.2, 3	p.2, 3	Addition	-A75
			Deletion	-AxxL (Low power)
	p.34	p.34	Addition	Pin Capacitance (MAX.)
	p.35	p.35	Addition	-A75 specs
			Modification	I_{CC5}
			Deletion	I_{CC6} -AxxL (Low power)
	p.36	p.36	Modification	AC Characteristics Test Conditions
	p.37, 38, 42	p.37, 38, 42	Addition	-A75 specs
	p.76, 78, 80, 82	–	Addition	Timing chart (/CAS latency = 3)
	p.85	p.81	Modification	Package Drawing
11th edition / Apr. 2000	p.38	p.38	Modification	t_{RC1} spec (-A10)
Elpida Memory, Inc. (E0031N)				
1st edition / Jan. 2001	–	–	–	Republished by Elpida Memory, Inc.
Ver. 2.0 / June 2001	p.2, 3	p.2, 3	Addition	-AxxL (Low power)
	p.2, 3, 35, 37, 38, 42	p.2, 3, 35, 37, 38, 42	Deletion	-10B specs
	p.35	p.35	Addition	I_{CC6} -AxxL (Low power)
Ver. 3.0 / August 2001	p.2, 3	p.2, 3	Addition	-A75A and -A75AL (Low power)
	p.35, 37, 38	p.35, 37, 38	Addition	-A75A specs

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┌─────────────────────── **NOTES FOR CMOS DEVICES** ───────────────────────┐

① **PRECAUTION AGAINST ESD FOR MOS DEVICES**

Exposing the MOS devices to a strong electric field can cause destruction of the gate oxide and ultimately degrade the MOS devices operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it, when once it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. MOS devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. MOS devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor MOS devices on it.

② **HANDLING OF UNUSED INPUT PINS FOR CMOS DEVICES**

No connection for CMOS devices input pins can be a cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to V_{DD} or GND with a resistor, if it is considered to have a possibility of being an output pin. The unused pins must be handled in accordance with the related specifications.

③ **STATUS BEFORE INITIALIZATION OF MOS DEVICES**

Power-on does not necessarily define initial status of MOS devices. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the MOS devices with reset function have not yet been initialized. Hence, power-on does not guarantee output pin levels, I/O settings or contents of registers. MOS devices are not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for MOS devices having reset function.

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CME0107